


Automotive door actuator driver with embedded LIN

Datasheet - production data



Features

- AEC-Q100 qualified 
- 1 half bridge for 7.5 A load ($R_{ON} = 100\text{ m}\Omega$)
- 1 half bridge for 7.5 A load ($R_{ON} = 150\text{ m}\Omega$)
- 2 half bridges for 3 A load ($R_{ON} = 300\text{ m}\Omega$)
- 1 configurable high-side driver for up to 1.5 A ($R_{ON} = 500\text{ m}\Omega$) or 0.35 A ($R_{ON} = 1600\text{ m}\Omega$) load
- 1 configurable high-side driver for 0.8 A ($R_{ON} = 800\text{ m}\Omega$) or 0.35 A ($R_{ON} = 1600\text{ m}\Omega$) load
- 3 configurable high-side drivers for 0.15 A/0.35 A ($R_{ON} = 2\text{ }\Omega$)
- 1 configurable high-side driver for 0.25 A/0.5 A ($R_{ON} = 2\text{ }\Omega$)
- 4 configurable high-side drivers for 0.15 A/0.25 A ($R_{ON} = 5\text{ }\Omega$)
- Internal 10bit PWM timer for each stand-alone high-side driver
- Buffered supply for voltage regulators and 2 high-side drivers (OUT15 & OUT_HS / both P-channel) to supply e.g. external contacts
- Programmable soft-start function to drive loads with higher inrush currents as current limitation value (for OUT1-6, OUT7, OUT8 and OUT_HS) with thermal expiration feature
- All the embedded outputs come with protection and supervision features:
 - Current Monitor (high-side only)
 - Open-load

- Overcurrent
- Thermal warning
- Thermal shutdown
- Fully protected driver for external MOSFETs in H-bridge configuration
- Two 5 V voltage regulators for microcontroller and peripheral supply
- Programmable reset generator for power-on and undervoltage
- Configurable window watchdog
- LIN 2.2a compliant (SAEJ2602 compatible) transceiver
- Separated (Isolated) fail-safe block with 2 LS ($R_{ON} = 1\text{ }\Omega$) to pull down the gates of the external HS MOSFETs
- Thermal clusters
- A/D conversion of supply voltages and internal temperature sensors
- Embedded and programmable VS duty cycle adjustment for LED driver outputs

Applications

Door zone applications.

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1 Description

The L99DZ120 is a door zone systems IC providing electronic control modules with enhanced power management power supply functionality, including various standby modes, as well as LIN physical communication layers.

The two low-drop voltage regulators of the devices supply the system microcontroller and external peripheral loads such as sensors and provide enhanced system standby functionality with programmable local and remote wake-up capability. In addition 8 high-side drivers to supply LEDs, 2 high-side drivers to supply bulbs increase the system integration level.

Up to 3 DC motors and 4 external MOS transistors in H-bridge configuration can be driven. All outputs are SC protected and implement an open-load diagnosis.

The ST standard SPI interface (4.0) allows control and diagnosis of the device and enables generic software development.

2 Block diagram and pin descriptions

Figure 1. Block diagram

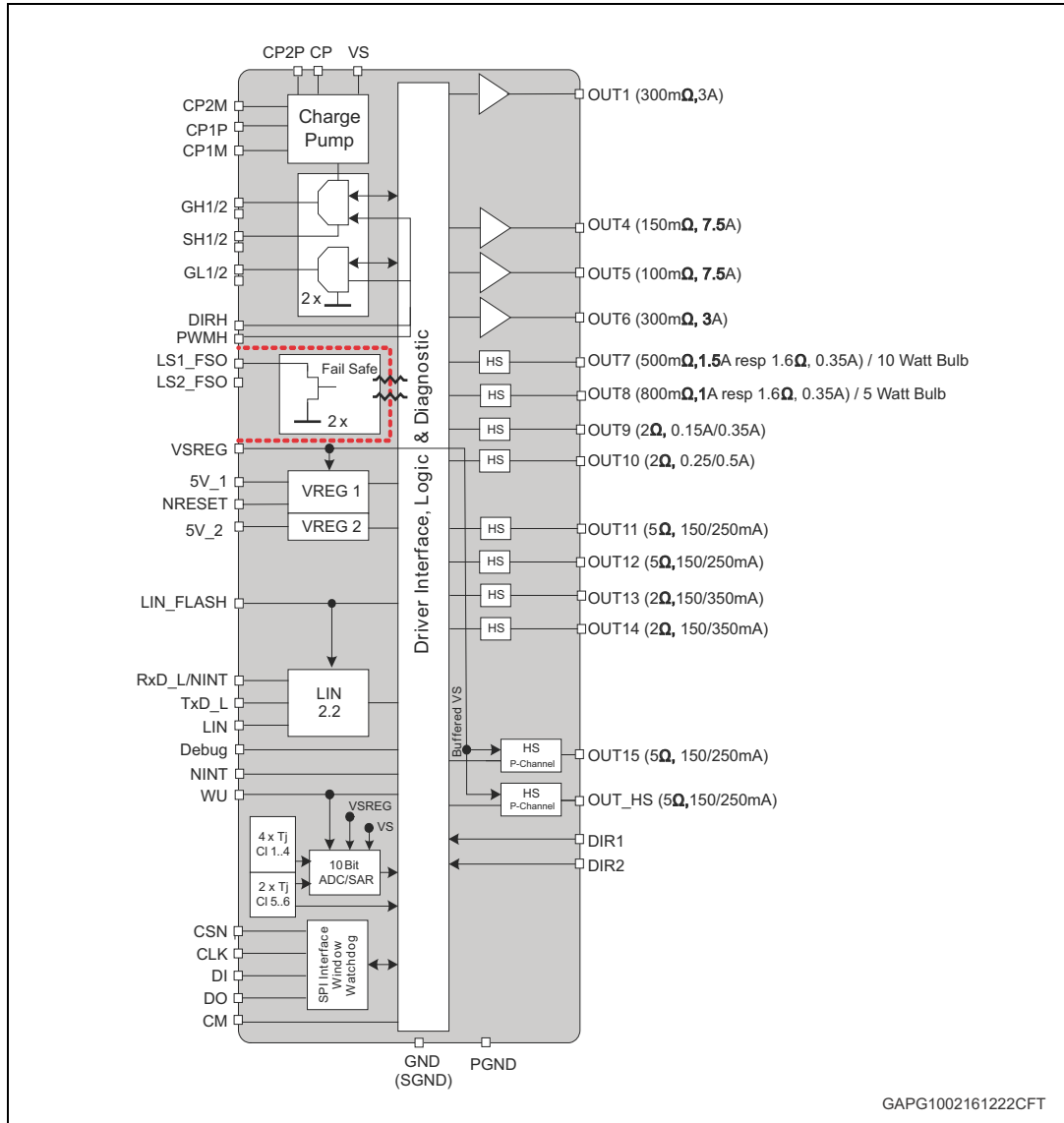


Table 1. Pin definitions and functions

Pin	Symbol	Function
1	WU	Wake-up Input: Input pin for static or cyclic monitoring of external contacts
2	CP2M	Charge pump pin for capacitor 2, negative side
3	CP2P	Charge pump pin for capacitor 2, positive side
4	CP	Charge pump output
5	CP1P	Charge pump pin for capacitor 1, positive side
6	CP1M	Charge pump pin for capacitor 1, negative side

Table 1. Pin definitions and functions (continued)

Pin	Symbol	Function
7	NC	Not connected
8	NC	Not connected
9	OUT14	High-side-driver output to drive LEDs
10	OUT13	High-side-driver output to drive LEDs
11	OUT12	High-side-driver output to drive LEDs
12	OUT9	High-side-driver output to drive LEDs
13	OUT10	High-side-driver-output
14	OUT11	High-side-driver output to drive LEDs
15	LS1_FSO	Fail Safe low-side switch (Active low)
16	LS2_FSO	Fail Safe low-side switch (Active low)
17	VS	Power supply voltage for power stage outputs (external reverse battery protection required), for this input a ceramic capacitor as close as possible to GND is recommended. Important: For the capability of driving, the full current at the outputs all pins of VS must be connected externally!
18	VS; 2nd pin	Current capability (pin description see above)
19	OUT7	High-side-driver output to drive LEDs or a 10 Watt bulb (programmable R_{dson})
20	OUT6	Half-bridge outputs: the output is built by a high-side and a low-side switch which are internally connected. The output stage of both switches is a power DMOS transistor. Each driver has an internal parasitic reverse diode (bulk-drain-diode: high-side driver from output to VS, low-side driver from GND to output)
21	OUT1	Half-bridge outputs: the output is built by a high-side and a low-side switch which are internally connected. The output stage of both switches is a power DMOS transistor. Each driver has an internal parasitic reverse diode (bulk-drain-diode: high-side driver from output to VS, low-side driver from GND to output)
22	NC	Not connected
23	OUT5	Half-bridge outputs: the output is built by a high-side and a low-side switch which are internally connected. The output stage of both switches is a power DMOS transistor. Each driver has an internal parasitic reverse diode (bulk-drain-diode: high-side driver from output to V_S , low-side driver from GND to output)
24	OUT5; 2nd pin	Current capability (pin description see above)
25	V_{SREG}	Power supply voltage to supply the internal voltage regulators, OUT15 and the OUT_HS (external reverse battery protection required / Diode) for this input a ceramic capacitor as close as possible to GND and an electrolytic back up capacitor is recommended.
26	OUT_HS	High-side-driver output to drive LEDs or to supply contacts

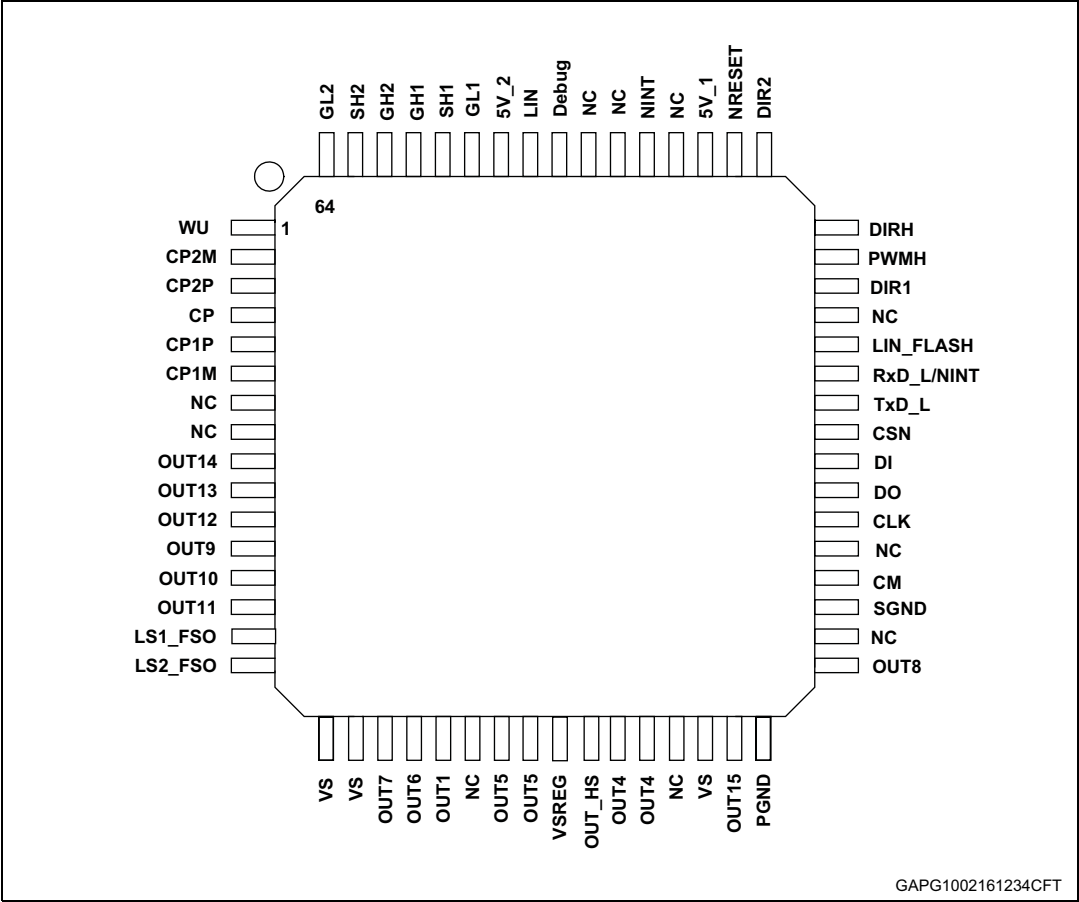
Table 1. Pin definitions and functions (continued)

Pin	Symbol	Function
27	OUT4	Half-bridge outputs: the output is built by a high-side and a low-side switch which are internally connected. The output stage of both switches is a power DMOS transistor. Each driver has an internal parasitic reverse diode (bulk-drain-diode: high-side driver from output to V_S , low-side driver from GND to output)
28	OUT4; 2 nd pin	Current capability (pin description see above)
29	NC	Not connected
30	VS; 3rd pin	Current capability (for the pin description see above)
31	OUT15	High-side-driver output to drive LEDs
32	PGND	Power GND
33	OUT8	High-side-driver output to drive LEDs or a 5 Watt bulb (programmable R_{dson})
34	NC	Not connected
35	SGND	Signal Ground
36	CM	Current monitor output: depending on the selected multiplexer bits CM_SEL_x ($CR\ 7$) of the; Control Register this output sources an image of the instant current; through the corresponding high-side driver with a fixed ratio
37	NC	Not connected
38	CLK	SPI: serial clock input
39	DO	SPI: serial data output (push pull output stage)
40	DI	SPI: serial data input
41	CSN	SPI: chip select not input
42	TxD_L	LIN Transmit data input
43	RxD_L/NINT	RxDL -> LIN receive data output; NINT -> indicates local/remote wake-up events (push pull output stage)
44	LIN_FLASH	LIN Flash Mode enable (former TxD_C pin, to guarantee family compatibility)
45	NC	Not connected
46	DIR1	Direct Drive Input 1
47	PWMH	PWMH input: this input signal can be used to control the H-bridge Gate Drivers.
48	DIRH	Direction Input: this input controls the H-bridge Drivers for the external MOSFETs
49	DIR2	Direct Drive Input 2
50	NRESET	NReset output to micro controller; (reset state = LOW) (low-side switch with drain connected to the output pin and internal pull up resistance to 5V_1)
51	5V_1	Voltage regulator 1 output: 5 V supply e.g. micro controller
52	NC	Not connected

Table 1. Pin definitions and functions (continued)

Pin	Symbol	Function
53	NINT	Interrupt output (low active; push-pull output stage) to indicate V_{SREG} early warning (Active mode); indicates wake-up events from V1_standby mode
54	NC	Not connected
55	NC	Not connected
56	Debug	Debug input to deactivate the window watchdog (high active)
57	LIN	LIN bus line
58	5V_2	Voltage regulator 2 output: 5 V supply for external loads (potentiometer, sensors). V2 is protected against reverse supply
59	GL1	Gate driver for PowerMOS low-side switch in half-bridge 1
60	SH1	Source of high-side switch in half-bridge 1
61	GH1	Gate driver for PowerMOS high-side switch in half-bridge 1
62	GH2	Gate driver for PowerMOS high-side switch in half-bridge 2
63	SH2	Source of high-side switch in half-bridge 2
64	GL2	Gate driver for PowerMOS low-side switch in half-bridge 2

Figure 2. Pin connection (top view)



GAPG1002161234CFT

3 Electrical specifications

3.1 Absolute maximum ratings

Stressing the device above the rating listed in [Table 2](#) may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability

Table 2. Absolute maximum ratings

Symbol	Parameter / test condition	Value [DC voltage]	Unit
V_S, V_{SREG}	DC supply voltage / "jump start"	-0.3 to +28	V
	Load dump	-0.3 to +40	V
5V_1	Stabilized supply voltage, logic supply	-0.3 to 6.5 $V_1 < V_{SREG}$	V
5V_2 ⁽¹⁾	Stabilized supply voltage	-0.3 to +28 ⁽²⁾	V
$V_{DI}, V_{CLK}, V_{CSN}, V_{DO}, V_{RXDL/NINT}, V_{NRESET}, V_{CM}, V_{DIR}, V_{DIR2}, V_{PWMH}, V_{DIRH}, V_{INT}$	Logic input / output voltage range	-0.3 to $V_1+0.3$	V
V_{LIN_FLASH}, V_{TXDL}	Multi Level Inputs	-0.3 to 40	V
V_{Debug}	Debug input pin voltage range	-0.3 to 40	V
V_{LS1_FSO}, V_{LS2_FSO}	Output voltage range of Fail-Safe low-side Switches	-0.3 to 35	V
V_{WU}	DC Wake up input voltage / "jump start"	-0.3 to +28	V
	Load dump	-0.3 to +40	V
V_{LIN}	LIN bus I/O voltage range	-20 to +40	V
$I_{Input}^{(3)}$	Current injection into V_S related input pins	20	mA
$I_{OUT_INJ}^{(3)}$	Current injection into V_S related outputs	20	mA
V_{OUTn}, V_{out_HS}	Output voltage (n = 1 to 15)	-0.3 to $V_S+0.3$	V
$V_{GH1}, V_{GH2} (V_{Gxy})$	High Voltage Signal Pins	$V_{Sxy}-0.3$ to $V_{Sxy}+13; V_{CP}+0.3$	V
$V_{GL1}, V_{GL2} (V_{Gxy})$	High Voltage Signal Pins	$V_{Sxy}-0.3$ to $V_{Sxy}+13; V_{CP}-0.3V$ to +12V; $V_{cp}+0.3V$	V
$V_{SH1}, V_{SH2} (V_{Sxy})$	High Voltage Signal Pins	-1 to 40	V
	High Voltage Signal Pins; single pulse with $t_{max} = 200ns$	-5 to 40	V
V_{CP1P}	High Voltage Signal Pins	$V_S-0.3$ to V_S+14	V
V_{CP2P}	High Voltage Signal Pins	$V_S-0.6$ to V_S+14	V

Table 2. Absolute maximum ratings (continued)

Symbol	Parameter / test condition	Value [DC voltage]	Unit
V_{CP1M}, V_{CP2M}	High Voltage Signal Pins	-0.3 to $V_S+0.3$	V
V_{CP}	High Voltage Signal Pin $V_S \leq 26$ V	$V_S-0.3$ to V_S+14	V
	High Voltage Signal Pin $V_S > 26$ V	$V_S-0.3$ to +40	V
$I_{OUT9}, I_{OUT10}, I_{OUT11}, I_{OUT12}, I_{OUT13}, I_{OUT14}, I_{OUT15}, I_{OUT_HS}$	Output current ⁽²⁾	± 1.25	A
I_{OUT8}		± 2.5	A
I_{OUT7}		± 5	A
$I_{OUT1,6}$		± 5	A
$I_{OUT4,5}$		± 10	A
I_{VScum}	Maximum cumulated current at V_S drawn by OUT1 ⁽²⁾	± 7.5	A
	Maximum cumulated current at V_S drawn by OUT8 & OUT10 ⁽²⁾	± 2.5	A
	Maximum cumulated current at V_S drawn by OUT4 ⁽²⁾	± 10	A
	Maximum cumulated current at V_S drawn by OUT5 ⁽²⁾	± 10	A
	Maximum cumulated current at V_S drawn by OUT6 & OUT7 ⁽²⁾	± 7.5	A
	Maximum cumulated current at V_S drawn by OUT9, OUT11, OUT12, OUT13, OUT14, OUT15 and CP	± 2.5	A
I_{VSREG}	Maximum current at V_{SREG} pin ⁽²⁾ (5V_1, 5V_2 and OUT_HS)	± 2.5	A
$I_{PGNDcum}$	Maximum cumulated current at PGND drawn by OUT1 & OUT6 ⁽²⁾	± 7.5	A
	Maximum cumulated current at PGND drawn by OUT5 ⁽²⁾	± 12.5	A
	Maximum cumulated current at PGND drawn by OUT4 ⁽²⁾	± 12.5	A
I_{SGND}	Maximum current at SGND ⁽²⁾	± 1.25	A
GND pins	PGND versus SGND	-0.3 to 0.3	V

- 5V_2 is robust against SC to 28 V only in case V_{SREG} is supplied.
- Values for the absolute maximum DC current through the bond wires. This value does not consider maximum power dissipation or other limits.
- Guaranteed by design.

Note: All maximum ratings are absolute ratings. Leaving the limitation of any of these values may cause an irreversible damage of the integrated circuit!

Note: Loss of ground or ground shift with externally grounded loads: ESD structures are configured for nominal currents only. If external loads are connected to different grounds, the current load must be limited to this nominal current.

3.2 ESD protection

Table 3. ESD protection

Parameter	Value	Unit
All pins ⁽¹⁾	+/-2	kV
All power output pins ⁽²⁾ : OUT1 – OUT15, OUT_HS	+/-4	kV
LIN	+/-8 ⁽²⁾ +/-10 ⁽³⁾ +/-6 ⁽⁴⁾	kV
All pins ⁽⁵⁾	+/-500	V
Corner pins ⁽⁵⁾	+/-750 ⁽⁶⁾	V
All pins ⁽⁷⁾	+/- 200	V

1. HBM (human body model, 100 pF, 1.5 kΩ) according to MIL 883C, Method 3015.7 or EIA/JESD22A114-A.
2. HBM with all none zapped pins grounded.
3. Indirect ESD Test according to IEC 61000-4-2 (150 pF, 330 Ω) and 'Hardware Requirements for LIN, CAN and Flexray Interfaces in Automotive Applications' (version 1.3, 2012-05-04).
4. Direct ESD Test according to IEC 61000-4-2 (150 pF, 330 Ω) and 'Hardware Requirements for LIN, CAN and Flexray Interfaces in Automotive Applications' (version 1.3, 2012-05-04).
5. Charged device model.
6. For WU, these limits are referred to one-zap stress; in case of three-zap stress, the limits are +750V/-400V.
7. Machine model; C = 220 pF, R = 0 Ω.

3.3 Thermal data

Table 4. Operating junction temperature

Symbol	Parameter	Value	Unit
T _j	Operating junction temperature	-40 to 175	°C

All parameters are guaranteed in the junction temperature range -40 to 150°C (unless otherwise specified); the device is still operative and functional at higher temperatures (up to 175°C).

Note: Parameters limits at higher junction temperatures than 150°C may change respect to what is specified as per the standard temperature range.

Note: Device functionality at high junction temperature is guaranteed by characterization.

Table 5. Temperature warning and thermal shutdown

Symbol	Parameter		Min.	Typ.	Max.	Unit
T_W	Thermal overtemperature warning threshold	$T_j^{(1)}$	140	150	160	°C
T_{SD1}	Thermal shutdown junction temperature 1	$T_j^{(1)}$ Cluster 1-4 Cluster 5-6	165 165	175 175	185 190	°C
T_{SD2}	Thermal shutdown junction temperature 2	$T_j^{(1)}$	175	185	195	°C
$T_{SD12hys}$		Hysteresis		5		°C
T_{jft}	Thermal warning / shutdown filter time			32		µs

1. Non-overlapping.

3.3.1 LQFP64 thermal data

Devices belonging to L99DZxxx family embed a multitude of junctions (i.e. Outputs based on a PowerMOSFET stage) housed in a relatively small piece of silicon. The most complex device contains, among all the described features, 6 half-bridges (12 N-Channel PowerMOS), 10 high-sides and two voltage regulators; all the other derivatives, even if smaller than the family super set device, still contain a significant number of junctions.

For this reason, using the Thermal Impedance of a single junction (i.e. voltage regulator or major power dissipation contributor) does not allow to predict thermal behavior of the whole device and therefore it is not possible to assess if a device is thermally suitable for a given activation profile and loads characteristics.

Thermal information is provided as temperature reading by different clusters placed close to the most dissipative junctions.

Some representative and realistic worst-case thermal profiles are described in the below paragraph.

Following measurement methods can be easily implemented, by final user, for a specific activation profile.

L99DZ120 thermal profiles

Profile 1

Battery Voltage: 16V, Ambient temperature start: 85°C

DC activation

- V1 charged with 70 mA (DC activation)
- V2 charged with 30 mA (DC activation)
- OUT7: 1 x10W bulb (DC activation)
- OUT8: 1 x 5W bulb (DC activation)
- OUT11: 300 Ω resistor (DC activation)
- OUT12: 300 Ω resistor (DC activation)
- OUT13: 300 Ω resistor (DC activation)
- OUT14: 300 Ω resistor (DC activation)

Cyclic activation

- OUT4 – OUT5: 3,3 Ω resistor placed across those outputs
 - 10 activations of Lock/Un-lock (250 ms ON Lock; 500 ms wait; 250 ms ON Un-lock unlock; 500 ms wait)
- OUT5 – OUT6: 10 Ω resistor placed across those outputs
 - (250 ms ON Safe Lock; 500 ms wait; 250 ms ON Safe unlock; 500 ms wait)

Test execution:

Once thermal equilibrium is reached with all DC load active, the “Cyclic Activation” sequence is applied.

Temperature reading is logged just at the end of the whole sequence.

Figure 3. Activation profile 1

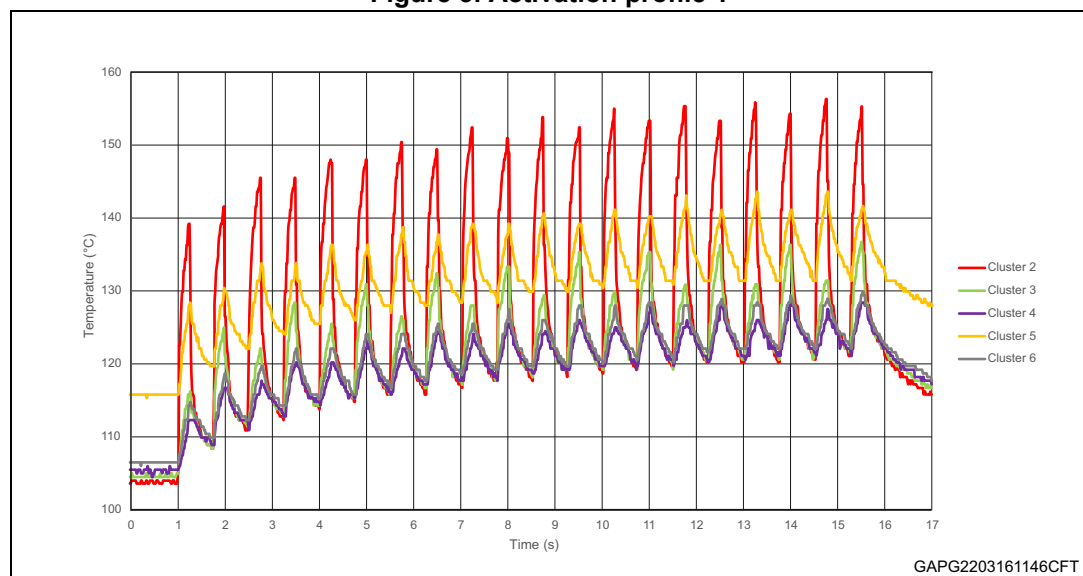
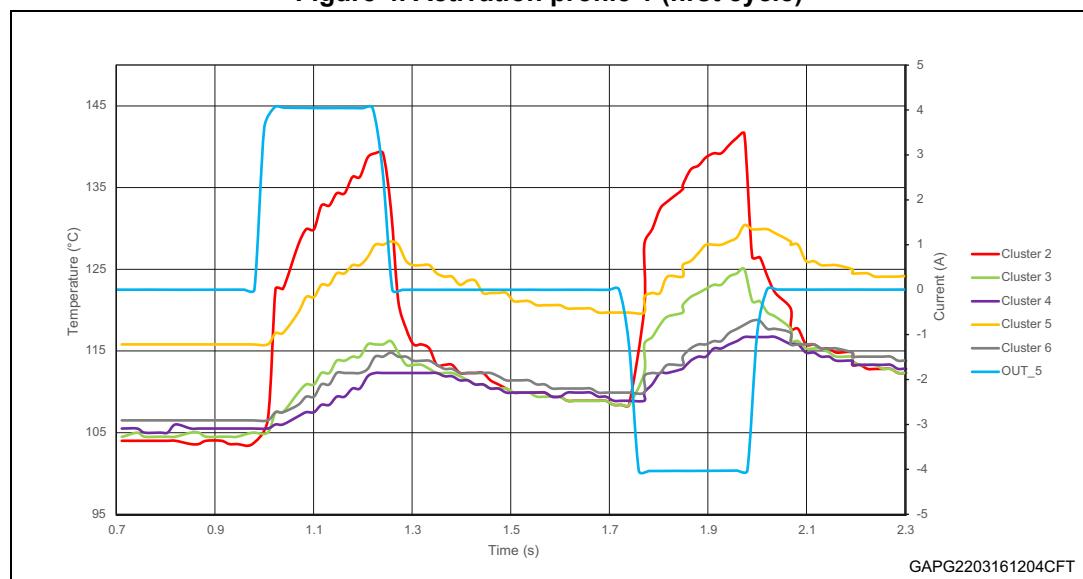


Figure 4. Activation profile 1 (first cycle)



Note: All curves are plotted interpolating measured samples with 15 ms of period.

Profile 2

Battery Voltage: 16V, Ambient temperature start: 85°C

DC activation

- V1 charged with 70 mA (DC activation)
- V2 charged with 30 mA (DC activation)
- OUT7: 1 x10W bulb (DC activation)
- OUT8: 1 x 5W bulb (DC activation)
- OUT11: 300 Ω resistor (DC activation)
- OUT12: 300 Ω resistor (DC activation)
- OUT13: 300 Ω resistor (DC activation)
- OUT14: 300 Ω resistor (DC activation)

Cyclic activation

- OUT1 – OUT6: 6,8 Ω resistor placed across those outputs
 - 2 activations (3s ON; 1s OFF; 2x)

Test execution:

Once thermal equilibrium is reached with all DC load active, the “Cyclic Activation” sequence is applied.

Figure 5. Activation profile 2

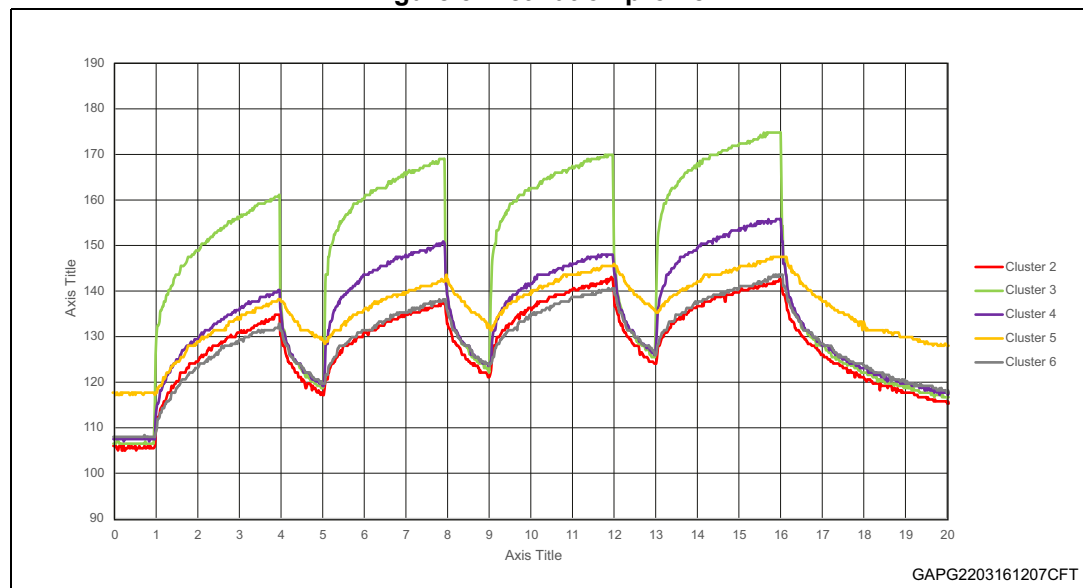
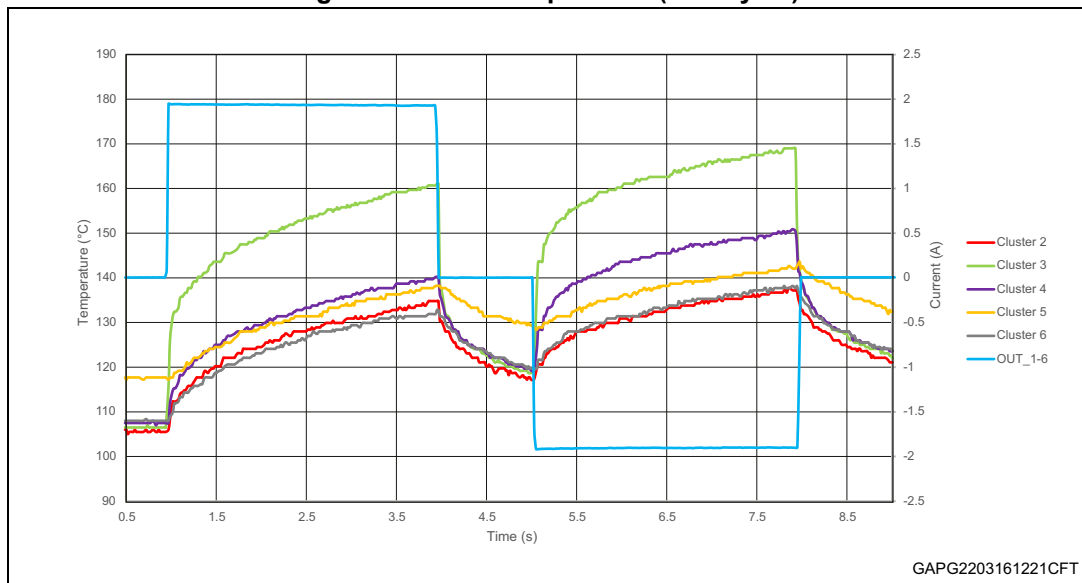
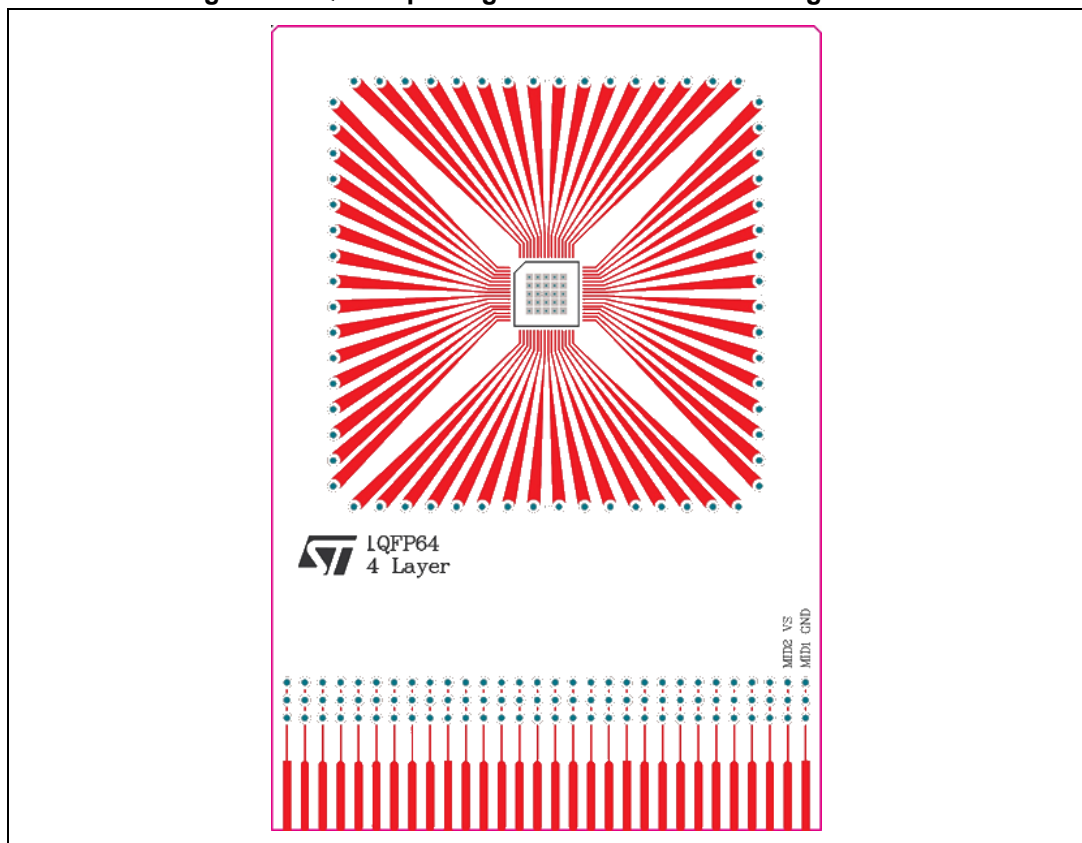


Figure 6. Activation profile 2 (first cycle)



Note: All curves are plotted interpolating measured samples with 15 ms of period.

Figure 7. LQFP64 package and PCB thermal configuration



Note: Layout condition for Thermal Characterization (board finishing thickness 1.5 mm +/- 10%, board four layers, board dimension 77 mm x 114 mm, board material FR4, Cu thickness 0,070 mm for outer layers, 0.0035 mm for inner layers, thermal vias separation 1.2 mm).

3.4 Electrical characteristics

3.4.1 Supply and supply monitoring

All SPI communication, logic and oscillator parameters are working down to $V_{SREG} = 3.5\text{ V}$ and parameters are as specified in the following chapters (guaranteed by design).

- SPI thresholds
- Oscillator frequency (delay times correctly elapsed)
- Internal register status correctly kept (reset at default values for $V_{SREG} < V_{POR}$)
- Reset threshold correctly detected

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 28\text{ V}$; $6\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

Table 6. Supply and supply monitoring

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{SUV}	V_S undervoltage threshold	V_S increasing / decreasing	4.7		5.4	V
V_{hyst_UV}	V_S undervoltage hysteresis		0.04	0.1	0.2	V
V_{SOV}	V_S overvoltage threshold	V_S increasing	20		22.5	V
		V_S decreasing	18.5		22.5	
V_{hyst_OV}	V_S overvoltage hysteresis		0.5	1	1.5	V
V_{SREG_UV}	V_{SREG} undervoltage threshold	V_{SREG} increasing / decreasing	4.2		4.9	V
V_{hyst_UV}	V_{SREG} undervoltage hysteresis		0.04	0.1	0.2	V
V_{SREG_OV}	V_{SREG} overvoltage threshold	V_{SREG} increasing	20		22.5	V
		V_{SREG} decreasing	18.5		22.5	
V_{hyst_OV}	V_{SREG} overvoltage hysteresis		0.5	1	1.5	V
t_{ovuv_filt}	V_S/V_{SREG} over/undervoltage filter time			64		μs
$I_{V(act)}$	Current consumption in Active mode	$V_S = V_{SREG} = 12\text{ V}$; TxD LIN = high; V1 = ON; V2 = ON; HS/LS Driver OFF; CP = ON		11	14	mA
$I_{V(BAT)}$	Current consumption in $V_{bat_standby}$ mode ⁽¹⁾	$V_S = 12\text{ V}$; Both voltage regulators deactivated; HS/LS Driver OFF	8	16	30	μA
$I_{V(BAT)CS}$	Current consumption in $V_{bat_standby}$ mode with cyclic sense enabled ⁽¹⁾	$V_S = 12\text{ V}$; Both voltage regulators deactivated; $T = 50\text{ ms}$, $t_{ON} = 100\text{ }\mu\text{s}$	30	80	130	μA
$I_{V(BAT)CW}$	Current consumption in $V_{bat_standby}$ mode with cyclic wake enabled ⁽¹⁾	$V_S = 12\text{ V}$; Both voltage regulators deactivated during standby phase	30	80	130	μA

Table 6. Supply and supply monitoring (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$I_{V(V1stby)}$	Current consumption in $V_{1_standby}$ mode ⁽¹⁾	$V_S = 12\text{ V}$; Voltage regulator V1 active; ($I_{V1} = 0$); HS/LS Driver OFF	16	50	70	μA
	Current consumption in $V_{1_standby}$ mode ^{(1) (2)}	$V_S = 12\text{ V}$; Voltage regulator V1 active; ($I_{V1} = I_{CMP}$); HS/LS Driver OFF			196	μA
	Current consumption in $V_{1_standby}$ mode ⁽¹⁾	$V_S = 12\text{ V}$; Voltage regulator V1 active; ($I_{V1} = I_{PEAK}$); HS/LS Driver OFF			436	μA
I_{qLIN}	Quiescent current adder for LIN wake up activated	Guaranteed by design		0		μA
I_{OUT_HS}	Additional bias quiescent current for switched on OUT_HS or OUT15 by DIR or Timer; value for 1 output	Guaranteed by design		620	1100	μA
I_{OUTHS_DIR}	Quiescent current adder if OUT_HS and/or OUT15 are configured for Direct Drive; value during output off	Guaranteed by design		0	5	μA
I_{timer}	Quiescent current adder if timer1 and/or timer 2 are active to provide interrupt on NINT upon timer expiration	Guaranteed by design		65	110	μA

1. Conditions for specified current consumption:

- $V_{LIN} > (V_S - 1.5\text{ V})$
- $V_{WU} < 1\text{ V}$ or $V_{WU} > (V_S - 1.5\text{ V})$

2. $I_q = I_{q0} + 2\% \cdot I_{LOAD}$ (see also [Figure 8: Voltage regulator V1 characteristics \(quiescent current and accuracy\)](#))

3.4.2 Oscillator

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 28\text{ V}$; $6\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$, unless otherwise specified.

Table 7. Oscillator

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$f_{CLK1}^{(1)}$	Oscillation frequency OSC1		1.66	2.0	2.34	MHz
$f_{CLK2}^{(1)}$	Oscillation frequency OSC2		30.4	32.0	33.6	MHz

1. OSC1: charge pump, SPI, output drivers, watchdog
OSC2: ADC

3.4.3 Power-on reset (V_{SREG})

All outputs open; $T_j = -40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$, unless otherwise specified.

Table 8. Power-on reset (V_{SREG})

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{POR_R}	V_{POR} threshold	V_{SREG} rising		3.45	4.5	V
V_{POR_F}	V_{POR} threshold	V_{SREG} falling ⁽¹⁾	2.45		3.5	V

1. This threshold is valid if V_{SREG} had already reached $V_{POR_R(max)}$ previously.

3.4.4 Voltage regulator V1

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $4.5\text{ V} \leq V_S \leq 28\text{ V}$; $4.5\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

Table 9. Voltage regulator V1

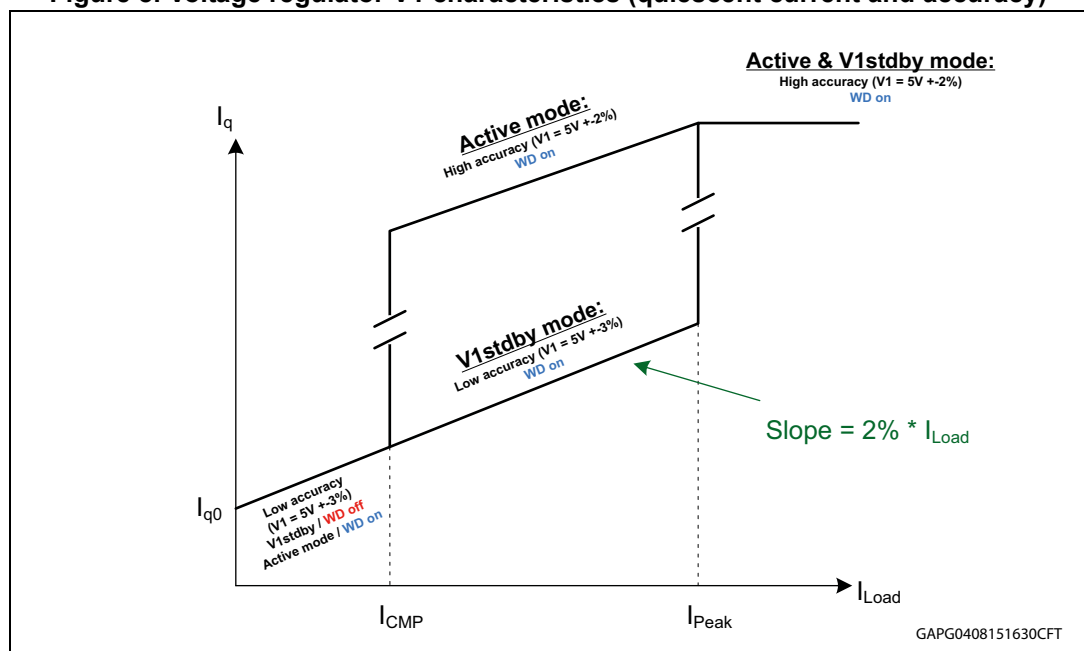
Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V1	Output voltage	$V_{SREG} = 13.5\text{ V}$		5.0		V
V_{SREG_absmin}	V_{SREG} absolute minimum value for controlling NRESET output	V_{SREG} rising/falling			2	V
$V1_{low_acc}$	Output voltage tolerance low accuracy mode	$I_{LOAD} = 0\text{ mA}$ to I_{CMP} ; (Active mode) or $I_{LOAD} = 0\text{ mA}$ to I_{PEAK} ($V1_{stdby}$); $V_{SREG} = 13.5\text{ V}$	-3		3	%
$V1_{hi_acc}$	Output voltage tolerance high accuracy mode	$I_{LOAD} = I_{CMP}$ to 100 mA ; (Active mode) or $I_{LOAD} = I_{PEAK}$ to 100 mA ($V1_{stdby}$); $V_{SREG} = 13.5\text{ V}$	-2		2	%
$V1_{250mA}$	Output voltage tolerance (100 to 250mA)	$I_{LOAD} = 250\text{ mA}$; $V_{SREG} = 13.5\text{ V}$	-3		3	%
V_{DP1}	Drop-out Voltage	$I_{LOAD} = 50\text{ mA}$; $V_{SREG} = 5\text{ V}$		0.2	0.4	V
		$I_{LOAD} = 100\text{ mA}$; $V_{SREG} = 5\text{ V}$		0.3	0.5	V
		$I_{LOAD} = 150\text{ mA}$; $V_{SREG} = 5\text{ V}$		0.45	0.6	V
I_{CC1}	Output current in Active mode	Max. continuous load current			250	mA
I_{CCmax1}	Short circuit output current	Current limitation	340	600	900	mA
C_{load1}	Load capacitor1	Ceramic (+/- 20%)	0.22 ⁽¹⁾			μF
t_{TSD}	V1 deactivation time after thermal shut-down			1		sec
I_{CMP_ris}	Current comp. rising thresh	Rising current	2	4	6	mA
I_{CMP_fal}	Current comp. falling threshold	Falling current	1.4	2.8	4.2	mA

Table 9. Voltage regulator V1 (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$I_{\text{CMP_hys}}$	Current comp. Hysteresis			1.2		mA
$I_{\text{Peak_ris}}^{(2)}$	Current comp. rising thresh.	Rising current	6	12	18	mA
$I_{\text{Peak_fal}}^{(2)}$	Current comp. falling threshold	Falling current	5	10	15	mA
$I_{\text{Peak_hys}}^{(2)}$	Current comp. Hysteresis			2		mA
$V1_{\text{fail}}$	V1 fail threshold	V1 forced		2		V
$t_{V1\text{fail}}$	V1 fail filter time			2		μs
$t_{V1\text{short}}$	V1 short filter time			4		ms
$t_{V1\text{FS}}$	V1 Fail-Safe Filter Time			2		ms
$t_{V1\text{off}}$	V1 deactivation time after 8 consecutive WD failures	Tested by scan	150	200	250	ms

- Nominal capacitor value required for stability of the regulator. Tested with 220 nF ceramic (+/- 20%). Capacitor must be located close to the regulator output pin. A 2.2 μF capacitor is recommended to minimize the DPI stress in the application.
- In Active mode, V1 regulator is switched to high accuracy mode, dropping below the I_{CMP} threshold regulator switches to low accuracy mode.

Figure 8. Voltage regulator V1 characteristics (quiescent current and accuracy)



3.4.5 Voltage regulator V2

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $4.5\text{ V} \leq V_S \leq 28\text{ V}$; $4.5\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

Table 10. Voltage regulator V2

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V2	Output voltage	$V_{SREG} = 13.5\text{ V}$		5.0		V
V2_1mA	Output voltage tolerance (0 to 1 mA)	$I_{LOAD} = 1\text{ mA}$; $V_{SREG} = 13.5\text{ V}$	-6.5		6.5	%
V2_25mA	Output voltage tolerance (1 to 25 mA)	$I_{LOAD} = 25\text{ mA}$; $V_{SREG} = 13.5\text{ V}$	-3		3	%
V2_50mA	Output voltage tolerance (25 to 50 mA)	$I_{LOAD} = 50\text{ mA}$; $V_{SREG} = 13.5\text{ V}$	-4		4	%
V2_100mA	Output voltage tolerance (50 to 100 mA)	$I_{LOAD} = 100\text{ mA}$; $V_{SREG} = 13.5\text{ V}$	-4		4	%
V _{DP2}	Drop-out voltage	$I_{LOAD} = 25\text{ mA}$; $V_{SREG} = 5.25\text{ V}$		0.3	0.4	V
		$I_{LOAD} = 50\text{ mA}$; $V_{SREG} = 5.25\text{ V}$		0.4	0.8	V
		$I_{LOAD} = 100\text{ mA}$; $V_{SREG} = 13.5\text{ V}$		1	1.6	V
I _{CC2}	Output current in Active mode	Max. continuous load current			50	mA
I _{CCmax2}	Short circuit output current	Current limitation	100	150	250	mA
C _{load}	Load capacitor	Ceramic (+/- 20%)	0.22 ⁽¹⁾			μF
V2 _{fail}	V2 fail threshold	V2 forced		2		V
t _{V2fail}	V2 fail filter time			2		μs
t _{V2short}	V2 short filter time			4		ms

1. Nominal capacitor value required for stability of the regulator. Tested with 220 nF ceramic (+/- 20%). Capacitor must be located close to the regulator output pin. A 2.2 μF capacitor is recommended to minimize the DPI stress in the application.

3.4.6 Reset output

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $4\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

Table 11. Reset output

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V _{RT1falling}	Reset threshold voltage1	V _{V1} decreasing	3.25	3.5	3.7	V
V _{RT2falling}	Reset threshold voltage2	V _{V1} decreasing	3.55	3.8	4	V
V _{RT3falling}	Reset threshold voltage3	V _{V1} decreasing	3.75	4.0	4.2	V

Table 11. Reset output (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$V_{RT4falling}$	Reset threshold voltage4	V_{V1} decreasing	4.1	4.3	4.5	V
$V_{RTrising}$	Reset threshold voltage4	V_{V1} increasing	4.67	4.8	4.87	V
V_{RESET}	Reset Pin low output voltage	$V1 > 1\text{ V}$; $I_{RESET} = 5\text{ mA}$		0.2	0.4	V
R_{RESET}	Reset pull up int. resistor		10	20	30	$k\Omega$
t_{RR}	Reset reaction time	$I_{LOAD} = 1\text{ mA}$	6		40	μs
t_{UV1}	V1 undervoltage filter time			16		μs
t_{V1R}	Reset pulse duration (V1 undervoltage and V1 power on reset)		1.5	2.0	2.5	ms
t_{WDR}	Reset pulse duration (watchdog failure)		3	4	5	ms

3.4.7 Watchdog timing

$4.5\text{ V} \leq V_{\text{SREG}} \leq 28\text{ V}$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

Table 12. Watchdog timing

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
t_{LW}	Long open window		160	200	240	ms
T_{EFW1}	Early Failure Window 1				4.5	ms
T_{LFW1}	Late Failure Window 1		20			ms
T_{SW1}	Safe Window 1		7.5		12	ms
T_{EFW2}	Early Failure Window 2				22.3	ms
T_{LFW2}	Late Failure Window 2		100			ms
T_{SW2}	Safe Window 2		37.5		60	ms
T_{EFW3}	Early Failure Window 3				45	ms
T_{LFW3}	Late Failure Window 3		200			ms
T_{SW3}	Safe Window 3		75		120	ms
T_{EFW4}	Early Failure Window 4				90	ms
T_{LFW4}	Late Failure Window 4		400			ms
T_{SW4}	Safe Window 4		150		240	ms

Figure 9. Watchdog timing

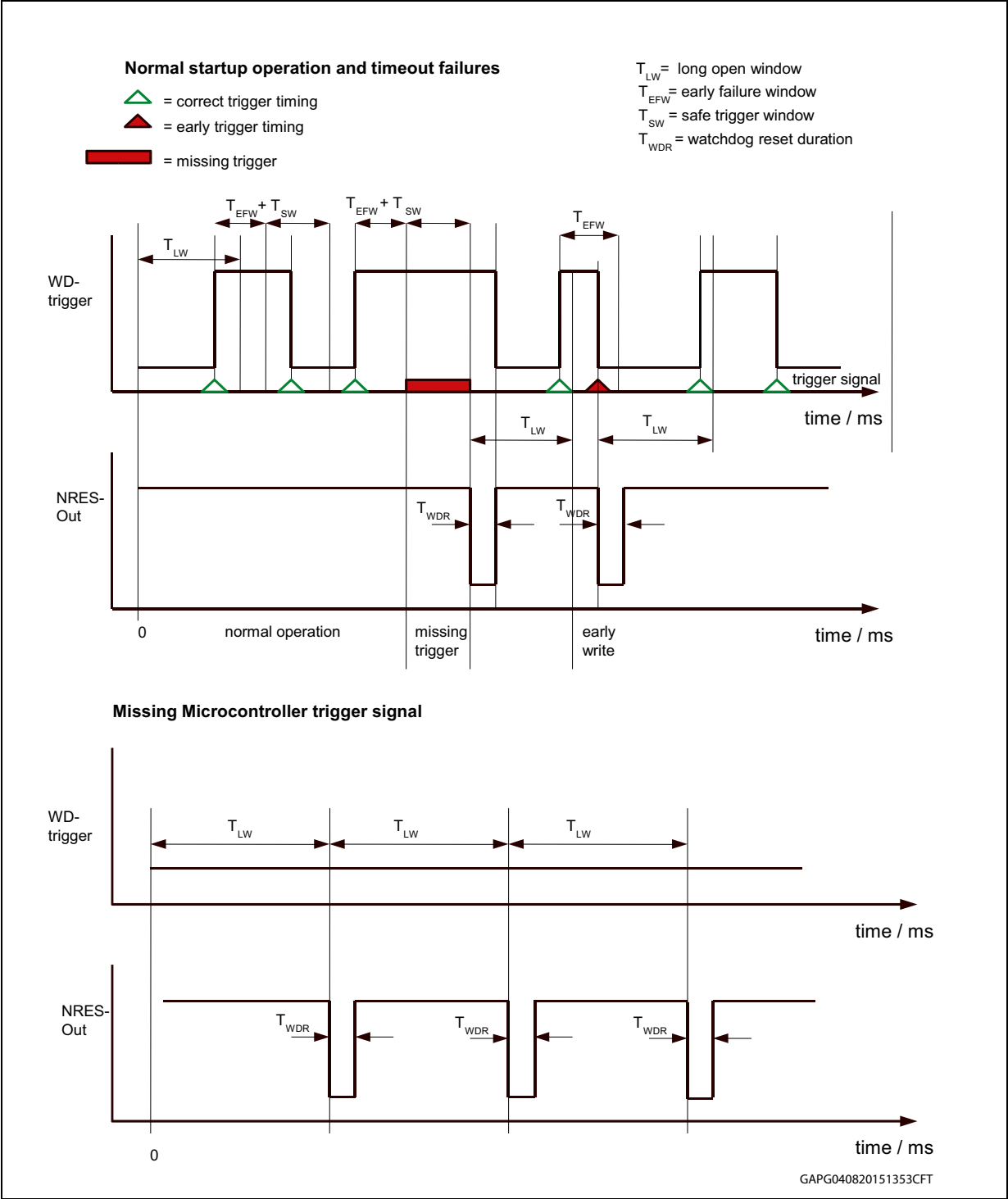
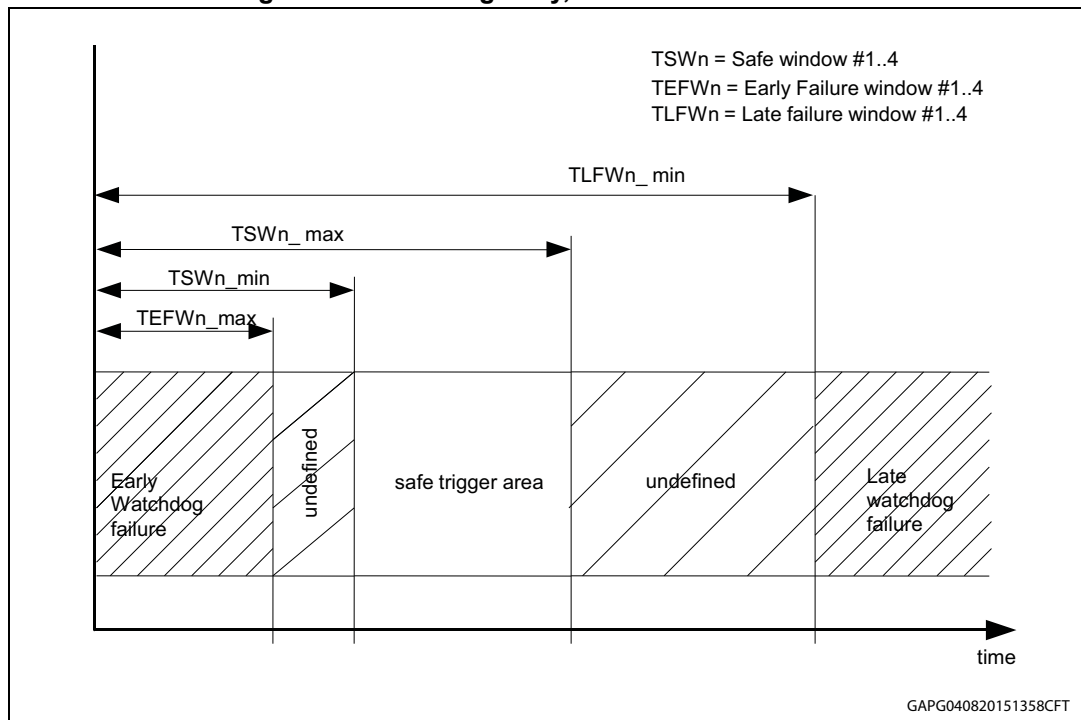


Figure 10. Watchdog early, late and safe windows



3.4.8 Current monitor output (CM)

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 28\text{ V}$; $6\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$, unless otherwise specified

Table 13. Current monitor output (CM)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{CM}	Functional voltage range		0		$V_1 - 1\text{ V}$	V
I_{CMr}	Current monitor output ratio: $I_{CM}/I_{OUT1,4,5,6}$ and 7 (low on-resistance)	$0\text{ V} \leq V_{CM} \leq (V_1 - 1\text{ V})$		1/10000		
	I_{CM}/I_{OUT8} (low on-resistance)			1/6500		
	$I_{CM}/I_{OUT7,8}$ (high on-resistance)			1/2000		
	$I_{CM}/I_{OUT9,10,11,12,13,14,15}$ and HS			1/1000		

Table 13. Current monitor output (CM) (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$I_{CM\ acc}$	Current monitor accuracy $accI_{CMOUT1,4,5,6\ and\ 7}$ (low on-resistance)	$0\ V \leq V_{CM} \leq (V_1 - 1\ V)$; $I_{OUTmin} = 500\ mA$; $I_{OUT4,5max} = 7.4\ A$; $I_{OUT1,6max} = 2.9\ A$; $I_{OUT7max} = 1.4\ A$				
	Current monitor accuracy $accI_{CMOUT\ 8}$ (low on-resistance)	$0\ V \leq V_{CM} \leq (V_1 - 1\ V)$; $I_{OUTmin} = 100\ mA$; $I_{OUT8max} = 0.9\ A$		4% + 1% FS ⁽¹⁾	8% + 2% FS ⁽¹⁾	
	Current monitor accuracy $accI_{CMOUT9,10,11,12,13,14,15\ ,HS}$ and $OUT_{7,8}$ (high on-resistance)	$0\ V \leq V_{CM} \leq (V_1 - 1\ V)$; $I_{OUT.min} = 100\ mA$; $I_{OUT11,12,15\ HS} = 0.2\ A$; $I_{OUT7,8\ max} = 0.3\ A$				
$I_{CM\ acc_2ol}$	Current monitor accuracy $accI_{CMOUT1,4,5,6\ and\ 7}$ (low on-resistance)	$0\ V \leq V_{CM} \leq (V_1 - 1\ V)$; $I_{OUTmin} = 2 * I_{OLD}$; $I_{OUT4,5max} = 7.4\ A$; $I_{OUT1,6max} = 2.9\ A$; $I_{OUT7max} = 1.4\ A$		4% + 1% FS ⁽¹⁾	8% + 2% FS ⁽¹⁾	
	Current monitor accuracy $accI_{CMOUT\ 8}$ (low on-resistance)	$0\ V \leq V_{CM} \leq (V_1 - 1\ V)$; $I_{OUTmin} = 2 * I_{OLD}$; $I_{OUT8max} = 0.9\ A$				
	Current monitor accuracy $accI_{CMOUT9,11,12,13,14,15, HS}$ and $OUT_{7,8}$ (high on-resistance)	$0\ V \leq V_{CM} \leq (V_1 - 1\ V)$; $I_{OUT.min} = 2 * I_{OLD}$; $I_{OUT9,13,14max} = 0.3\ A$; $I_{OUT11,12,15\ HS} = 0.2\ A$; $I_{OUT7,8\ max} = 0.3\ A$				
	Current monitor accuracy $accI_{CMOUT10}$	$0\ V \leq V_{CM} \leq (V_1 - 1\ V)$; $I_{OUT.min} = 2 * I_{OLD}$; $I_{OUT10max} = 0.4\ A$		4% + 1% FS ⁽¹⁾	8% + 4% FS ⁽¹⁾	
t_{cmb}	Current monitor blanking time			32		μs

1. FS (full scale) = $I_{OUTmax} * I_{CMr}$

3.4.9 Charge pump

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\ V \leq V_S \leq 28\ V$; $T_j = -40\ ^\circ C$ to $150\ ^\circ C$, unless otherwise specified.

Table 14. Charge pump electrical characteristics

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{CP}	Charge pump output voltage	$V_S = 6\ V$, $I_{CP} = -15\ mA$	$V_S + 6$	$V_S + 7$		V
		$V_S \geq 10\ V$, $I_{CP} = -15\ mA$	$V_S + 11$	$V_S + 12$	$V_S + 13.5$	V
I_{CP}	Charge pump output current ⁽¹⁾	$V_{CP} = V_S + 10\ V$; $V_S = 13.5\ V$; $C_1 = C_2 = C_{CP} = 100\ nF$	22.5			mA

Table 14. Charge pump electrical characteristics (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
I_{CPlim}	Charge pump output current limitation ⁽²⁾	$V_{CP} = V_S$; $V_S = 13.5\text{ V}$; $C_1 = C_2 = C_{CP} = 100\text{ nF}$			70	mA
V_{CP_low}	Charge pump low threshold voltage		$V_S + 4.5$	$V_S + 5$	$V_S + 5.5$	V
T_{CP}	Charge pump low filter time			64		μs
f_{CP}	Charge Pump frequency			400		kHz

1. I_{CP} is the minimum current the device can provide to an external circuit without V_{CP} going below $V_S + 10\text{ V}$.

2. I_{CPlim} is the maximum current, which flows out of the device in case of a short to V_S .

3.4.10 Outputs OUT1 - OUT15, OUT_HS

The voltages are referred to power ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 28\text{ V}$; $6\text{ V} \leq V_{SREG} \leq 28\text{ V}$, all outputs open;
 $T_j = -40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$, unless otherwise specified.

Table 15. Outputs OUT1 - OUT15, OUT_HS

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$r_{ON\ OUT1,6}$	On-resistance to supply or GND	$V_S = 13.5\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$; $I_{OUT1,6} = \pm 1.5\text{ A}$		300		$\text{m}\Omega$
		$V_S = 13.5\text{ V}$; $T_j = 130\text{ }^\circ\text{C}$; $I_{OUT1,6} = \pm 1.5\text{ A}$			600	$\text{m}\Omega$
$r_{ON\ OUT4}$	On-resistance to supply or GND	$V_S = 13.5\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$; $I_{OUT4} = \pm 3\text{ A}$		150		$\text{m}\Omega$
		$V_S = 13.5\text{ V}$; $T_j = 130\text{ }^\circ\text{C}$; $I_{OUT4} = \pm 3\text{ A}$			300	$\text{m}\Omega$
$r_{ON\ OUT5}$	On-resistance to supply or GND	$V_S = 13.5\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$; $I_{OUT5} = \pm 3\text{ A}$		100		$\text{m}\Omega$
		$V_S = 13.5\text{ V}$; $T_j = 130\text{ }^\circ\text{C}$; $I_{OUT5} = 3\text{ A}$			200	$\text{m}\Omega$
$r_{ON\ OUT7}$	On-resistance to supply in low resistance mode	$V_S = 13.5\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$; $I_{OUT7} = -0.8\text{ A}$		500		$\text{m}\Omega$
		$V_S = 13.5\text{ V}$; $T_j = 130\text{ }^\circ\text{C}$; $I_{OUT7} = -0.8\text{ A}$			1000	$\text{m}\Omega$
	On-resistance to supply in high resistance mode	$V_S = 13.5\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$; $I_{OUT7} = -0.2\text{ A}$		1600		$\text{m}\Omega$
		$V_S = 13.5\text{ V}$; $T_j = 130\text{ }^\circ\text{C}$; $I_{OUT7} = -0.2\text{ A}$			3200	$\text{m}\Omega$

Table 15. Outputs OUT1 - OUT15, OUT_HS (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$r_{ON\ OUT8}$	On-resistance to supply in low resistance mode	$V_S = 13.5\text{ V}; T_J = 25\text{ }^{\circ}\text{C}; I_{OUT8} = -0.4\text{ A}$		800		m Ω
		$V_S = 13.5\text{ V}; T_J = 130\text{ }^{\circ}\text{C}; I_{OUT8} = -0.4\text{ A}$			1600	m Ω
	On-resistance to supply in high resistance mode	$V_S = 13.5\text{ V}; T_J = 25\text{ }^{\circ}\text{C}; I_{OUT8} = -0.2\text{ A}$		1600		m Ω
		$V_S = 13.5\text{ V}; T_J = 130\text{ }^{\circ}\text{C}; I_{OUT8} = -0.2\text{ A}$			3200	m Ω
$r_{ON\ OUT9,10,13,14}$	On-resistance to supply	$V_S = 13.5\text{ V}; T_J = 25\text{ }^{\circ}\text{C}; I_{OUT9,10,13,14} = -75\text{ mA}$		2000		m Ω
		$V_S = 13.5\text{ V}; T_J = 130\text{ }^{\circ}\text{C}; I_{OUT9,10,13,14} = -75\text{ mA}$			4000	m Ω
$r_{ON\ OUT11,12,15, HS}$	On-resistance to supply	$V_S = 13.5\text{ V}; T_J = 25\text{ }^{\circ}\text{C}; I_{OUT11,12,15, HS} = -75\text{ mA}$		5		Ω
		$V_S = 13.5\text{ V}; T_J = 130\text{ }^{\circ}\text{C}; I_{OUT11,12,15, HS} = -75\text{ mA}$			10	Ω
I_{QLH}	Switched-off output current high-side drivers of OUT7-15, OUT_HS	$V_{OUT} = 0\text{ V}; \text{standby mode}$	-5			μA
		$V_{OUT} = 0\text{ V}; \text{active mode}$	-10			μA
I_{QLH}	Switched-off output current high-side drivers of OUT1-6	$V_{OUT} = 0\text{ V}; \text{standby mode}$	-5			μA
		$V_{OUT} = 0\text{ V}; \text{Active mode}$	-100			μA
I_{QLL}	Switched-off output current low-side drivers of OUT1-6	$V_{OUT} = V_S; \text{standby mode}$			165	μA
		$V_{OUT} = V_S - 0.5\text{ V}; \text{active mode}$	-100			μA

3.4.11 Power outputs switching times

The voltages are referred to power ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 28\text{ V}$; $6\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$, unless otherwise specified.

Table 16. Power outputs switching times

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$t_{d\text{ ON H}}$	Output delay time high-side driver on (OUT _{1,4,5,6})	$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$; corresponding low-side driver is not active ⁽¹⁾⁽²⁾⁽³⁾	15	40	80	μs
	Output delay time high-side driver on (OUT _{7,8})	(from CSN 50% to OUT 50%) see Figure 20	20	40	90	μs
$t_{d\text{ OFF H}}$	Output delay time high-side driver off (OUT _{1,4,5,6})	$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$ ⁽¹⁾⁽²⁾⁽³⁾ (from CSN 50% to OUT 50%) see Figure 20	50	150	300	μs
	Output delay time high-side driver off (OUT _{7,8})		20	70	130	μs
$t_{d\text{ ON H}}$	Output delay time high-side driver on (OUT9 ...OUT15, OUT_HS)	$V_S/V_{SREG} = 13.5\text{ V}$; $V_1 = 5\text{ V}$; (from CSN 80% to OUT 80%)			30	μs
$t_{d\text{ OFF H}}$	Output switch off delay time high-side driver on (OUT9 ...OUT15, OUT_HS)	$V_S/V_{SREG} = 13.5\text{ V}$; $V_1 = 5\text{ V}$; (from CSN 80% to OUT 20%)			35	μs
$t_{d\text{ ON L}}$	Output delay time low-side driver (OUT ₁₋₆) on	$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$; corresponding high-side driver is not active ⁽¹⁾⁽²⁾⁽³⁾ (from CSN 50% to OUT 50%) see Figure 20	15	30	70	μs
$t_{d\text{ OFF L}}$	Output delay time low-side driver (OUT ₁₋₆) off	$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$ ⁽¹⁾⁽²⁾⁽³⁾ (from CSN 50% to OUT 50%) see Figure 20	40	150	300	μs
$t_{d\text{ HL}}$	Cross current protection time (OUT ₁₋₆)	$t_{cc\text{ ONLS_OFFHS}} - t_{d\text{ OFF H}}$ ⁽⁴⁾	50	200	400	μs
$t_{d\text{ LH}}$		$t_{cc\text{ ONHS_OFFLS}} - t_{d\text{ OFF L}}$ ⁽⁴⁾				
dV_{OUT}/dt	Slew rate of OUT ₁ -OUT ₈	$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$ ⁽¹⁾⁽²⁾⁽³⁾	0.1	0.2	0.6	$\text{V}/\mu\text{s}$
dV_{max}/dt	Maximum external applied slew rate on OUT1-OUT6 without switching on the LS and HS (only in Active mode)	Guaranteed by design	20			$\text{V}/\mu\text{s}$
dV_{OUT}/dt	Slew rate of OUT9-OUT15, OUT_HS	$V_S/V_{SREG} = 13.5\text{ V}$; $V_1 = 5\text{ V}$ ⁽¹⁾⁽²⁾⁽³⁾		2		$\text{V}/\mu\text{s}$
$f_{PWMx(00)}$	PWM switching frequency	$V_S/V_{SREG} = 13.5\text{ V}$; $V_1 = 5\text{ V}$		100		Hz
$f_{PWMx(01)}$	PWM switching frequency	$V_S/V_{SREG} = 13.5\text{ V}$; $V_1 = 5\text{ V}$		200		Hz

Table 16. Power outputs switching times (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$f_{PWMx(10)}$	PWM switching frequency	$V_S/V_{SREG} = 13.5\text{ V};$ $V_1 = 5\text{ V}$		330		Hz
$f_{PWMx(11)}$	PWM switching frequency	$V_S/V_{SREG} = 13.5\text{ V};$ $V_1 = 5\text{ V}$		500		Hz

1. $R_{LOAD} = 16\ \Omega$ at $OUT_{1,6}$ and $OUT_{7,8}$ in low on-resistance mode
2. $R_{LOAD} = 4\ \Omega$ at $OUT_{4,5}$
3. $R_{LOAD} = 128\ \Omega$ at $OUT_{4,9,10,11,12,13,15,15,HS}$ and $OUT_{7,8}$ in high on-resistance mode
4. t_{CC} is the switch-on delay time if complement in half bridge has to switch off

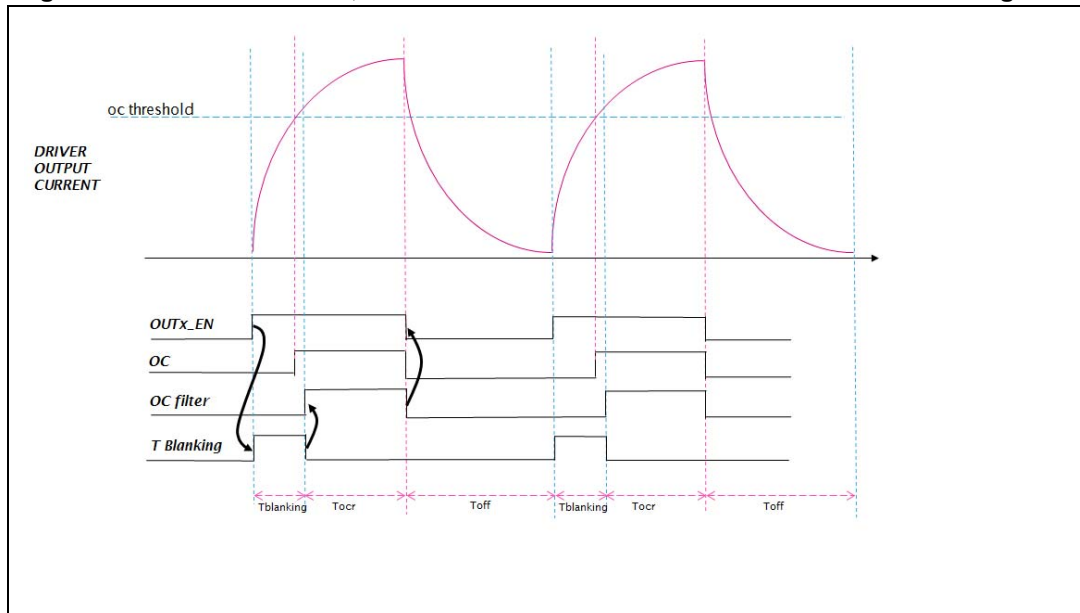
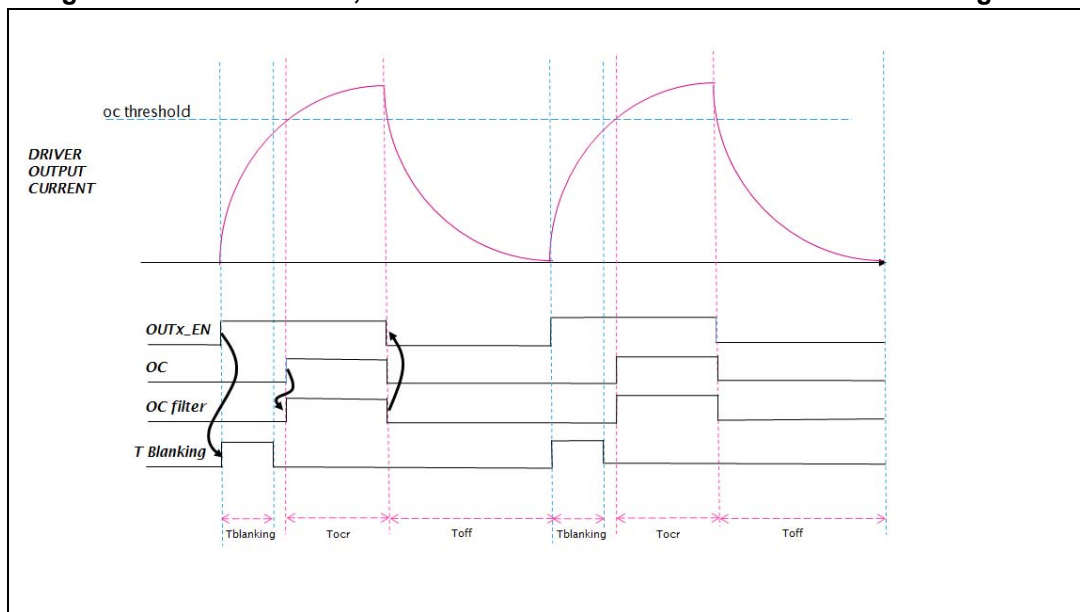
3.4.12 Over Current Recovery settings

Table 17. Half bridges (OUT1, OUT4, OUT5 and OUT6) OCR timing parameters

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
Tblanking		Guaranteed by Design	33	40	47	μs
Tocr_hb	Over current filter time for half bridges	Guaranteed by Design	26	32	38	μs
Toff_hb	OFF Time for half bridges OCR_FREQ=0	Guaranteed by Design	218	264	310	μs
	OFF Time for half bridges OCR_FREQ=1		106	128	150	μs

Table 18. High-side (OUT7, OUT8 and OUT_HS) OCR timing parameters

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
Tblanking		Guaranteed by Design	33	40	47	μs
Tocr_hs	Over current filter time for high-side	Guaranteed by Design	53	64	75	μs
Toff_hs	OFF Time for high-side OCR_FREQ=0	Guaranteed by Design	398	480	562	μs
	OFF Time for high-side OCR_FREQ=1		192	232	272	μs

Figure 11. Hard Short case, the OC threshold is reached before end of blanking time**Figure 12. Overload case, the OC threshold is reached after end of blanking time**

3.4.13 Current monitoring

The voltages are referred to power ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 28\text{ V}$; $6\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

Table 19. Current monitoring

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
I_{OC1} , I_{OC6}	Overcurrent threshold HS & LS	$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$; sink and source	3		5	A
I_{OC4}		$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$; sink and source; $T_j = -40\text{ }^{\circ}\text{C}$ to $70\text{ }^{\circ}\text{C}$	7.5		10	A
		$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$; sink and source; $T_j = 130\text{ }^{\circ}\text{C}$	6		10	A
I_{OC5_1}		$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$; sink and source	3	4	5	A
I_{OC5_2}			4.5	6	7.5	A
I_{OC5_3}			7.5		10	A
I_{OC7}	Overcurrent threshold HS in low on-resistance mode	$V_S/V_{SREG} = 13.5\text{ V}$; $V_1 = 5\text{ V}$; source	1.5		2.5	A
	Overcurrent threshold HS in high on-resistance mode		0.35		0.65	A
I_{OC8}	Overcurrent threshold HS in low on-resistance mode		0.7		1.3	A
	Overcurrent threshold HS in high on-resistance mode		0.35		0.65	A
I_{OC9} , I_{OC13} , I_{OC14}	Overcurrent threshold HS in high current mode		0.35		0.7	A
	Overcurrent threshold to HS in low current mode		0.15		0.3	A
I_{OC10}	Overcurrent threshold HS in high current mode		0.5		1	A
	Overcurrent threshold HS in low current mode		0.25		0.5	A
I_{OC11} , I_{OC12} , I_{OC15} , I_{OC_HS}	Overcurrent threshold HS in high current mode		0.25		0.5	A
	Overcurrent threshold HS in low current mode		0.15		0.3	A
t_{AR}	Auto recovery time limit	OUT1 to OUT6		100		ms
		OUT7, OUT8, OUT_HS		120		ms
I_{OLD1} , I_{OLD6}	Under-current threshold HS & LS	$V_S = 13.5\text{ V}$; $V_1 = 5\text{ V}$; sink and source	10	30	80	mA
I_{OLD4} , I_{OLD5}			60	150	300	mA

Table 19. Current monitoring (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
I _{OLD7}	Under-current threshold HS in low on-resistance mode	V _S /V _{SREG} = 13.5 V; V ₁ = 5 V; source	15	40	60	mA
	Under-current threshold HS in high on-resistance mode		5	10	15	mA
I _{OLD8}	Under-current threshold HS in low on-resistance mode		10	30	45	mA
	Under-current threshold HS in high on-resistance mode		5	10	15	mA
I _{OLD9} , I _{OLD13} , I _{OLD14}	Under-current threshold HS in high current mode		6		12	mA
	Under-current threshold HS in low current mode		0.5		4	mA
I _{OLD10}	Under -current threshold HS in high current mode		10		30	mA
	Under -current threshold HS in low current mode		0.3		4	mA
I _{OLD11} , I _{OLD12} , I _{OLD15} , I _{OLD_HS}	Under -current threshold HS in high current mode		6		12	mA
	Under -current threshold HS in low current mode		0.85		4	mA
t _{OL_out}	Filter time of open-load signal	Duration of open-load condition to set the status bit	150	200	250	μs

3.4.14 H-bridge driver

The voltages are referred to power ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 28\text{ V}$; $6\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40^\circ\text{C}$ to 150°C , unless otherwise specified.

Table 20. H-bridge driver

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
Drivers for external high-side PowerMOS						
I _{GHx(Ch)}	Average charge current (charge stage)	T _j = 25 °C		0.3		A
R _{GHx}	On-resistance (discharge-stage)	V _{SHx} = 0 V; I _{GHx} = 50 mA; T _j = 25 °C	6	10	14	Ω
		V _{SHx} = 0 V; I _{GHx} = 50 mA; T _j = 130 °C		14	20	Ω
V _{GHHx}	Gate-on voltage	V _S = SH = 6 V; I _{CP} = 15 mA	V _{SHx} + 6			V
		V _S = SH = 12 V; I _{CP} = 15 mA	V _{SHx} + 8	V _{SHx} + 10	V _{SHx} + 11.5	V

Table 20. H-bridge driver (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
R_{GSHx}	Passive gate-clamp resistance	$V_{GHx} = 0.5 \text{ V}$		15		$k\Omega$
Drivers for external low-side Power-MOS						
$I_{GLx(Ch)}$	Average charge-current (charge stage)	$T_j = 25 \text{ }^\circ\text{C}$		0.3		A
R_{GLx}	On-resistance (discharge-stage)	$V_{SLx} = 0 \text{ V}; I_{GHx} = 50 \text{ mA}; T_j = 25 \text{ }^\circ\text{C}$	6	10	14	Ω
		$V_{SLx} = 0 \text{ V}; I_{GHx} = 50 \text{ mA}; T_j = 130 \text{ }^\circ\text{C}$		14	20	Ω
V_{GHLx}	Gate-on voltage	$V_S = 6 \text{ V}; I_{CP} = 15 \text{ mA}$	$V_{SLx} + 6$			V
		$V_S = 12 \text{ V}; I_{CP} = 15 \text{ mA}$	$V_{SLx} + 8$	$V_{SLx} + 10$	$V_{SLx} + 11.5$	V
R_{GSLx}	Passive gate-clamp resistance			15		$k\Omega$

3.4.15 Gate drivers for the external Power-MOS switching times

The voltages are referred to power ground and currents are assumed positive, when the current flows into the pin. $6 \text{ V} \leq V_S \leq 28 \text{ V}$; $6 \text{ V} \leq V_{SREG} \leq 28 \text{ V}$; $T_j = -40 \text{ }^\circ\text{C}$ to $150 \text{ }^\circ\text{C}$, unless otherwise specified.

Table 21. Gate drivers for the external Power-MOS switching times

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$T_{G(HL)xHL}$	Propagation delay time high to low (switch mode) ⁽¹⁾	$V_S = 13.5 \text{ V}; V_{SHx} = 0;$ $R_G = 0 \Omega; C_G = 2.7 \text{ nF}$		1.5		μs
$T_{G(HL)xLH}$	Propagation delay time low to high (switch mode) ⁽¹⁾	$V_S = 13.5 \text{ V}; V_{SLx} = 0;$ $R_G = 0 \Omega; C_G = 2.7 \text{ nF}$		1.5		μs
$I_{GHx\text{max}}$	Maximum source current (current mode)	$V_S = 13.5 \text{ V}; V_{SHx} = 0;$ $V_{GHx} = 1 \text{ V};$ $\text{SLEW}<4:0> = 1 \text{ F}_H$		32		mA
$I_{GHx\text{fmax}}$	Maximum sink current (current mode)	$V_S = 13.5 \text{ V}; V_{SHx} = 0;$ $V_{GHx} = 2 \text{ V};$ $\text{SLEW}<4:0> = 1 \text{ F}_H$		32		mA
dI_{GHxr}	Source current accuracy	$V_S = 13.5 \text{ V}; V_{SHx} = 0;$ $V_{GHx} = 1 \text{ V}$	See Figure 14: IGHxr ranges			
dI_{GHxf}	Sink current accuracy	$V_S = 13.5 \text{ V}; V_{SHx} = 0;$ $V_{GHx} = 2 \text{ V}$	See Figure 15: IGHxf ranges			
$V_{DSHxrSW}$	Switching voltage ($V_S - V_{SH}$) between current mode and switch mode (rising)	$V_S = 13.5 \text{ V}$		2.8		V
$V_{DSHxfSW}$	Switching voltage ($V_S - V_{SH}$) between switch mode and current mode (falling)	$V_S = 13.5 \text{ V}$		2.8		V

Table 21. Gate drivers for the external Power-MOS switching times (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
t_{0GHxr}	Rise time (switch mode)	$V_S = 13.5\text{ V}; V_{SHx} = 0;$ $R_G = 0\ \Omega; C_G = 2.7\text{ nF}$		45		ns
t_{0GHxf}	Fall time (switch mode)	$V_S = 13.5\text{ V}; V_{SHx} = 0;$ $R_G = 0\ \Omega; C_G = 2.7\text{ nF}$		85		ns
t_{0GLxr}	Rise time	$V_S = 13.5\text{ V}; V_{SLx} = 0;$ $R_G = 0\ \Omega; C_G = 2.7\text{ nF}$		45		ns
t_{0GLxf}	Fall time	$V_S = 13.5\text{ V}; V_{SLx} = 0;$ $R_G = 0\ \Omega; C_G = 2.7\text{ nF}$		85		ns
$tccp_{0001}$	Programmable cross-current protection time			500		ns
$tccp_{0010}$	Programmable cross-current protection time			750		ns
$tccp_{0011}$	Programmable cross-current protection time			1000		ns
$tccp_{0100}$	Programmable cross-current protection time			1250		ns
$tccp_{0101}$	Programmable cross-current protection time			1500		ns
$tccp_{0110}$	Programmable cross-current protection time			1750		ns
$tccp_{0111}$	Programmable cross-current protection time			2000		ns
$tccp_{1000}$	Programmable cross-current protection time			2250		ns
$tccp_{1001}$	Programmable cross-current protection time			2500		ns
$tccp_{1010}$	Programmable cross-current protection time			2750		ns
$tccp_{1011}$	Programmable cross-current protection time			3000		ns
$tccp_{1100}$	Programmable cross-current protection time			3250		ns
$tccp_{1101}$	Programmable cross-current protection time			3500		ns
$tccp_{1110}$	Programmable cross-current protection time			3750		ns
$tccp_{1111}$	Programmable cross-current protection time			4000		ns
f_{PWMH}	PWMH switching frequency	$V_S = 13.5\text{ V}; V_{SLx} = 0;$ $R_G = 0\ \Omega; C_G = 2.7\text{ nF};$ PWMH-Duty-Cycle = 50%; $tccp$ configured as 0001			50	kHz

Figure 13. H-driver delay times

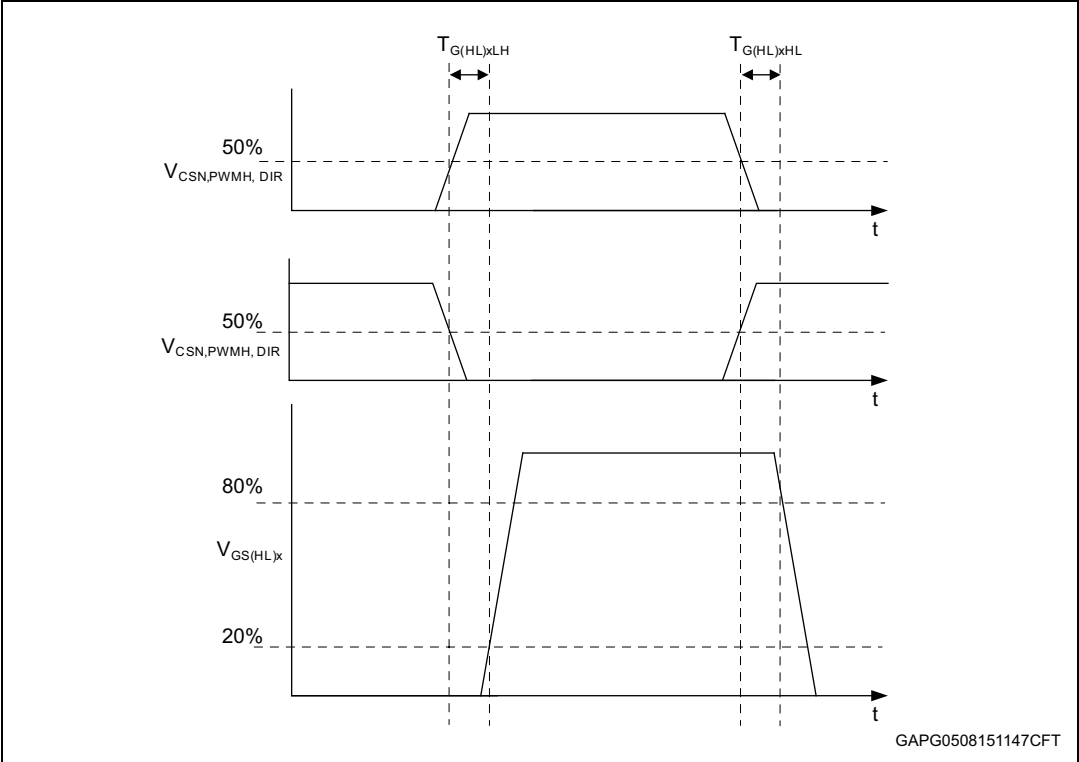


Figure 14. IGHxr ranges

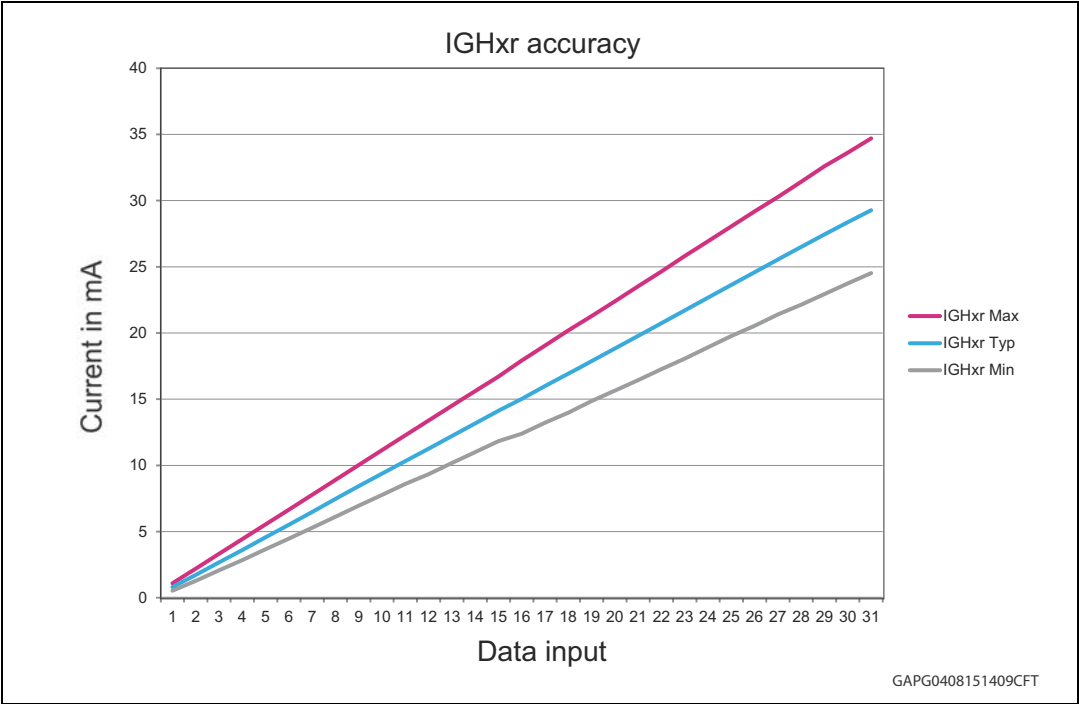
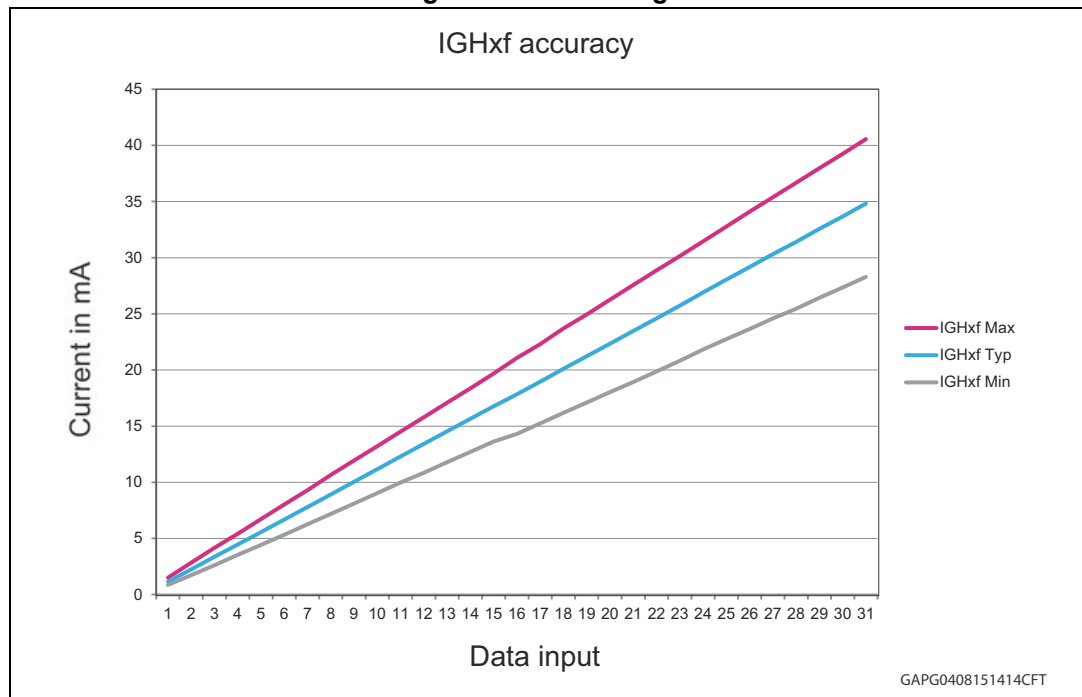


Figure 15. IGHxf ranges



3.4.16 Drain source monitoring external H-bridge

The voltages are referred to power ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 28\text{ V}$; $6\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40^\circ\text{C}$ to 150°C , unless otherwise specified.

Table 22. Drain source monitoring external H-bridge

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{SCd1_HB}	Drain-source threshold voltage		0.375	0,5	0.625	V
V_{SCd2_HB}	Drain-source threshold voltage		0.6	0,75	0.9	V
V_{SCd3_HB}	Drain-source threshold voltage		0,85	1	1,15	V
V_{SCd4_HB}	Drain-source threshold voltage		1,06	1,25	1,43	V
V_{SCd5_HB}	Drain-source threshold voltage		1,27	1,5	1,73	V
V_{SCd6_HB}	Drain-source threshold voltage		1,49	1,75	2,01	V
V_{SCd7_HB}	Drain-source threshold voltage		1,7	2	2,3	V
t_{SCd_HB}	Drain-source monitor filter time			6		μs
t_{scs_HB}	Drain-source comparator settling time	$V_S = 13.5\text{ V}$; $V_{SH} = \text{jump from GND to } V_S$			5	μs

3.4.17 Open-load monitoring external H-bridge

The voltages are referred to power ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 28\text{ V}$; $6\text{ V} \leq V_{SREG} \leq 28\text{ V}$; $T_j = -40^\circ\text{C}$ to 150°C , unless otherwise specified.

Table 23. Open-load monitoring external H-bridge

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{ODSL}	Low-side drain-source monitor low off-threshold voltage	$V_{SLx} = 0\text{ V}; V_S = 13.5\text{ V}$		$0.15 V_S$		V
V_{ODSH}	Low-side drain-source monitor high off-threshold voltage	$V_{SLx} = 0\text{ V}; V_S = 13.5\text{ V}$		$0.85 V_S$		V
V_{OLSHx}	Output voltage of selected SHx in open-load test mode	$V_{SLx} = 0\text{ V}; V_S = 13.5\text{ V}$		$0.5 V_S$		V
R_{pdOL}	Pull-down resistance of the non-selected SHx pin in open-load mode	$V_{SLx} = 0\text{ V}; V_S = 13.5\text{ V}; V_{SHx} = 4.5\text{ V}$		20		k Ω
t_{OL_HB}	Open-load filter time			2		ms

3.4.18 Fail safe low-side switch

The voltages are referred to power ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_S \leq 18\text{ V}$; $T_j = 40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

Table 24. Fail safe low-side switch

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{OUT_max}	Max output voltage in case of missing supply	$I_{OUT} = 1\text{ mA}; V_S = V_{SREG} = 0\text{ V}$		2	2.5	V
R_{DSON}	DC output resistance	$I_{LOAD} = 250\text{ mA}; T_j = 25\text{ }^{\circ}\text{C}$		1.4		Ω
		$I_{LOAD} = 250\text{ mA}; T_j = 130\text{ }^{\circ}\text{C}$			2.2	Ω
I_{OLimit}	Overcurrent limitation	$8\text{ V} < V_S < 16\text{ V}$	500		1500	mA
t_{ONHL}	Turn on delay time to 10% V_{OUT}				100	μs
t_{OFFLH}	Turn off delay time to 90% V_{OUT}				100	μs
t_{SCF}	Short circuit filter time			64		μs
dV_{max}/dt	Maximum external applied slew rate on LS1_FSO and LS2_FSO without switching on LS	Guaranteed by design	60			V/ μs

3.4.19 Wake up input WU

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_{\text{SREG}} \leq 28\text{ V}$; $T_j = 40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$, unless otherwise specified.

Table 25. Wake-up inputs

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{WUthn}	Wake-up negative edge threshold voltage		0.4 V_{SREG}	0.45 V_{SREG}	0.5 V_{SREG}	V
V_{WUthp}	Wake-up positive edge threshold voltage		0.5 V_{SREG}	0.55 V_{SREG}	0.6 V_{SREG}	V
V_{HYST}	Hysteresis		0.05 V_{SREG}	0.1 V_{SREG}	0.15 V_{SREG}	V
$t_{\text{WU_stat}}$	Static wake filter time			64		μs
$I_{\text{WU_stdby}}$	Input current in standby mode	$V_{\text{WU}} < 1\text{ V}$ or $V_{\text{WU}} > (V_{\text{SREG}} - 1.5\text{ V})$	5	30	60	μA
$R_{\text{WU_act}}$	Input resistor to GND in Active mode and in Standby mode during Wake-up input sensing		80	160	300	k Ω
$t_{\text{WU_cyc}}$	Cyclic wake filter time			16		μs

3.4.20 LIN transceiver

LIN 2.2 compliant for bit-rates up to 20 kBit/s SAE J2602 compatible.

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_{\text{SREG}} \leq 18\text{ V}$; $T_{\text{junction}} = -40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$ unless otherwise specified.

Table 26. LIN transmit data input: pin TxD

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{TXDLOW}	Input voltage dominant level	Active mode	1.0			V
V_{TXDHIGH}	Input voltage recessive level	Active mode			2.3	V
V_{TXDHYS}	$V_{\text{TXDHIGH}} - V_{\text{TXDLOW}}$	Active mode	0.2			V
R_{TXDPU}	TXD pull up resistor	Active mode	13	29	46	k Ω

Table 27. LIN receive data output: pin RxD

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{RXDLOW}	Output voltage dominant level	Active mode		0.2	0.5	V
V_{RXDHIGH}	Output voltage recessive level	Active mode	$V_1 - 0.5$	$V_1 - 0.2$		V

Table 28. LIN transmitter and receiver: pin LIN

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{THdom}	Receiver threshold voltage recessive to dominant state		0.4 V_{SREG}	0.45 V_{SREG}	0.5 V_{SREG}	V
V_{Busdom}	Receiver dominant state				$0.4V_{SREG}$	V
V_{THrec}	Receiver threshold voltage dominant to recessive state		0.5 V_{SREG}	0.55 V_{SREG}	0.6 V_{SREG}	V
V_{Busrec}	Receiver recessive state		0.6 V_{SREG}			V
V_{THhys}	Receiver threshold hysteresis: $V_{THrec} - V_{THdom}$		0.07 V_{SREG}	0.1 V_{SREG}	0.175 V_{SREG}	V
V_{THcnt}	Receiver tolerance center value: $(V_{THrec} + V_{THdom})/2$		0.475 V_{SREG}	0.5 V_{SREG}	0.525 V_{SREG}	V
V_{THwkup}	Activation threshold for wake-up comparator		1.0	1.5	2	V
$V_{THwkdown}$	Activation threshold for wake-up comparator		$V_{SREG} - 3.5$	$V_{SREG} - 2.5$	$V_{SREG} - 1.5$	V
t_{LINBUS}	LIN Bus Wake-up Dominant Filter time	Sleep mode; edge: rec-dom		64		μs
t_{dom_LIN}	LIN Bus Wake-up Dominant Filter time	Sleep mode; edge: rec-dom-rec	28			μs
$I_{LINDomSC}$	Transmitter input current limit in dominant state	$V_{TXD} = V_{TXDLOW}$; $V_{LIN} = V_{BATMAX} = 18\text{ V}$	40	100	180	mA
$I_{bus_PAS_dom}$	Input leakage current at the receiver incl. pull-up resistor	$V_{TXD} = V_{TXDHIGH}$; $V_{LIN} = 0\text{ V}$; $V_{BAT} = 12\text{ V}$; Slave mode	-1			mA
$I_{bus_PAS_rec}$	Transmitter input current in recessive state	In standby modes; $V_{TXD} = V_{TXDHIGH}$; $V_{LIN} > 8\text{ V}$; $V_{BAT} < 18\text{ V}$; $V_{LIN} \geq V_{BAT}$			20	μA
$I_{bus_NO_GND}$	Input current if loss of GND at device	$GND = V_{SREG}$; $0\text{ V} < V_{LIN} < 18\text{ V}$; $V_{BAT} = 12\text{ V}$	-1		1	mA
I_{bus}	Input current if loss of V_{BAT} at device	$GND = V_S$; $0\text{ V} < V_{LIN} < 18\text{ V}$ $T_j = -40\text{ }^{\circ}\text{C} \dots 105\text{ }^{\circ}\text{C}^{(1)}$			30	μA
		$GND = V_S$; $0\text{ V} < V_{LIN} < 18\text{ V}$ $T_j = 130\text{ }^{\circ}\text{C}^{(2)}$			35	μA
V_{LINdom}	LIN voltage level in dominant state	Active mode; $V_{TXD} = V_{TXDLOW}$; $R_{bus} = 500\text{ }\Omega$			1.2	V
V_{LINrec}	LIN voltage level in recessive state	Active mode; $V_{TXD} = V_{TXDHIGH}$; $I_{LIN} = 10\text{ }\mu A$	$0.8 \cdot V_S$			V
R_{LINup}	LIN output pull up resistor	$V_{LIN} = 0\text{ V}$	20	40	60	k Ω
C_{LIN}	LIN input capacitance	Guaranteed by design			100	pF

1. 105°C is the maximum junction temperature of an unpowered device according to this test condition within the specified ambient temperature range
2. Used for device test only

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6V \leq V_S \leq 28V$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

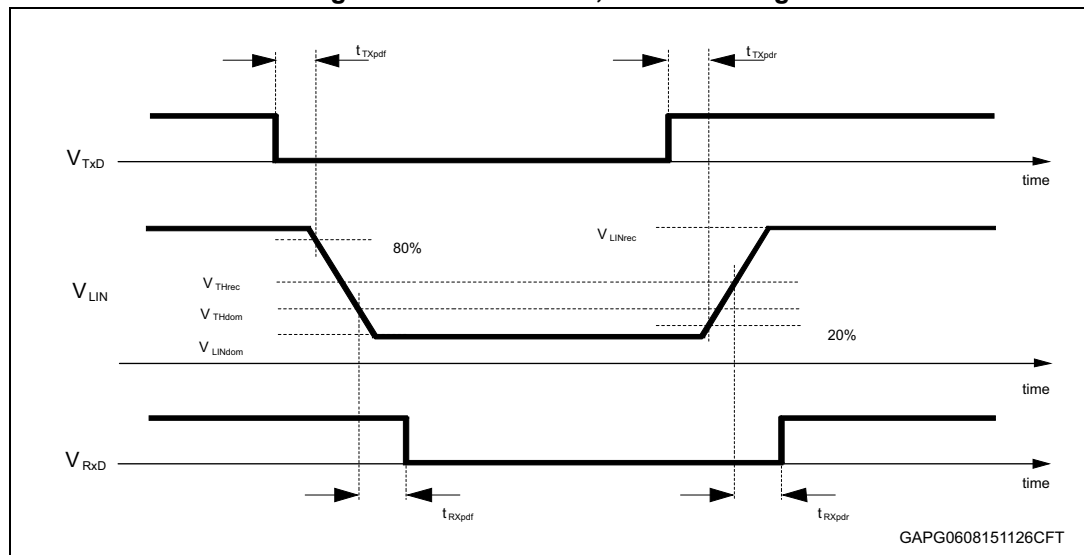
Table 29. LIN transceiver timing

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
t_{RXpd}	Receiver propagation delay time	$t_{RXpd} = \max(t_{RXpdr}, t_{RXpdf})$; $t_{RXpdf} = t(0.5 V_{RXD}) - t(0.45 V_{LIN})$; $t_{RXpdr} = t(0.5 V_{RXD}) - t(0.55 V_{LIN})$; $V_{SREG} = 12\text{ V}$; $C_{RXD} = 20\text{ pF}$; $R_{bus} = 1\text{ k}\Omega$, $C_{bus} = 1\text{ nF}$; $R_{bus} = 660\text{ }\Omega$, $C_{bus} = 6.8\text{ nF}$; $R_{bus} = 500\text{ }\Omega$, $C_{bus} = 10\text{ nF}$			6	μs
t_{RXpd_sym}	Symmetry of receiver propagation delay time (rising vs. falling edge)	$t_{RXpd_sym} = t_{RXpdr} - t_{RXpdf}$; $V_{SRE} = 12\text{ V}$; $R_{bus} = 1\text{ k}\Omega$; $C_{bus} = 1\text{ nF}$; $C_{RXD} = 20\text{ pF}$	-2		2	μs
D1	Duty Cycle 1	$TH_{Rec}(\max) = 0.744 * V_{SREG}$; $TH_{Dom}(\max) = 0.581 * V_{SREG}$; $V_{SREG} = 7\text{ to }18\text{ V}$, $t_{bit} = 50\text{ }\mu\text{s}$; $D1 = t_{bus_rec}(\min) / (2 * t_{bit})$; $R_{bus} = 1\text{ k}\Omega$, $C_{bus} = 1\text{ nF}$; $R_{bus} = 660\text{ }\Omega$, $C_{bus} = 6.8\text{ nF}$; $R_{bus} = 500\text{ }\Omega$, $C_{bus} = 10\text{ nF}$	0.396			
D2	Duty Cycle 2	$TH_{Rec}(\min) = 0.422 * V_{SREG}$; $TH_{Dom}(\min) = 0.284 * V_{SREG}$; $V_{SREG} = 7.6\text{ to }18\text{ V}$, $t_{bit} = 50\text{ }\mu\text{s}$; $D2 = t_{bus_rec}(\max) / (2 * t_{bit})$; $R_{bus} = 1\text{ k}\Omega$, $C_{bus} = 1\text{ nF}$; $R_{bus} = 660\text{ }\Omega$, $C_{bus} = 6.8\text{ nF}$; $R_{bus} = 500\text{ }\Omega$, $C_{bus} = 10\text{ nF}$			0.581	
D3	Duty Cycle 3	$TH_{Rec}(\max) = 0.778 * V_{SREG}$; $TH_{Dom}(\max) = 0.616 * V_{SREG}$; $V_{SREG} = 7\text{ to }18\text{ V}$, $t_{bit} = 96\text{ }\mu\text{s}$; $D3 = t_{bus_rec}(\min) / (2 * t_{bit})$; $R_{bus} = 1\text{ k}\Omega$, $C_{bus} = 1\text{ nF}$; $R_{bus} = 660\text{ }\Omega$, $C_{bus} = 6.8\text{ nF}$; $R_{bus} = 500\text{ }\Omega$, $C_{bus} = 10\text{ nF}$	0.417			
D4	Duty Cycle 4	$TH_{Rec}(\min) = 0.389 * V_{SREG}$; $TH_{Dom}(\min) = 0.251 * V_{SREG}$; $V_{SREG} = 7.6\text{ to }18\text{ V}$, $t_{bit} = 96\text{ }\mu\text{s}$; $D4 = t_{bus_rec}(\max) / (2 * t_{bit})$; $R_{bus} = 1\text{ k}\Omega$, $C_{bus} = 1\text{ nF}$; $R_{bus} = 660\text{ }\Omega$, $C_{bus} = 6.8\text{ nF}$; $R_{bus} = 500\text{ }\Omega$, $C_{bus} = 10\text{ nF}$			0.590	
$t_{dom}(TXDL)$	TXDL dominant time-out			12		ms

Table 29. LIN transceiver timing (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
t_{LIN}	LIN permanent recessive time-out			40		μs
$t_{dom(bus)}$	LIN Bus permanent dominant time-out			12		ms

Figure 16. LIN transmit, receive timing



3.4.21 SPI

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} < V_{SREG} < 18\text{ V}$; $V_1 = 5\text{ V}$; all outputs open; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

Table 30. Input: CSN

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{CSNLOW}	Input voltage low level	Normal mode	1.0			V
$V_{CSNHIGH}$	Input voltage high level	Normal mode			2.3	V
V_{CSNHYS}	$V_{CSNHIGH} - V_{CSNLOW}$	Normal mode	0.2			V
I_{CSNPU}	CSN Pull up resistor	Normal mode	13	29	46	k Ω

Table 31. Inputs: CLK, DI

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
t_{set}	Delay time from standby to Active mode	Time until SPI, ADC and OUT15/OUT_HS are operative		10		μs
t_{set_CP}	Delay time from standby to Active mode	Time until power stages that are supplied by the CP are operative	560	750	960	μs

Table 31. Inputs: CLK, DI (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{in_L}	Input low level		1.0			V
V_{in_H}	Input high level				2.3	V
V_{in_Hyst}	Input hysteresis		0.2			V
I_{pdin}	Pull down current at input	$V_{in} = 1.5\text{ V}$	5	30	60	μA
$C_{in}^{(1)}$	Input capacitance at input CSN, CLK, DI and PWM _{1,2}	Guaranteed by design			15	pF
f_{CLK}	SPI input frequency at CLK				4	MHz

1. Value of input capacity is not measured in production test. Parameter guaranteed by design.

Table 32. DI, CLK and CSN timing

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
t_{CLK}	Clock period		250			ns
t_{CLKH}	Clock high time		100			ns
t_{CLKL}	Clock low time		100			ns
t_{set_CSN}	CSN setup time, CSN low before rising edge of CLK		150			ns
t_{set_CLK}	CLK setup time, CLK high before rising edge of CSN		150			ns
t_{set_DI}	DI setup time		25			ns
t_{hold_DI}	DI hold time		25			ns
t_{r_in}	Rise time of input signal DI, CLK, CSN				25	ns
t_{f_in}	Fall time of input signal DI, CLK, CSN				25	ns

Note: See [Figure 18: SPI input timing](#).

Table 33. Output: DO

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{DOL}	Output low level	$I_{DO} = -4\text{ mA}$			0.5	V
V_{DOH}	Output high level	$I_{DO} = 4\text{ mA}$	$V_1 - 0.5$			V
I_{DOLK}	3-state leakage current	$V_{CSN} = V_1, 0\text{ V} < V_{DO} < V_1$	-10		10	μA
C_{DO}	3-state input capacitance	Guaranteed by design		10	15	pF

Table 34. DO timing

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$t_{r\ DO}$	DO rise time	$C_L = 50\text{ pF}$; $I_{LOAD} = -1\text{ mA}$			25	ns
$t_{f\ DO}$	DO fall time	$C_L = 50\text{ pF}$; $I_{LOAD} = -1\text{ mA}$			25	ns
$t_{en\ DO\ tri\ L}$	DO enable time from 3-state to low level	$C_L = 50\text{ pF}$; $I_{LOAD} = -1\text{ mA}$; pull-up load to V1		50	100	ns
$t_{dis\ DO\ L\ tri}$	DO disable time from low level to 3-state	$C_L = 50\text{ pF}$; $I_{LOAD} = -1\text{ mA}$; pull-up load to V1		50	100	ns
$t_{en\ DO\ tri\ H}$	DO enable time from 3-state to high level	$C_L = 50\text{ pF}$; $I_{LOAD} = -1\text{ mA}$; pull-down load to GND		50	100	ns
$t_{dis\ DO\ H\ tri}$	DO disable time from high level to 3-state	$C_L = 50\text{ pF}$; $I_{LOAD} = -1\text{ mA}$; pull-down load to GND		50	100	ns
$t_d\ DO$	DO delay time	$V_{DO} < 0.3\text{ V1}$; $V_{DO} > 0.7\text{ V1}$; $C_L = 50\text{ pF}$		30	60	ns

Note: See [Figure 19: SPI output timing](#).

Table 35. CSN timing

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$t_{CSN_HI,min}$	Minimum CSN high time, active mode	Transfer of SPI-command to Input Register	6			μs
$t_{CSNfail}$	CSN low timeout		20	35	50	ms

Note: See [Figure 20: SPI CSN - output timing](#).

3.4.22 Input LIN_FLASH for Flash mode

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_{SREG} \leq 18$; $V1 = 5\text{ V}$; $T_j = -40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$.

Table 36. Inputs LIN_FLASH for Flash mode

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{flashL}	Input low level (V_{LIN_FLASH} for exit from Flash mode)		6.1	7.25	8.4	V
V_{flashH}	Input high level (V_{LIN_FLASH} for transition into Flash mode)		7.4	8.4	9.4	V
$V_{flashHYS}$	Input voltage hysteresis		0.6	0.8	1.0	V

3.4.23 Inputs DIR, DIRH, PWMH

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_{\text{SREG}} \leq 18\text{ V}$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$.

Table 37. Inputs DIR, DIRH, PWMH

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{IL}	Input voltage low level	$V_{\text{SREG}} = 13.5\text{ V}$	1			V
V_{IH}	Input voltage high level	$V_{\text{SREG}} = 13.5\text{ V}$			2.3	V
V_{IHYS}	Input hysteresis	$V_{\text{SREG}} = 13.5\text{ V}$	0.2			V
I_{in}	Input pull-down current	$V_{\text{SREG}} = 13.5\text{ V}$	5	30	60	μA

3.4.24 Debug input

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_{\text{SREG}} \leq 18\text{ V}$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$.

Table 38. Debug input

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{dIL}	Input voltage low level	$V_{\text{SREG}} = 13.5\text{ V}$	1			V
V_{dIH}	Input voltage high level	$V_{\text{SREG}} = 13.5\text{ V}$			2.3	V
V_{dIHYS}	Input hysteresis	$V_{\text{SREG}} = 13.5\text{ V}$	0.2			V
R_{din}	Pull-down resistor	$V_{\text{DEBUG}} = 6\text{ to }18\text{ V}$	2.5	5	7.5	$\text{k}\Omega$

3.4.25 ADC characteristics

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_{\text{SREG}} \leq 18\text{ V}$, $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$.

Table 39. ADC characteristics

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
t_{con}	Conversion time			2.5		μs
f_{ADC}	Clock frequency (see $f_{\text{clk}2}$)			8		MHz
Acc	Accuracy	Voltage divider + reference ⁽¹⁾	-2		2	%
		Overall accuracy for WU input: WU = 22 V	-3		3	
		Overall accuracy for WU input: WU = 18 V	-3.5		3.5	
		Overall accuracy for WU input: WU = 6 V	-4		4	
		Overall accuracy for WU input: WU = 4.5 V	-4.6		4.6	

Table 39. ADC characteristics (continued)

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
IE_I	Integral linearity error				4	LSB
IE_D	Differential linearity error				2	LSB
V_{AINVS}	Conversion voltage range (V_S , V_{SREG} & WU)		1		22	V
$V_{AINTemp}$	Conversion voltage range ($T_{CL1} \dots T_{CL6}$)		0		2	V

1. Guaranteed by design.

3.4.26 Temperature diode characteristics

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_{SREG} \leq 18\text{ V}$, $T_j = -40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$

Table 40. Temperature diode characteristics

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$V_{TROOM\ 1-6}$	T_{SENSE} output voltage at $25\text{ }^\circ\text{C}$	$V_S = 12\text{ V}$; $T = 25\text{ }^\circ\text{C}$	—	1.4		V
$V_{TSENSE1-6}$	T_{SENSE} output voltage 1 - 8	$T = 25\text{ }^\circ\text{C}$; $T = 130\text{ }^\circ\text{C}$; $T = -40\text{ }^\circ\text{C}$	—	-4		mV/K

3.4.27 Interrupt outputs

The voltages are referred to ground and currents are assumed positive, when the current flows into the pin. $6\text{ V} \leq V_{SREG} \leq 18\text{ V}$, $T_j = -40\text{ }^\circ\text{C}$ to $150\text{ }^\circ\text{C}$

Table 41. Interrupt outputs

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
V_{INTL}	Output low level	$I_{INT} = -4\text{ mA}$			0.5	V
V_{INTH}	Output high level	$I_{INT} = 4\text{ mA}$	$V1 - 0.5$			V
I_{INTLK}	3-state leakage current	$0\text{ V} < V_{INT} < V1$	-10		10	μA
$t_{Interrupt}$	Interrupt pulse duration (NINT, $RxD_L/NINT$)			56		μs
t_{Int_react}	Interrupt reaction time	Tested by scan chain	6		40	μs

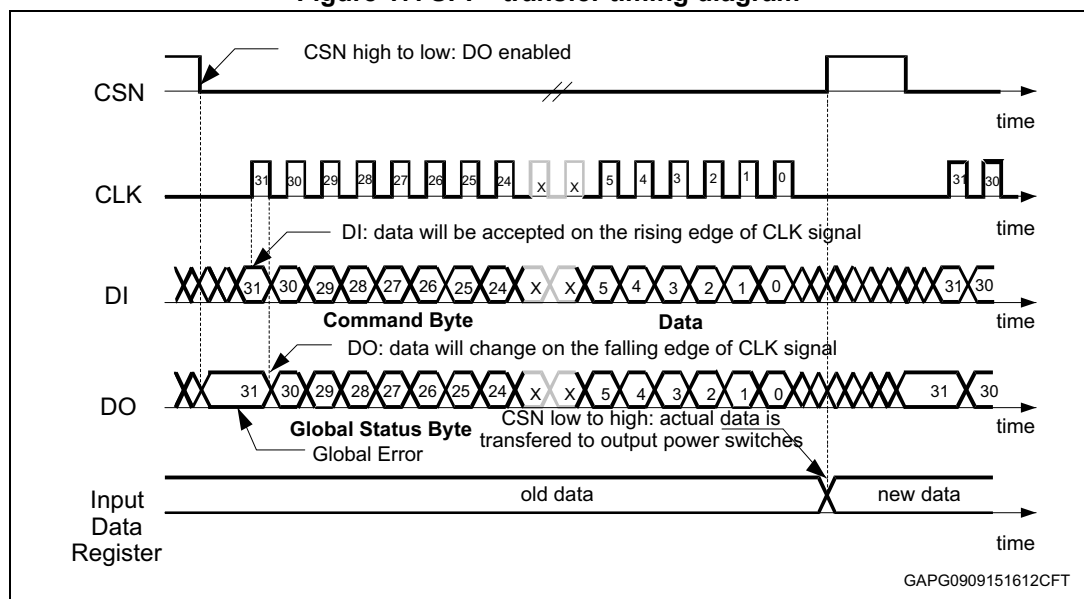
3.4.28 Timer1 and Timer2

$6\text{ V} \leq V_{\text{SREG}} \leq 18\text{ V}$; $T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$

Table 42. Timer1 and Timer2

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
ton 1	Timer on time			0.1		ms
ton 2	Timer on time			0.3		ms
ton 3	Timer on time			1		ms
ton 4	Timer on time			10		ms
ton 5	Timer on time			20		ms
T1	Timer period			10		ms
T2	Timer period			20		ms
T3	Timer period			50		ms
T4	Timer period			100		ms
T5	Timer period			200		ms
T6	Timer period			500		ms
T7	Timer period			1000		ms
T8	Timer period			2000		ms

Figure 17. SPI – transfer timing diagram



The SPI can be driven by a micro controller with its SPI peripheral running in the following mode:

CPOL = 0 and CPHA = 0.

For this mode input data is sampled by the low to high transition of the clock CLK, and output data is changed from the high to low transition of CLK.

Figure 18. SPI input timing

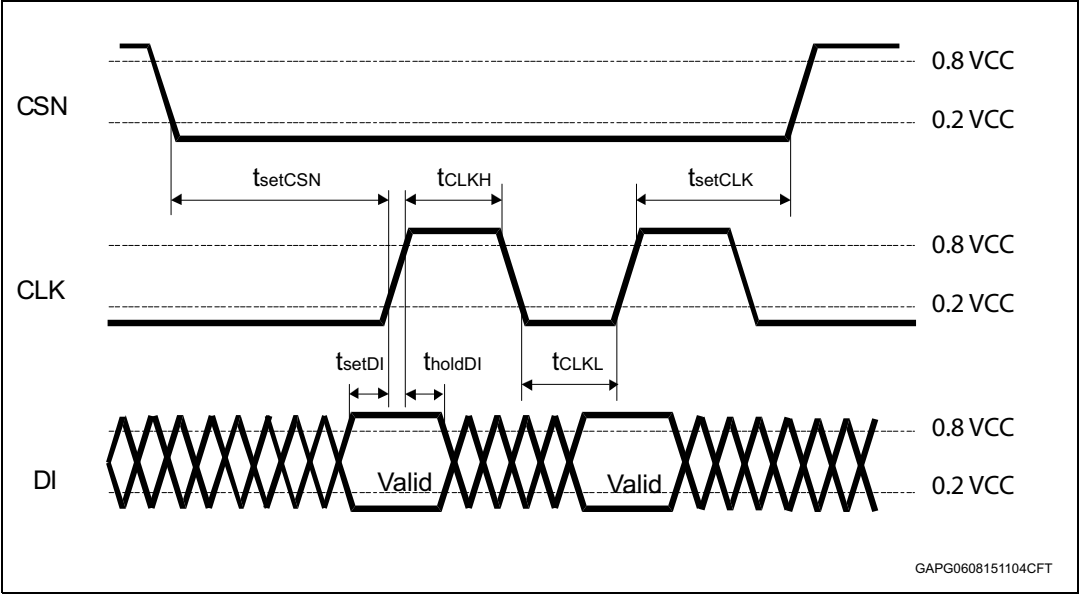


Figure 19. SPI output timing

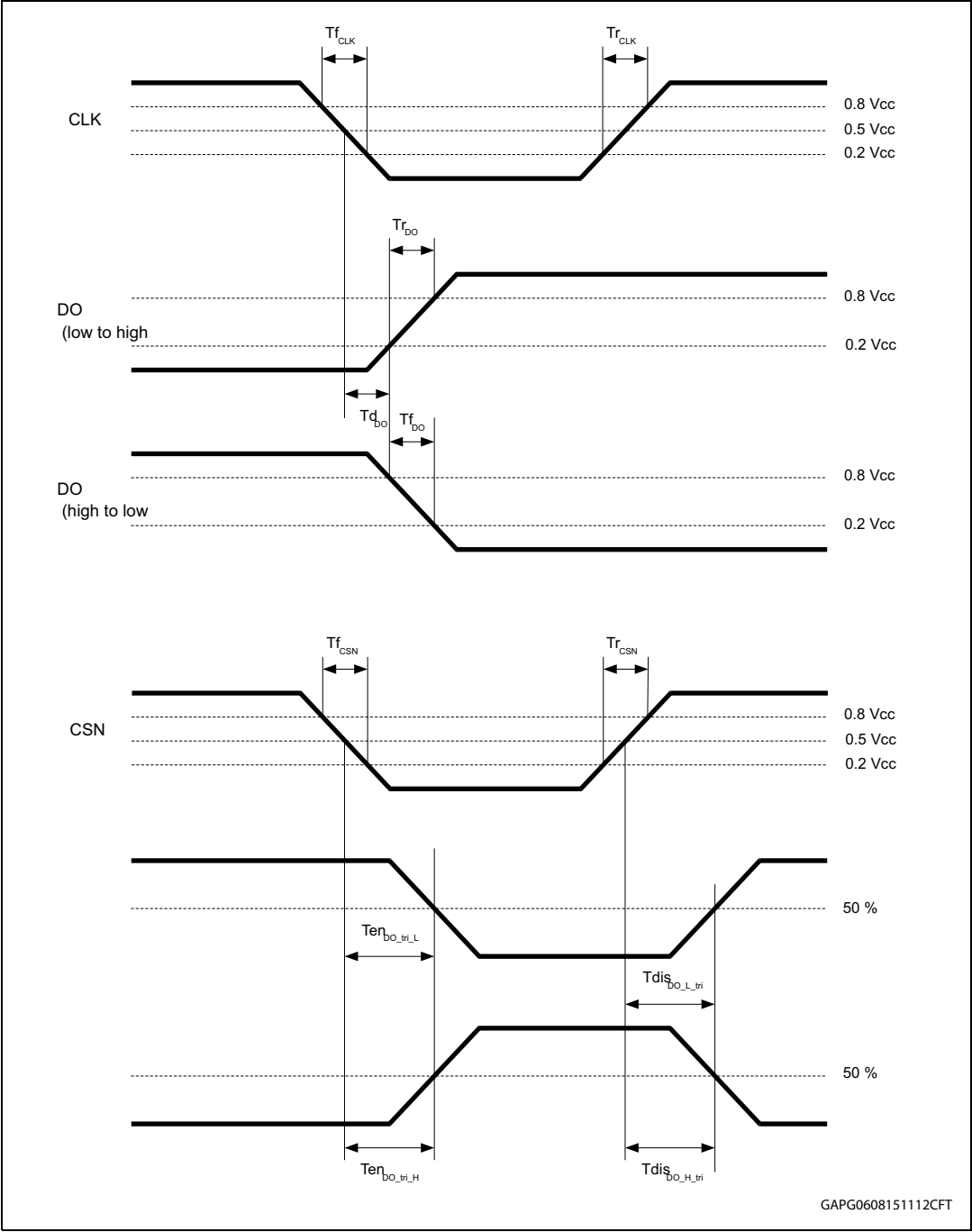


Figure 20. SPI CSN - output timing

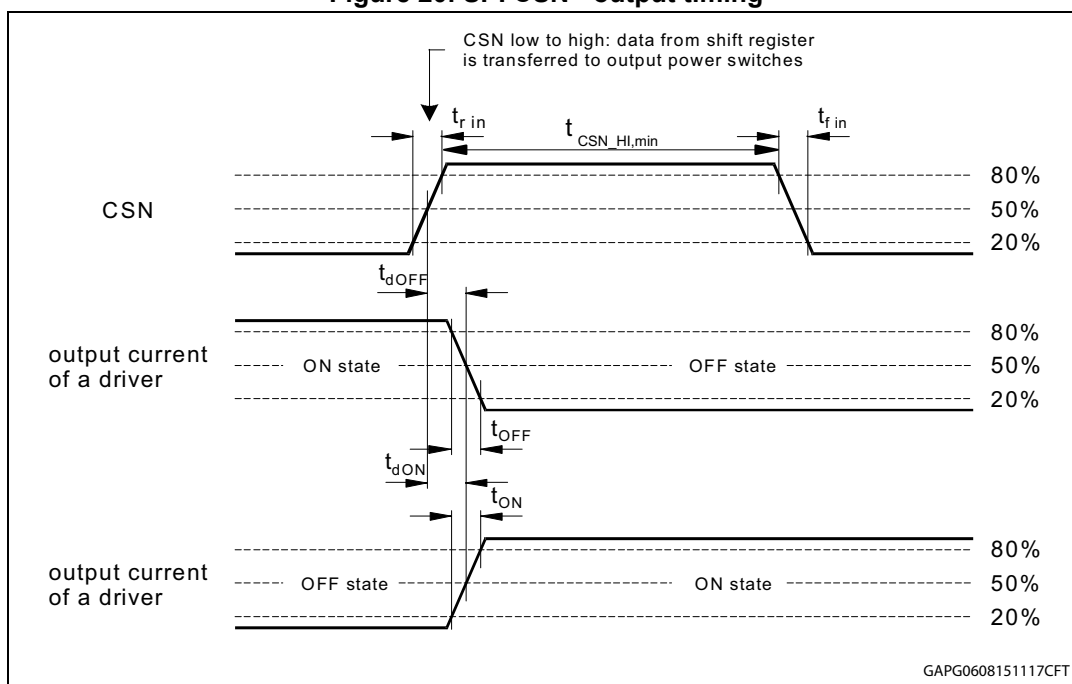
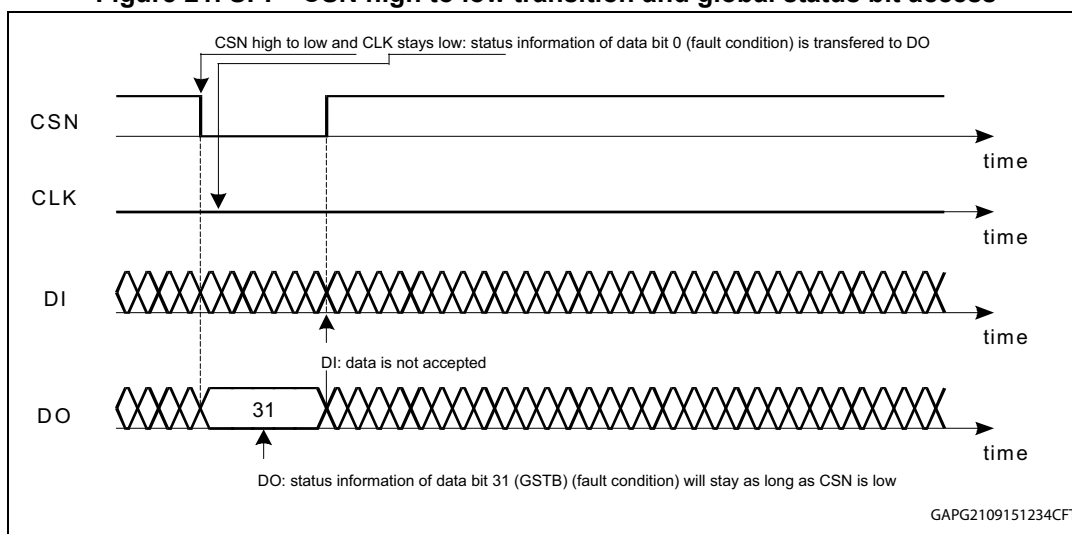


Figure 21. SPI – CSN high to low transition and global status bit access



3.4.29 SGND loss comparator

$T_j = -40\text{ }^{\circ}\text{C}$ to $150\text{ }^{\circ}\text{C}$, unless otherwise specified.

Table 43. SGND loss comparator

Symbol	Parameter	Test condition	Min.	Typ.	Max.	Unit
$V_{SGNDloss}$	V_{SGND} loss threshold	$(V_{SGND} - V_{PGND})$	100	270	500	mV
$t_{SGNDloss}$	V_{SGND} loss filter time		5	7	9	μs

4 Application information

4.1 Supply V_S , V_{SREG}

V_{SREG} supplies voltage regulators V1 and V2, all internal regulated voltages for analog and digital functionality, LIN and both P-channel high-side switches OUT15 and OUT_HS.

All other high-sides, Fail Safe block and the charge pump are supplied by V_S .

In case the V_{SREG} pin is disconnected, all power outputs connected to V_S are automatically switched off.

4.2 Voltage regulators

The device contains two independent and fully protected low drop voltage regulators designed for very fast transient response and do not require electrolytic output capacitors for stability.

The output voltage is stable with ceramic load capacitors >220 nF.

4.2.1 Voltage regulator: V1

The V1 voltage regulator provides 5 V supply voltage and up to 250 mA continuous load current to supply the system microcontroller. The V1 regulator is embedded in the power management and fail-safe functionality of the device and operates according to the selected operating mode. The V1 voltage regulator is supplied by pin V_{SREG} .

In addition, the V1 regulator supplies the devices internal loads. The voltage regulator is protected against overload and overtemperature. An external reverse current protection has to be provided by the application circuitry to prevent the input capacitor from being discharged by negative transients or low input voltage. Current limitation of the regulator ensures fast charge of external bypass capacitors. The output voltage is stable for ceramic load capacitors >220 nF.

In case the device temperature exceeds the TSD1 threshold (either cluster or grouped mode) the V1 regulator remains on. The micro controller has the possibility for interaction or error logging. If the chip temperature exceeds the TSD2 threshold ($TSD2 > TSD1$), V1 will be deactivated and all wakeup sources (LIN, WU and Timer) are disabled. After t_{TSD} , the voltage regulator will restart automatically. If the restart fails 7 times within one minute the devices enter the Forced Vbat_standby mode. The status bit FORCED_SLEEP_TSD2/V1SC (SR1) is set.

4.2.2 Voltage regulator: V2

The voltage regulator V2 is supplied by pin V_{SREG} and can supply additional 5 V loads such as sensors or potentiometers. The maximum continuous load current is 50 mA. The regulator is protected against:

- Overload
- Overtemperature
- Short-circuit (short to ground and battery supply voltage)
- Reverse biasing

4.2.3 Voltage regulator failure

The V1, and V2 regulator output voltages are monitored.

In case of a drop below the failure thresholds ($V1 < V1_{fail}$ for $t > t_{V1fail}$, $V2 < V2_{fail}$ for $t > t_{V2fail}$), the failure bits V1FAIL, V2FAIL (SR 2) are latched.

4.2.4 Short to ground detection

At turn-on of the V1 and V2 regulators, a short-to-GND condition is detected by monitoring the regulator output voltage.

If V1 or V2 is below the $V1_{fail}$ (or $V2_{fail}$) threshold for $t > t_{V1short}$ ($t > t_{V2short}$) after turn-on, the devices will identify a short circuit condition at the related regulator will be switched off.

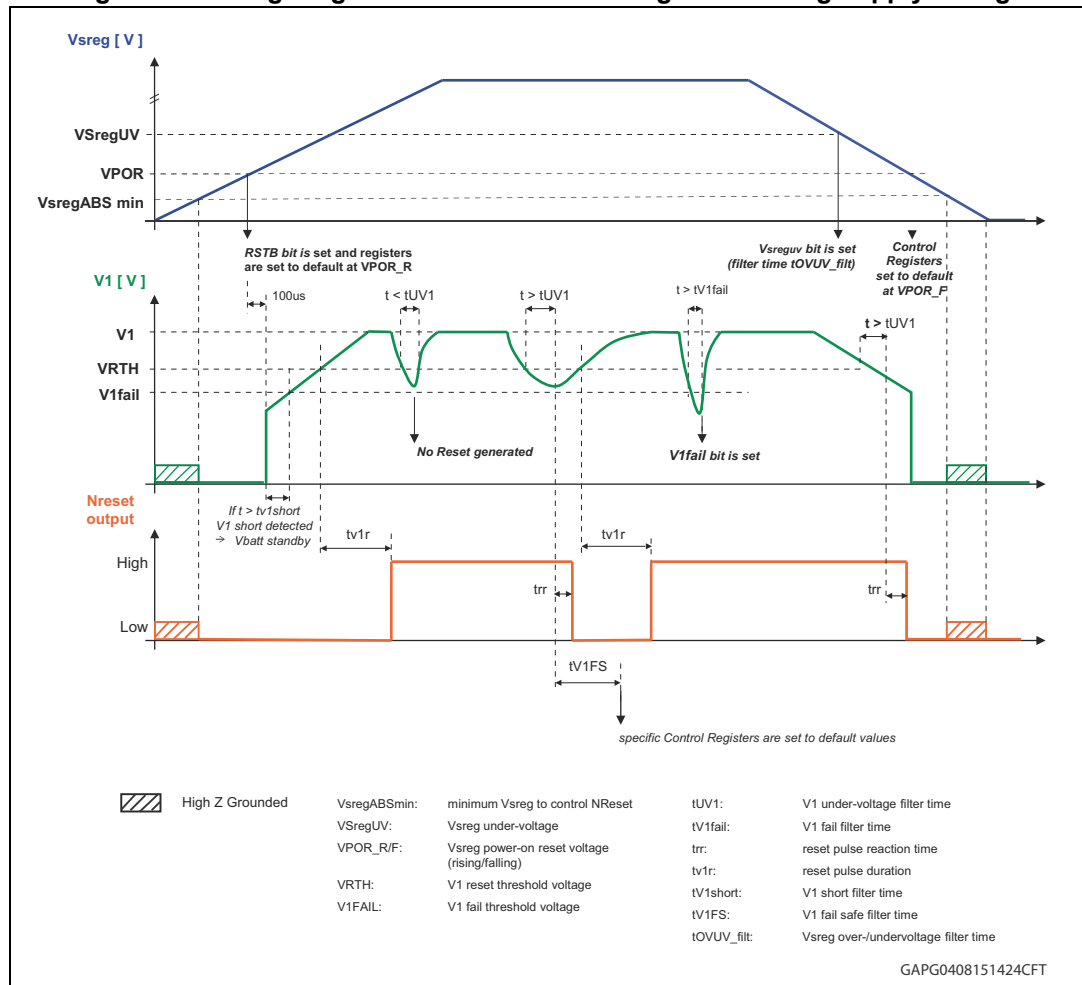
In case of V1 short-to-GND the device enters Forced Vbat_standby mode automatically. Bits FORCED_SLEEP_TSD2/V1SC and (SR 1) V1FAIL (SR 2) are set.

In case of a V2 short-to-GND failure the V2SC (SR 2) and V2FAIL (SR 2) bits are set.

Once the output voltage of the corresponding regulator exceeded the $V1_{fail}$ ($V2_{fail}$) threshold the short-to-ground detection is disabled. In case of a short-to-ground condition, the regulator is switched off due to thermal shutdown. V1 is switched off at TSD2, V2 is switched off at TSD1.

4.2.5 Voltage regulator behavior

Figure 22. Voltage regulator behaviour and diagnosis during supply voltage



4.3 Operating modes

The devices can be operated in the following operating modes:

- Active
- LIN Flash
- V_1 _standby
- $VBAT$ _standby
- Debug

4.3.1 Active mode

All functions are available and the device is controlled by SPI.

4.3.2 Flash mode

To program the system microcontroller via LIN bus signals, the devices can be operated in LIN Flash mode. The watchdog is disabled in this mode.

The Flash mode is entered by applying an external voltage at the pin:

- $V_{\text{LIN_FLASH}} \geq V_{\text{FlashH}}$ (LIN Flash mode)

In LIN Flash mode the maximum bitrate is increased to 100 kbit/s automatically (LIN_HS_EN = 1).

A transition from Flash mode to V1_standby or Vbat_standby mode is not possible.

At exit from Flash modes ($V_{\text{LIN_FLASH}} < V_{\text{FlashL}}$) no NReset pulse is generated. The watchdog starts with a Long Open Window (t_{LW}).

4.3.3 SW-debug mode

To allow software debugging, the watchdog can be deactivated by applying an external voltage to the DEBUG input pin ($V_{\text{debug}} > V_{\text{diH}}$).

In Debug mode, all device functionality and Operating modes are available. The watchdog is deactivated. At Exit from Debug mode ($V_{\text{debug}} < V_{\text{diL}}$) the watchdog starts with a Long Open Window.

Note: The device includes a test mode. This mode is activated by a dedicated sequence which includes a high voltage at the Debug Pin. The Debug Pin must be kept at nominal voltage levels in order to avoid accidental activation of the test mode.

4.3.4 V1_standby mode

The transition from Active mode to V1_standby mode is controlled by SPI.

To supply the micro controller in a low power mode, the V1 voltage regulator remains active.

After the V1_standby command (CSN low to high transition), the device enters V1_standby mode immediately and the watchdog starts a Long Open Window (t_{LW}). The watchdog is deactivated as soon as the V1 load current drops below the I_{CMP} threshold ($I_{\text{V1}} < I_{\text{cmp_fal}}$).

The V1 load current monitoring can be deactivated by setting ICMP = 1. In this configuration the watchdog will be deactivated upon transition into V1_standby mode without monitoring the V1 load current.

Writing ICMP (CR 34) = 1 is only possible with the first SPI command after setting ICMP_CONFIG_EN (Config Reg) = 1.

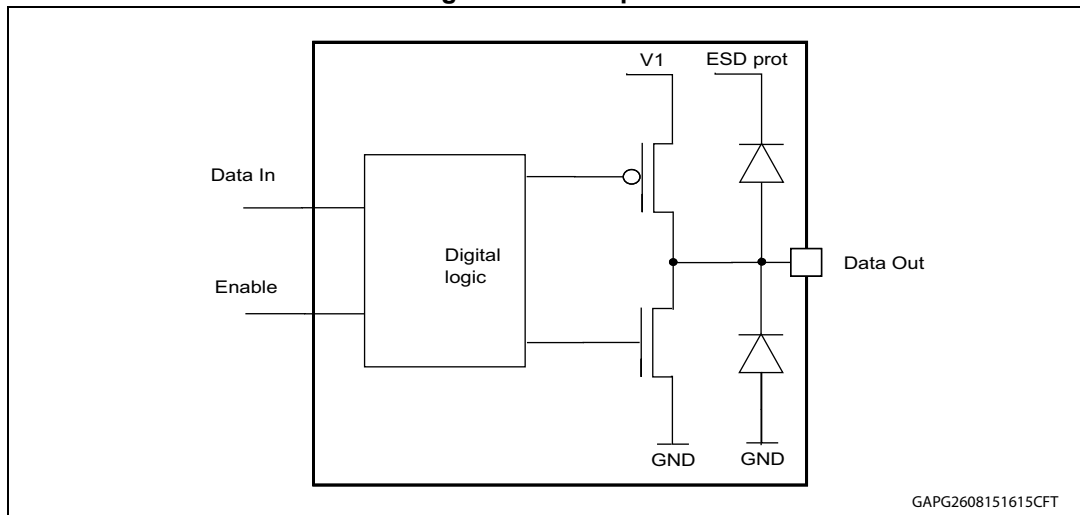
The ICMP_CONFIG_EN bit is reset to 0 automatically with the next SPI command.

Power outputs (except OUT_HS & OUT15) are switched off in V1_standby mode. OUT_HS & OUT15 remain in the configuration programmed prior to the standby command in order to enable (cyclic) supply of external contacts. The timer signal (Timer1 or Timer2) can be mirrored to the NINT output pin during V1_standby mode.

LIN transmitter (TxDL) is off.

4.3.5 Interrupt

Figure 23. NINT pins



RxDL/NINT indicates:

- a wake-up event from V1_standby mode and the programmable timer interrupt
RxDL/NINT pin is pulled low for $t = t_{\text{interrupt}}$.

NINT indicates:

- In Active mode:
V_{SREG} dropped below the programmed early warning threshold in Control Register 3 (V_{SREG} < VSREG_EW_TH); feature is deactivated if VSREG_EW_TH is set to 0 V.
In V1_standby mode
 - Programmable timer interrupt; An NINT pulse is generated at the beginning of the timer on-time (Timer 1 or Timer2)
 - Wake-up from V1_standby mode by any wake-up source
 NINT is pulled low for $t = t_{\text{interrupt}}$

In case of increasing V1 load current during V1_standby mode ($I_{V1} > I_{\text{cmp_ris}}$), the device remains in standby mode and the watchdog starts with a Long Open Window. No Interrupt signal is generated.

4.3.6 VBAT_standby mode

The transition from Active mode to Vbat_standby mode is initiated by an SPI command. In Vbat_standby mode, the voltage regulators V1 and V2 (depending on configuration in CR 1), the power outputs (except OUT15 and OUT_HS) as well as LIN transmitter are switched off.

An NReset pulse is generated upon wake-up from Vbat_standby mode.

4.4 Wake-up from Standby modes

A wake-up from standby mode will switch the device to Active mode. This can be initiated by one or more of the following events:

Table 44. Wake-up events description

Wake up source	Description
LIN bus activity	Always enabled
Level change of WU	Can be configured or disabled by SPI
$I_{V1} > I_{cmp_ris}$	Device remains in <i>V1_standby mode</i> but watchdog is enabled (If $I_{CMP} = 0$). No interrupt is generated.
Timer Interrupt / Wake up of μC by TIMER	Programmable by SPI: – <i>V1_standby mode</i> : device wakes up after programmable timer expiration. NINT and RxDL/NINT interrupt signals are generated – <i>Vbat_standby mode</i> : device wakes up after programmable timer expiration, V1 regulator is turned on and NReset signal is generated
SPI Access	Always active (except in <i>VBAT_STANDBY mode</i>) Wake up event: CSN is low and first rising edge on CLK

4.4.1 Wake up input

The WU input can be configured as wake-up source. The wake-up input is sensitive to any level transition (positive and negative edge) and can be configured for static or cyclic monitoring of the input voltage level.

For static contact monitoring, a filter time of t_{WU_STAT} is implemented. The filter is started when the input voltage passes the specified threshold V_{WU_THP} or V_{WU_THN} .

Cyclic contact monitoring allows periodical activation of the wake-up input to read the status of the external contact. The periodical activation can be configured to Timer 1 or Timer 2. The input signal is filtered with a filter time of t_{WU_CYC} after a delay (80% of the configured Timer on-time). A Wake-up will be processed if the status has changed versus the previous cycle. The buffered output OUT_HS can be used to supply the external contacts with the timer setting according to the cyclic monitoring of the wake-up input.

In standby modes, the input WU is configurable with an internal pull-up or pull-down current source according to the setup of the external contact. In Active mode the inputs have an internal pull down resistor (R_{WU_act}) and the input status can be read by SPI. Static sense should be configured before the read operation is started in order to reflect the actual input level.

4.5 Functional overview (truth table)

Table 45. Status of different functions/features vs operating modes

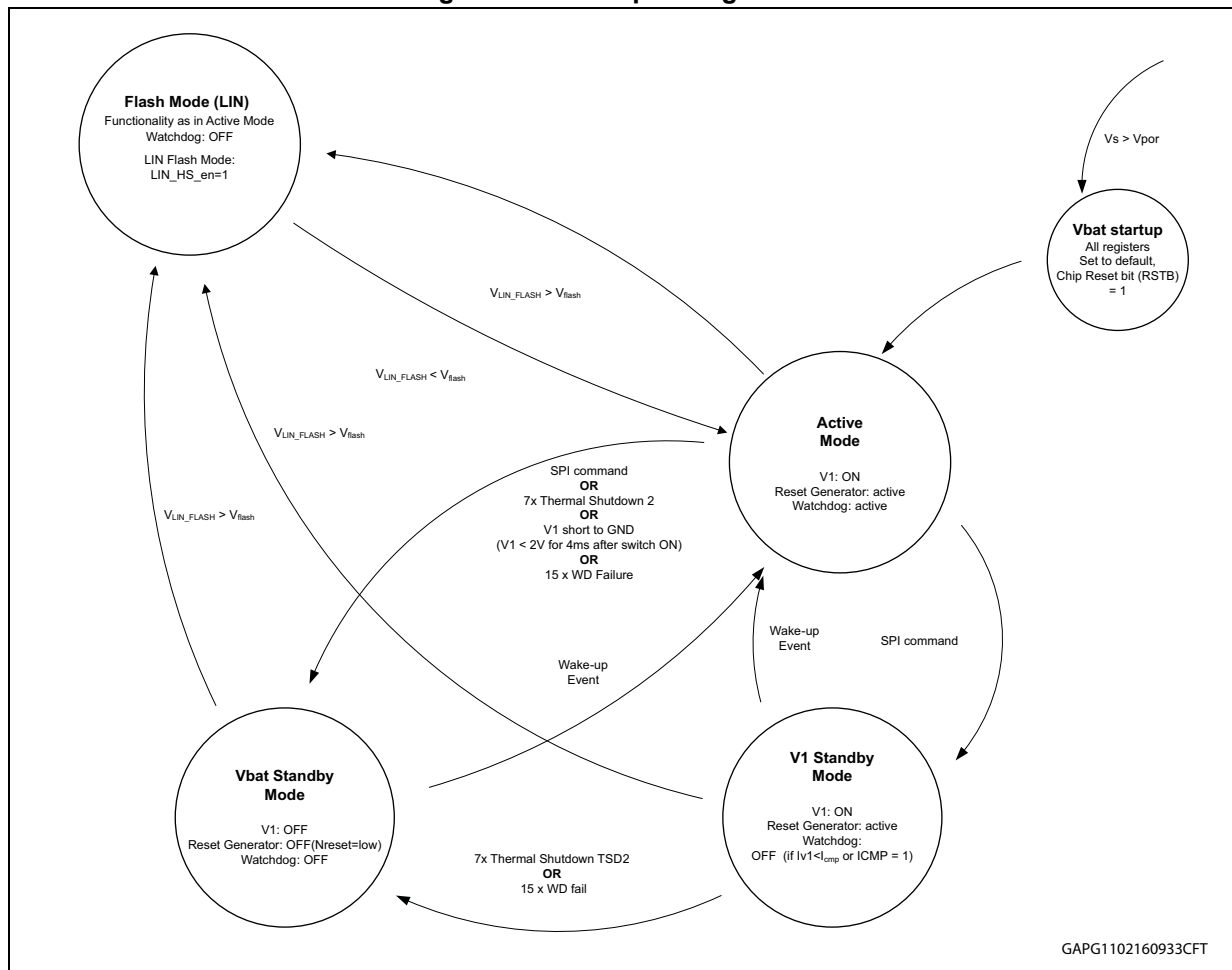
Function	Comments	Operating modes		
		Active mode	V ₁ -standby static mode (cyclic sense)	V _{bat} -standby static mode (cyclic sense)
Voltage regulator V1	$V_{OUT} = 5\text{ V}$	On	On ⁽¹⁾	Off
Voltage regulator V2	$V_{OUT} = 5\text{ V}$	On/ Off ⁽²⁾	On ⁽²⁾ / Off	On ⁽²⁾ / Off
Reset generator		On	On	Off

Table 45. Status of different functions/features vs operating modes (continued)

Function	Comments	Operating modes		
		Active mode	V ₁ -standby static mode (cyclic sense)	V _{bat} -standby static mode (cyclic sense)
Window watchdog	V ₁ monitor	On	Off (on if $I_{V1} > I_{CMP}$ and $I_{CMP} = 0$)	Off
Wake up		Off	Active ⁽³⁾	Active ⁽³⁾
HS-cyclic supply	Oscillator time base	On / Off	On ⁽²⁾ / Off	On ⁽²⁾ / Off
LIN	LIN 2.2a	On	Off ⁽⁴⁾	Off ⁽⁴⁾
Oscillator OSC1	2 MHz	On	On/Off ⁽⁵⁾	On/Off ⁽⁵⁾
Oscillator OSC2	32 MHz	ON	Off	Off
V _{SREG} -Monitor		On	(6)	(6)
V _S -Monitor		On	Off	Off
H-bridge Gate Driver, bridge drivers, all high-side drivers (except OUT_HS & OUT15) supplied by V _S		On/ Off ⁽²⁾	Off	Off
Fail-safe low-side switches		On/ Off ⁽⁷⁾	On	On
Short circuit protection for fail-safe low-side switches (in case LS is switched on)		On	On	On
OUT_HS & OUT15 (P-channel HS) supplied by V _{SREG}		On/ Off ⁽²⁾	On/ Off ⁽²⁾	On/ Off ⁽²⁾
Charge pump		On	Off	Off
ADC (SPI read out and V _{SREG} early warning interrupt)		On	Off	Off
Thermal shutdown TSD2		On	On	Off
Thermal shutdown TSD1x for OUT_HS and OUT15 (P-channel HS)		On	On/ Off ⁽²⁾	On/ Off ⁽²⁾

1. Supply the processor in low current mode.
2. According to SPI setting and DIR.
3. Unless disabled by SPI.
4. The bus state is internally stored when going to standby mode. A change of bus state will lead to a wake-up after exceeding of internal filter time.
5. ON, if cyclic sense is enabled or during wake-up request.
6. Cyclic activation = pulsed ON during cyclic sense.
7. ON in Fail-Safe mode; if standby mode is entered with active Fail-safe mode the output remains ON in standby mode.

Figure 24. Main operating modes



4.6 Configurable window watchdog

During normal operation, the watchdog monitors the micro controller within a programmable trigger cycle.

After power-on or standby mode, the watchdog is started with a timeout (Long Open Window t_{LW}). The timeout allows the micro controller to run its own setup and then to start the window watchdog by setting TRIG (CR1,ConfigReg) = 1

Subsequently, the micro controller has to serve the watchdog by alternating the watchdog trigger bit TRIG (CR1,Config Reg) within the safe trigger area T_{SWX} .

The trigger time is configurable by SPI. A correct watchdog trigger signal will immediately start the next cycle. After 8 watchdog failures in sequence, the V1 regulator is switched off for t_{V1OFF} . After 7 additional watchdog failures the V1 regulator is turned off permanently and the device goes into Forced Vbat_standby mode. The status bit FORCED_SLEEP_WD (SR 1) is set. A wake-up is possible by LIN.

After wake-up from Forced Vbat_standby mode and the watchdog trigger still fails, the device enters Forced Vbat_standby mode again after one Long Open Window.

This actually produces an additional watchdog failure but the watchdog fail counter will remain at maximum value of 15 failures.

This sequence is repeated until a valid watchdog trigger event is performed by writing $TRIG = 1$.

In case of a Watchdog failure, the power outputs and V2 are switched off and the status bit WDFAIL (SR 1) is set to 1. A reset pulse is generated at NReset output and the device enters Fail-safe mode. Control registers are set to their Fail Safe values and the Fail-safe low-side switches are turned on. Please refer to chapter [Section 4.7: Fail-safe mode](#) for more details.

The following diagrams illustrate the Watchdog behavior of the devices. The diagrams are split into 3 parts. The first diagram shows the functional behavior of the watchdog without any error. The second diagram covers the behavior covering all the error conditions, which can affect the watchdog behavior. [Figure 27: Watchdog in Flash mode](#) shows the transition in and out of Flash modes. [Figure 25](#), [Figure 26](#) and [Figure 27](#) can be overlapped to get all the possible state transitions under all circumstances. For a better readability, they were split in normal operating, operating with errors and Flash mode.

Figure 25. Watchdog in normal operating mode (no errors)

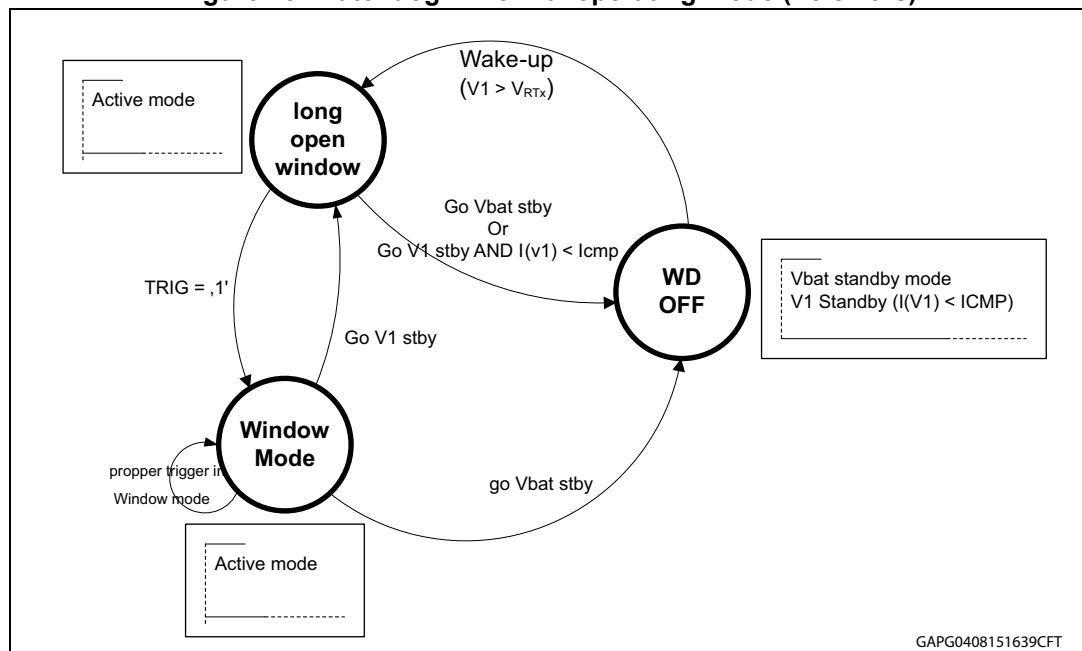


Figure 26. Watchdog with error conditions

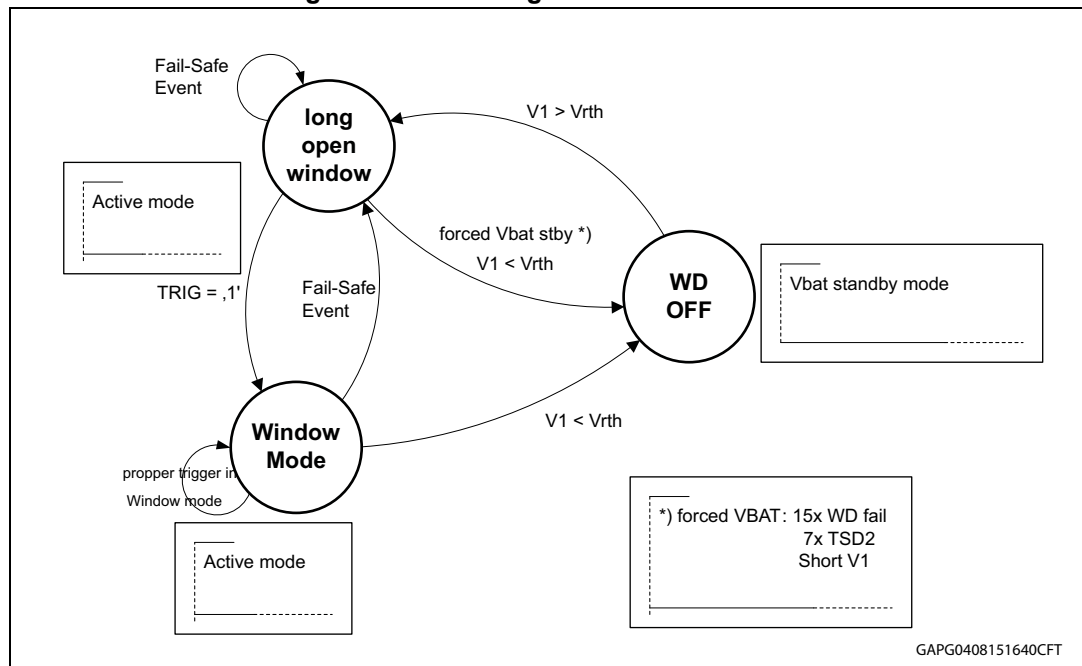
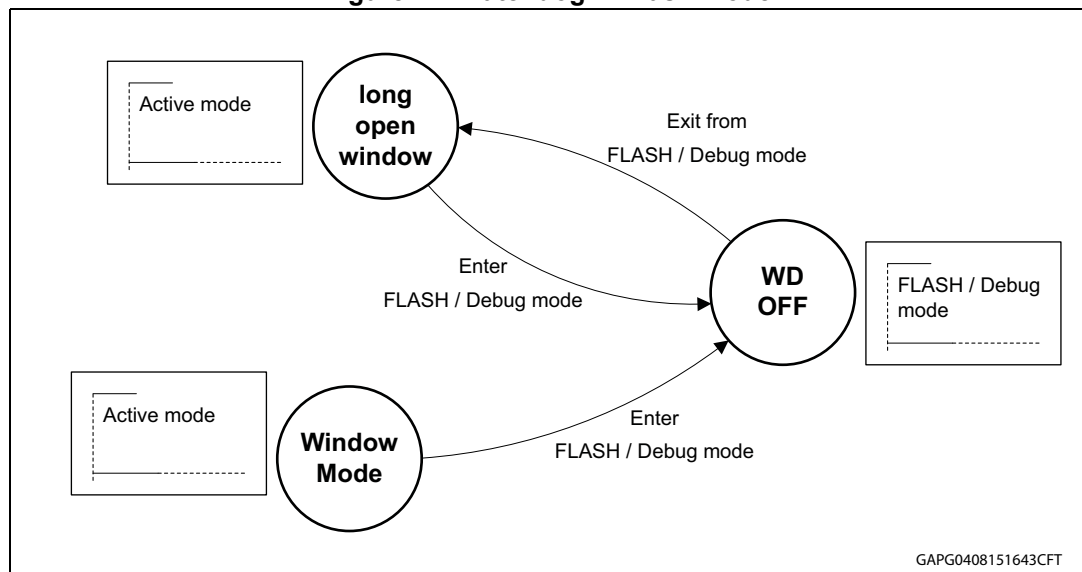


Figure 27. Watchdog in Flash mode



Note: Whenever the device is operated without servicing the mandatory watchdog trigger events, a sequence of 15 consecutive reset events is performed and the device enters the Forced_Vbat_Stby mode with bit FORCED_SLEEP_WD in SR1 set.

If the device is woken up after such a forced VBAT_Standby condition and the watchdog is still not serviced, the device, after one long open watchdog window will re-enter the same Forced_Vbat_Stby mode until the next wake up event. In this case, an additional watchdog failure is generated, but the fail counter is not cleared, keeping the maximum number of 15 failures. This sequence is repeated until a valid watchdog trigger event is performed by writing TRIG = 1.

4.6.1 Change watchdog timing

The watchdog trigger time is configured by setting WD_TIME_x (CR 2). Writing to these bits is possible only using the first SPI command after setting WD_CONFIG_EN = 1 (Config Reg). The WD_CONFIG_EN bit is reset to 0 automatically with the next SPI command.

4.7 Fail-safe mode

4.7.1 Temporary failures

The devices enter Fail-safe mode in case of:

- Watchdog failure
- V1 turn on failure
 - V1 short ($V1 < V1_{fail}$ for $t > t_{V1short}$)
- V1 failure ($V1 < V_{RTxfalling}$ for $t > t_{V1FS}$)
- Thermal Shutdown TSD2

The Fail Safe functionality is also available in V1_Standby mode. During V1_Standby mode the Fail Safe mode is entered in the following cases:

- V1 failure ($V1 < V_{RTxfalling}$ for $t > t_{V1FS}$)
- Watchdog failure (if watchdog still running due to $I_{V1} > I_{cmp_fal}$)
- Thermal Shutdown TSD2

In Fail Safe mode the devices return to a fail safe state. The Fail Safe condition is indicated to the system in the Global Status Byte. The conditions during Fail Safe mode are:

- All outputs beside LS1_FSO and LS2_FSO are turned off
- All Control Registers are set to fail safe default values
- Write operations to Control Registers are blocked until the Fail Safe condition is cleared. The following bits are not WRITE protected:
 - TRIG (CR1<bit 0>, Config Register <bit 0>): watchdog trigger bit
 - V2_x (CR1<bit 4:5>): Voltage Regulator V2 control
 - CR2 (bit <8:23>): Timer1 and Timer2 settings
 - OUT_HS_x (CR5 <bit 0:3>): OUT_HS configuration
 - OUT15_x (CR6<bit 0:3>): OUT15 configuration
 - PWMx_freq_y (CR12): PWM frequency configuration
 - PWMx_DC_y (CR13 – CR17): PWM duty cycle configuration
- LIN transmitter and SPI remain on (transmitters are deactivated in case of thermal shutdown TSD1 (TSD1 cluster 5 or 6 in cluster mode))
- Corresponding Failure Bits in Status Registers are set
- FS Bit (Global Status Byte) is set
- LS1_FSO and LS2_FSO will be turned on
- Charge pump is switched off

If the Fail Safe mode was entered it keeps active until the Fail safe condition is removed and the Fail Safe was read by SPI. Depending on the root cause of the Fail Safe operation, the actions to exit Fail safe mode are as shown in the following table.

Table 46. Temporary failures description

Failure source	Failure condition	Diagnosis	Exit from Fail-safe mode
Microcontroller (oscillator)	Watchdog early write failure or expired window	FS (Global Status Byte) =1; WDFAIL (SR 1) =1; WDFAIL_CNT_x (SR 1) = n+1	TRIG (CR 1) = 1 during long open window Read&Clear SR1
V1	Short at turn-on	FS (Global Status Byte) =1; FORCED_SLEEP_TSD2/V1SC (SR 1) =1	Wake-up; Read&Clear SR1
	Undervoltage	FS (Global Status Byte) = 1; V1UV (SR 1) = 1; V1fail (SR 2) = 1 ⁽¹⁾	V1 > V _{RTrising} ; Read&Clear SR1
Temperature	T _j > T _{SD2}	FS (Global Status Byte) = 1; TW (SR 2) = 1; TSD1 (SR 1) =1; TSD2 (SR 1) =1	T _j < T _{SD2} ; Read&Clear SR1

1. If V1 < V1_{fail} (for t > t_{V1fail}). The Fail-safe Bit is located in the Global Status Register.

4.7.2 Non-recoverable failures – forced Vbat_standby mode

If the Fail-safe condition persists and all attempts to return to normal system operation fail, the devices enter the *Forced Vbat_standby* mode in order to prevent damage to the system. The Forced Vbat_standby mode can be terminated by any wake-up source. The root cause of the Forced Vbat_standby mode is indicated in the SPI Status Registers.

In Forced Vbat_standby mode, all Control Registers are set to power-on default values except:

- CP_DITH_DIS (Config. Reg <bit 5>)

The Forced Vbat_standby mode is entered in case of:

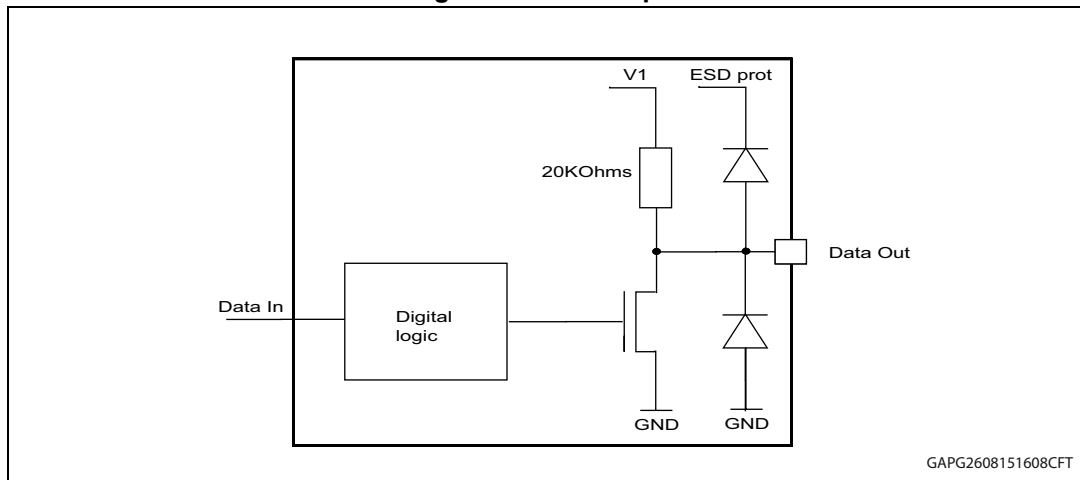
- Multiple watchdog failures: FORCED_SLEEP_WD (SR 1) = 1 (15 x watchdog failure)
- Multiple thermal shutdown 2: FORCED_SLEEP_TSD2/V1SC (SR 1) = 1 (7 x TSD2)
- V1 short at turn-on (V1 < V1_{fail} for t > t_{V1short}):
FORCED_SLEEP_TSD2/V1SC (SR 1) = 1

Table 47. Non-recoverable failure

Failure source	Failure condition	Diagnosis	Exit from Fail-safe mode
Microcontroller (Oscillator)	15 consecutive Watchdog Failures	FS (Global Status Byte) = 1; WDFAIL (SR 1) = 1; FORCED_SLEEP_WD (SR 1) = 1	Wake-up; TRIG (CR 1) = 1 during long open window; Read&Clear SR1
V1	Short at turn-on	FS (Global Status Byte) = 1; FORCED_SLEEP_TSD2/V1SC (SR 1) = 1	Wake-up; Read&Clear SR1
Temperature	7 times TSD2	FS (Global Status Byte) =1; TW (SR 2) = 1; TSD1 (SR 1) = 1; TSD2 (SR 1) = 1; FORCED_SLEEP_TSD2/V1SC (SR 1) = 1	Wake-up; Read&Clear SR1

4.8 Reset output (NReset)

Figure 28. NReset pin



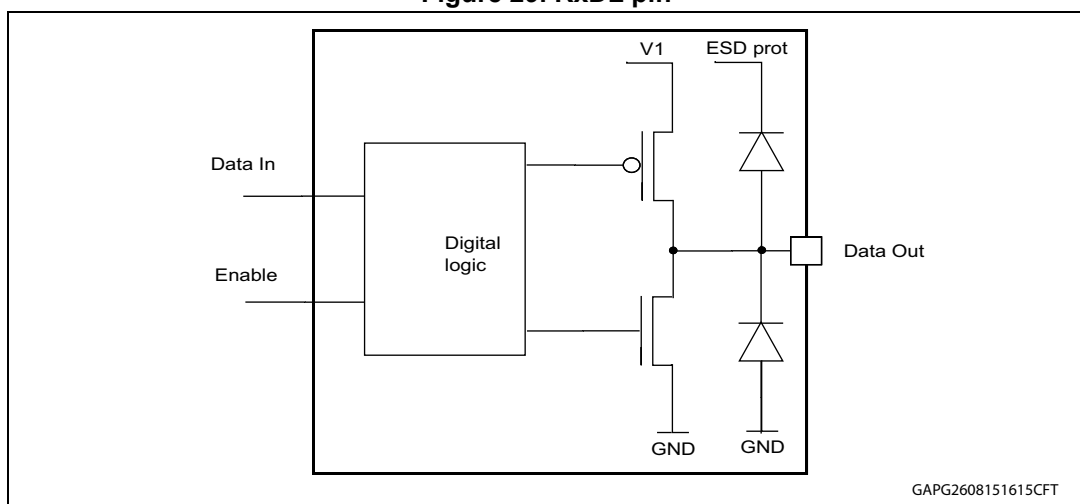
If V1 is turned on and the voltage exceeds the V1 reset threshold, the reset output *NReset* is pulled up to V1 by an internal pull-up resistor after a reset delay time (t_{V1R}). This is necessary for a defined start of the micro controller when the application is switched on. Since the *NReset* output is realized as an open drain output it is also possible to connect an external *NReset* open drain *NReset* source to the output. As soon as the *NReset* is released by the devices the watchdog starts with a long open window.

A reset pulse is generated in case of:

- V1 drops below $V_{RTxfalling}$ (configurable by SPI) for $t > t_{UV1}$
- Watchdog failure
- Turn-on of the V1 regulator (V_{SREG} Power-on or wake-up from Vbat_standby mode)

4.9 LIN Bus Interface

Figure 29. RxDL pin



4.9.1 Features

- LIN 2.2a compliant (SAEJ2602 compatible) transceiver
- LIN Cell has been designed according to “Hardware requirements for transceivers (version 1.3)”
- Bitrate up to 20 kbit/s
- Dedicated LIN Flash mode with bitrate up to 100 kbit/s
- GND disconnection fail safe at module level
- Off mode: does not disturb network
- GND shift operation at system level
- Micro controller Interface with CMOS-compatible I/O pins
- Internal pull-up resistor
- Receive-only mode
- ESD and transient immunity according to ISO7637 and EN / IEC61000-4-2
- Matched output slopes and propagation delay
- Wake-up behaviour according to LIN2.2a and Hardware Requirements for LIN, CAN and Flexray Interfaces (version 1.3)

At $V_{SREG} > V_{POR}$ (i.e. V_{SREG} power-on reset threshold), the LIN transceiver is enabled. The LIN transmitter is disabled in case of the following errors:

- Dominant TxDL time out
- LIN permanent recessive
- Thermal shutdown 1
- V_{SREG} overvoltage/ undervoltage

The LIN receiver is not disabled in case of any failure condition.

The default bitrate of the transceiver allows communication up to 20 kbit/s. To enable fast flashing via the LIN bus, the transceiver can be operated in high speed mode by setting bit LIN_HS_EN (Config Reg) = 1. This feature is enabled automatically in LIN Flash mode.

4.9.2 Error handling

The devices LIN transceiver provides the following 3 error handling features.

Dominant TxDL time out

If TXD_L is in dominant state (low) for $t > t_{dom(TXDL)}$ the transmitter will be disabled, the status bit LIN_TXD_DOM (SR 2) will be set.

The transmitter remains disabled until the status bit is cleared.

The TxD dominant timeout detection can be disabled via SPI (LIN_TXD_TOUT_EN = 0).

Permanent recessive

If TXD_L changes to dominant (low) state but RXD_L signal does not follow within $t < t_{LIN}$ the transmitter will be disabled, the status bit LIN_PERM_REC (SR 2) will be set.

The transmitter remains disabled until the status bit is cleared.

Permanent dominant

If the bus state is dominant (low) for $t > t_{\text{dom}}(\text{bus})$ a bus permanent dominant failure will be detected. The status bit LIN_PERM_DOM (SR 2) will be set.

The transmitter will not be disabled.

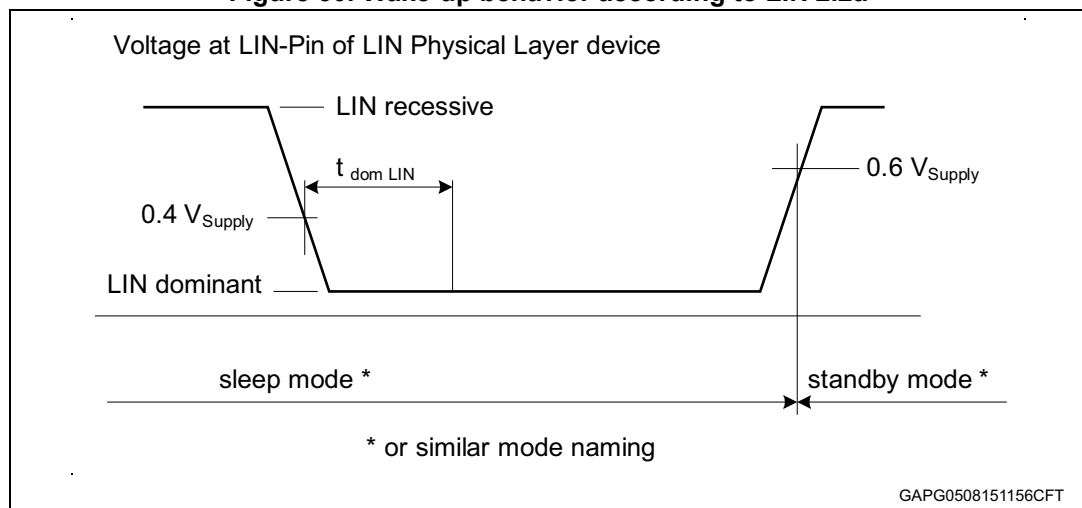
4.9.3 Wake up from Standby modes

In low power modes (V1_standby mode and Vbat_standby mode) the devices can receive two types of wake up signals from the LIN bus (configurable by SPI bit LIN_WU_CONFIG (Config Reg)):

- Recessive-Dominant-recessive pattern with $t > t_{\text{dom_LIN}}$ (default, according to LIN 2.2a)
- State Change recessive-to-dominant or dominant-to-recessive (according to LIN 2.1)

Pattern Wake-up (default)

Figure 30. Wake-up behavior according to LIN 2.2a



Status change wake-up - Recessive-to-dominant

Normal wake-up can occur when the LIN transceiver was set in standby mode while LIN was in recessive (high) state. A dominant level at LIN for $t > t_{\text{LINBUS}}$, will switch the devices to Active mode.

Status change wake-up - Dominant-to-recessive

If the LIN transceiver was set in standby mode while LIN was in dominant (low) state, recessive level at LIN for $t > t_{\text{LINBUS}}$, will switch the devices to Active mode.

4.9.4 Receive-only mode

The LIN transmitter can be disabled in Active mode by setting the bit LIN_REC_ONLY (CR2). In this mode it is possible to listen to the bus but not sending to it.

4.10 Serial Peripheral Interface (ST SPI Standard)

A 32-bit SPI is used for bi-directional communication with the microcontroller.

The SPI is driven by a microcontroller with its SPI peripheral running in following mode: CPOL = 0 and CPHA = 0. For this mode input data is sampled by the low to high transition of the clock CLK, and output data is changed from the high to low transition of CLK.

This device is not limited to microcontroller with a built-in SPI. Only three CMOS-compatible output pins and one input pin is needed to communicate with the device. A fault condition can be detected by setting CSN to low. If CSN = 0, the DO-Pin reflects the global error flag (fault condition) of the device.

- Chip Select Not (CSN)

The input Pin is used to select the serial interface of this device. When CSN is high, the output Pin (DO) is in high impedance state. A low signal activates the output driver and a serial communication can be started.

The state during CSN = 0 is called a communication frame.

If CSN = low for $t > t_{\text{CSNfail}}$ the DO output is switched to high impedance in order not to block the signal line for other SPI nodes.

- Serial Data In (DI)

The input Pin is used to transfer data serial into the device. The data applied to the DI is sampled at the rising edge of the CLK signal and shifted into an internal 32-bit shift register. At the rising edge of the CSN signal the content of the shift register is transferred to Data Input Register. The writing to the selected Data Input Register is only enabled if exactly 32-bit are transmitted within one communication frame (i.e. CSN low). If more or less clock pulses are counted within one frame the complete frame is ignored. This safety function is implemented to avoid an activation of the output stages by a wrong communication frame.

Note: Due to this safety functionality a daisy chaining of SPI is not possible. Instead, a parallel operation of the SPI bus by controlling the CSN signal of the connected IC's is recommended.

- Serial Data Out (DO)

The data output driver is activated by a logical low level at the CSN input and will go from high impedance to a low or high level depending on the global error flag (fault condition). The first rising edge of the CLK input after a high to low transition of the CSN Pin will transfer the content of the selected status register into the data out shift register. Each subsequent falling edge of the CLK will shift the next bit out.

- Serial Clock (CLK)

The CLK input is used to synchronize the input and output serial bit streams. The data input (DI) is sampled at the rising edge of the CLK and the data output (DO) will change with the falling edge of the CLK signal. The SPI can be driven with a CLK Frequency up to 4 MHz.

4.11 Power supply failure

4.11.1 V_S supply failure

V_S overvoltage

If the supply voltages V_S reaches the overvoltage threshold V_{SOV} :

- LIN remains enabled
- OUT1 to OUT_14 are turned off (default).
The shutdown of outputs may be disabled by SPI ($VS_OV_SD_EN$ (CR 3) = 0)
- Charge pump is disabled (and is switched on automatically in case the supply voltage recovers to normal operating voltage)
- H-bridge gate driver is switched into sink condition
- Recovery of outputs after overvoltage condition is configurable by SPI:
 - VS_LOCK_EN (CR 3) = 1: outputs are off until Read&Clear VS_OV (SR 2).
 - VS_LOCK_EN (CR 3) = 0: outputs turned on automatically after V_S overvoltage condition has recovered.
- The overvoltage bit VS_OV (SR 2) is set and can be cleared with a 'Read&Clear' command. The overvoltage bit is reset automatically if VS_LOCK_EN (CR 3) = 0 and the overvoltage condition has recovered.

V_S undervoltage

If the supply voltage V_S drops below the under voltage threshold voltage (V_{SUV}):

- LIN remains enabled
- OUT1 to OUT14 are turned off (default).
- The shutdown of outputs may be disabled by SPI ($VS_UV_SD_EN$ (CR 3) = 0)
- Recovery of outputs after undervoltage condition is configurable by SPI:
 - VS_LOCK_EN (CR 3) = 1: outputs are off until Read&Clear VS_UV (SR 2).
 - VS_LOCK_EN (CR 3) = 0: outputs turned on automatically after V_S undervoltage condition has recovered.
- The undervoltage bit VS_UV (SR 2) is set and can be cleared with a 'Read&Clear' command. The undervoltage bit is removed automatically if VS_LOCK_EN (CR 3) = 0 and the undervoltage condition has recovered.

4.11.2 V_{SREG} supply failure

V_{SREG} overvoltage

If the supply voltages V_{SREG} reaches the overvoltage threshold V_{SREG_OV}:

- LIN is switched to high impedance
- OUT15 and OUT_HS are turned off (default).
The shutdown of outputs may be disabled by SPI (V_{SREG_OV_SD_EN} (CR 3) = 0)
- Recovery of outputs after overvoltage condition is configurable by SPI:
 - VSREG_LOCK_EN (CR 3) = 1: outputs are off until Read&Clear VSREG_OV (SR 2).
 - VSREG_LOCK_EN (CR 3) = 0: outputs turned on automatically after V_{SREG} overvoltage condition has recovered.
- The overvoltage bit VSREG_OV (SR 2) is set and can be cleared with a 'Read&Clear' command. The overvoltage bit is reset automatically if VSREG_LOCK_EN (CR 3) = 0 and the overvoltage condition has recovered.

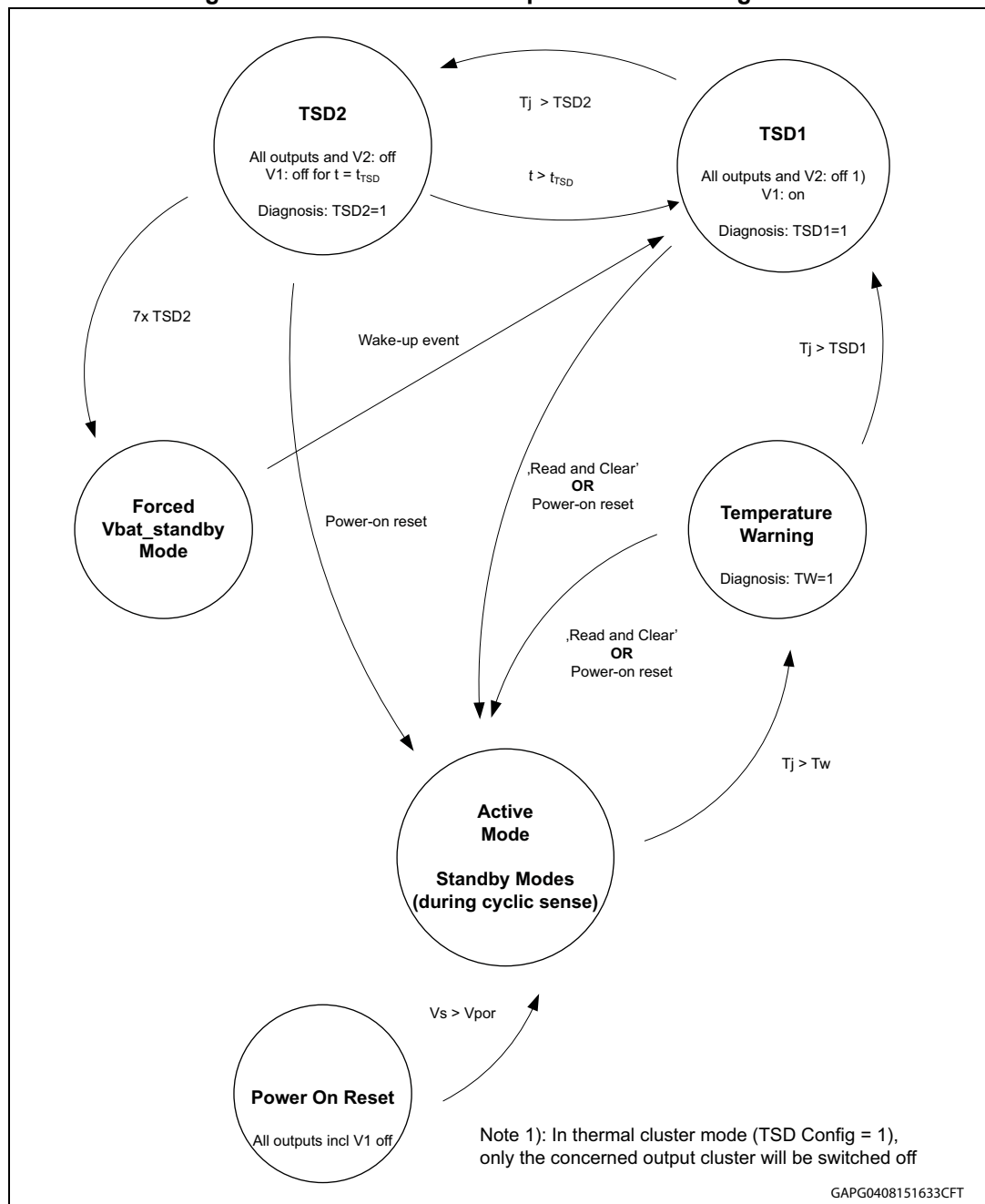
V_{SREG} undervoltage

If the supply voltage V_{SREG} drops below the under voltage threshold voltage (V_{SREG_UV}):

- LIN is switched to high impedance
- OUT15 and OUT_HS are turned off (default).
- The shutdown of outputs may be disabled by SPI (VSREG_UV_SD_EN (CR 3) = 0)
- Recovery of outputs after undervoltage condition is configurable by SPI:
 - VSREG_LOCK_EN (CR 3) = 1: outputs are off until Read&Clear VSREG_UV (SR 2).
 - VSREG_LOCK_EN (CR 3) = 0: Outputs turned on automatically after V_{SREG} undervoltage condition has recovered.
- The undervoltage bit VSREG_UV (SR 2) is set and can be cleared with a 'Read&Clear' command. The undervoltage bit is removed automatically if VSREG_LOCK_EN (CR 3) = 0 and the undervoltage condition has recovered.

4.12 Temperature warning and thermal shutdown

Figure 31. Thermal shutdown protection and diagnosis



Note: The Thermal State machine will recover the same state as before entering Standby mode. In case of a TSD2 it will enter TSD1 state.

4.13 Power outputs OUT1..15 and OUT_HS

The component provides a total of 4 half bridges outputs OUT1, OUT4-6 to drive motors and 10 stand alone high-side outputs OUT7..15 and OUT_HS to drive e.g. LED's, bulbs or to supply contacts. All high-side outputs beside OUT_HS and OUT15 are supplied by the pin VS and OUT_HS and OUT15 are supplied by the buffered supply VSREG. OUT_HS is intended to be used as contact supply. Beside OUT15 and OUT_HS the high-side switches can be activated only in case of running charge pump. OUT15 and OUT_HS can be activated also in standby modes.

All high-side and low-side outputs switch off in case of:

- V_S (V_{SREG}) overvoltage and undervoltage (depending on configuration, see [Section 4.11.2: \$V_{SREG}\$ supply failure](#))
- Overcurrent (depending on configuration, auto recovery mode (see below))
- Overtemperature (TSD1x/ cluster or single mode)
- Fail safe event
- Loss of GND at SGND pin

In case of overcurrent or overtemperature (TSD1_CLx (SR 6)) condition, the drivers will switch off. The relevant status bit will be latched and can be read and optionally cleared by SPI. The drivers remain off until the status is cleared. In case overvoltage/ undervoltage condition, the drivers will be switched off. The relevant status bit will be latched and can be read and optionally cleared by SPI. If VSREG_LOCK_EN (CR 3) respectively VS_LOCK_EN (CR 3) are set, the drivers remain off until the status is cleared. If the VS_LOCK_EN or VSREG_LOCK_EN bit is set to 0, the drivers will switch on automatically if the error condition disappears. Undervoltage and overvoltage shutdown can be disabled by SPI. In case of open-load condition, the relevant status register will be latched. The status can be read and optionally cleared by SPI. The high and low-side outputs are not switched off in case of open-load condition.

For OUT1, OUT4-8 and OUT_HS the auto recovery feature (OUTx_OCR (CR 7)) can be enabled; half-bridges and high-side drivers have different Auto recovery frequencies (frecx_hs and frecx_hb). If these bits are set to 1 the driver will automatically restart from an overload condition. This overload recovery feature is intended for loads which have an initial current higher than the overcurrent limit of the output (e.g. Inrush current of cold light bulbs). The SPI bits OUTx_OCR_ALERT (SR4) indicate that the output reached auto-recovery condition.

Note: The maximum voltage and current applied to the high-side Outputs is specified in the 'Absolute Maximum Ratings'. Appropriate external protection may be required in order to respect these limits under application conditions. In case of outputs switch off due to loss of ground at SGND pin, the device has to be re-started through a power off on both V_S and V_{SREG}

Each of the stand alone high-side driver outputs OUT7 ... OUT15 and OUT_HS can be driven with an internally generated PWM signal, an internal Timer or with DIR1 respectively DIR2. See [Table 48](#).

Table 48. Power output settings

OUTx_3	OUTx_2	OUTx_1	OUTx_0	Description
0	0	0	0	OFF
0	0	0	1	ON
0	0	1	0	Timer1 output is controlled by timer1; starting with ON phase after timer restart
0	0	1	1	Timer2 output is controlled by timer2; starting with ON phase after timer restart
0	1	0	0	PWM1
0	1	0	1	PWM2
0	1	1	0	PWM3
0	1	1	1	PWM4
1	0	0	0	PWM5
1	0	0	1	PWM6
1	0	1	0	PWM7
1	0	1	1	PWM8
1	1	0	0	PWM9
1	1	0	1	PWM10
1	1	1	0	DIR1
1	1	1	1	DIR2

4.14 Auto-recovery alert and thermal expiration

The thermal expiration feature provides a robust protection against possible microcontroller malfunction, switching off a given channel if continuously driven in auto-recovery. If the temperature of the related cluster increases by more than 30 °C after reaching the auto-recovery time t_{AR} , the channel is switched off. The thermal expiration status bit OUTx_TH_EX (SR 3) is set.

During auto-recovery condition, OUTx_OCR_ALERT (SR 4) is set. The Alert bit indicates that an overload condition (load in-rush, short-circuit, etc) is present.

The thermal expiration feature is controlled by SPI (OUTx_OCR_THX_EN (CR 8).

Figure 32. Example of long auto-recovery on OUT7. Temperature acquisition starts after t_{AR} , thermal expiration occurs after a $\Delta T = 30^\circ$

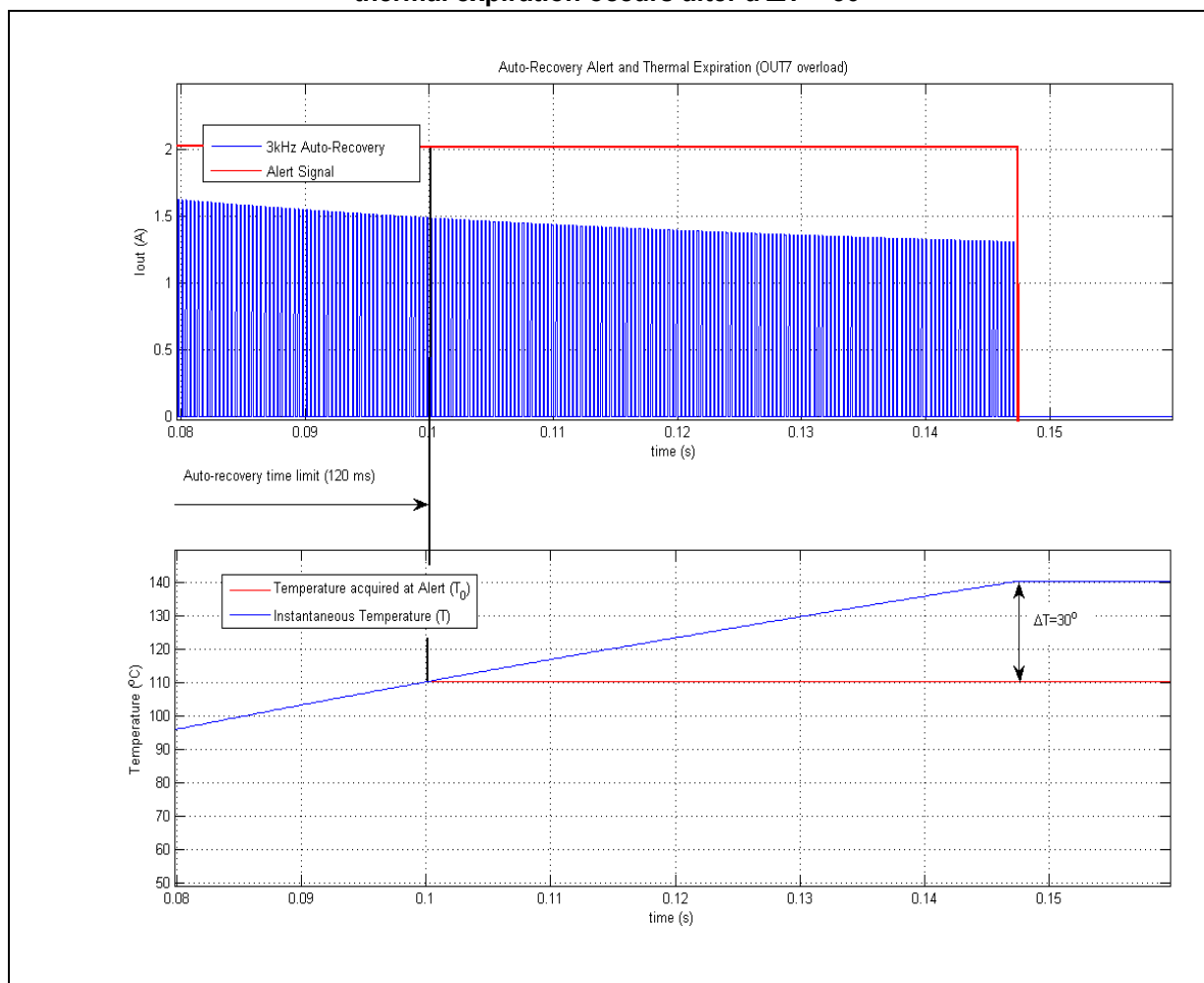
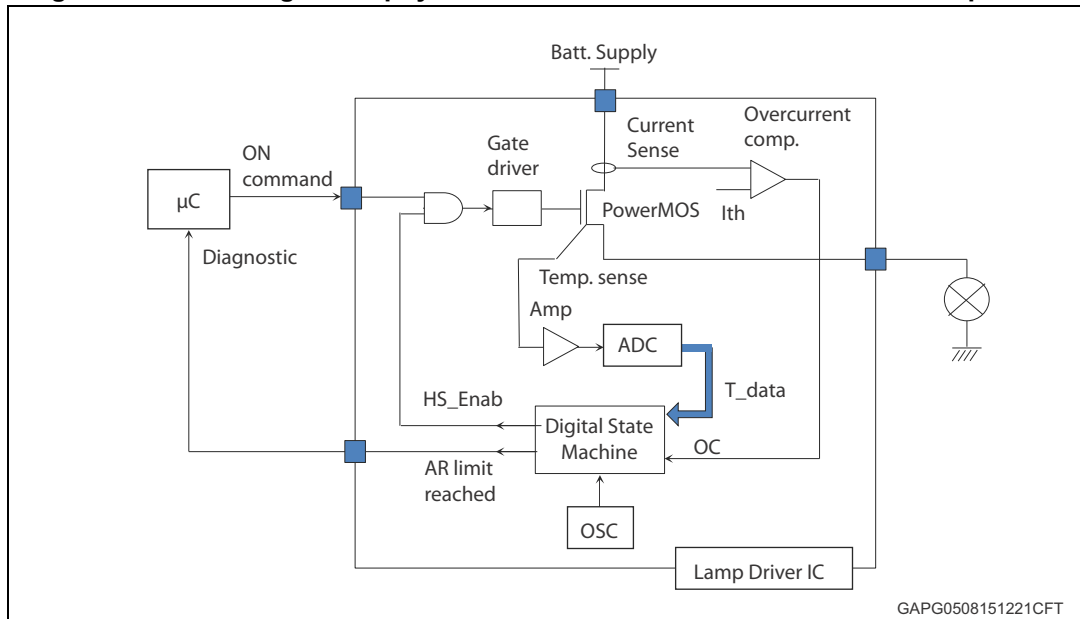


Figure 33. Block diagram of physical realization of AR alert and thermal expiration

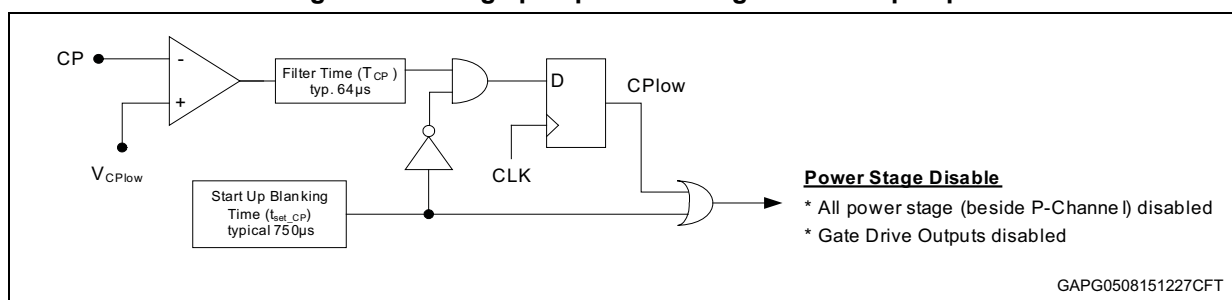


4.15 Charge pump

The charge pump uses two external capacitors, which are switched with f_{CP} . The output of the charge pump has a current limitation. In standby mode and after a thermal shutdown has been triggered the charge pump is disabled. If the charge pump output voltage remains too low for longer than T_{CP} , the power-MOS outputs and the EC-control are switched off. The H-bridge MOSFET gate drivers are switched to resistive low and CP_LOW (SR 2) is set. This bit has to be cleared to reactivate the drivers. If the bit CP_LOW_CONFIG (Configuration Register 0x3F) is set to '1', CP_LOW (SR2) behaves as a 'live' bit and the outputs are re-activated automatically upon recovery of the charge pump output voltage.

In case of reaching the overvoltage shutdown threshold V_{SOV} the charge pump is disabled and automatically restarted after V_S recovered to normal operating voltage.

Figure 34. Charge pump low filtering and start up implementation



4.16 Inductive loads

Each of the half bridges is built by internally connected high-side and low-side power DMOS transistors. Due to the built-in reverse diodes of the output transistors, inductive loads can

be driven at the outputs OUT1 and OUT4-6 without external freewheeling diodes. The high-side drivers OUT7 to OUT15 and OUT_HS are intended to drive resistive loads only. Therefore only a limited energy ($E < 1 \text{ mJ}$) can be dissipated by the internal ESD-diodes in freewheeling condition. For inductive loads ($L > 100 \text{ }\mu\text{H}$) an external freewheeling diode connected between GND and the corresponding output is required.

4.17 Open-load detection

The open-load detection monitors the load current in each activated output stage. If the load current is below the open-load detection threshold for $t > t_{OL_OUT}$ the corresponding open-load bit OUTx_OL (SR 5) is set in the status register.

4.18 Overcurrent detection

An overcurrent condition is detected after a filter time (see [Figure 11](#) and [Figure 12](#)) and is indicated by the status bit OUTx_OC (SR 3). In case of overcurrent, the corresponding driver switches off to reduce the power dissipation and to protect the integrated circuit. If the outputs are not configured in recovery mode, the microcontroller has to clear the relevant status bits to reactivate the corresponding drivers.

4.19 Current monitor

The current monitor sources a current image of the power stage output current at the current monitor pin CM, which has a fixed ratio (I_{CMr}) of the instantaneous current of the selected high-side driver. The signal at output CM is blanked for t_{cmb} after switching on the driver until the correct settlement of the circuitry. The bits CM_SELx (CR 7) define which of the outputs is multiplexed to the current monitor output CM. The current monitor output allows a more precise analysis of the actual state of the load rather than the detection of an open-load or overload condition. For example, it can be used to detect the motor state (starting, free running, stalled). The current monitor output is enabled after the current-monitor blanking time, when the selected output is switched on. If this output is off, the current monitor output is in high impedance mode. The current monitor can be deactivated by CM_EN (CR 7).

4.20 PWM mode of the power outputs

Description see [Section 7.3: Status register overview](#).

4.21 Cross-current protection

The four half-bridges of the device are cross-current protected by an internal delay time. If one driver (LS or HS) is turned off, the activation of the other driver of the same half-bridge will be automatically delayed by the crosscurrent protection time. After the crosscurrent protection time is expired the slew-rate limited switch-off phase of the driver is changed to a fast turn-off phase and the opposite driver is turned-on with slew-rate limitation. Due to this behavior, it is always guaranteed that the previously activated driver is completely turned off before the opposite driver starts to conduct.

4.22 Programmable soft-start function to drive loads with higher inrush current

Loads with start-up currents higher than the overcurrent limits (e.g. inrush current of lamps, start current of motors) can be driven by using the programmable soft-start function (i.e. overcurrent recovery mode). Each driver has a corresponding overcurrent recovery bit `OUTx_OCR` (CR 7). If this bit is set, the device automatically switches the outputs on again after a programmable recovery time. The PWM modulated current will provide sufficient average current to power up the load (e.g. heat up the bulb) until the load reaches operating condition.

The PWM frequency is defined by setting `OCR_FREQ` (CR7).

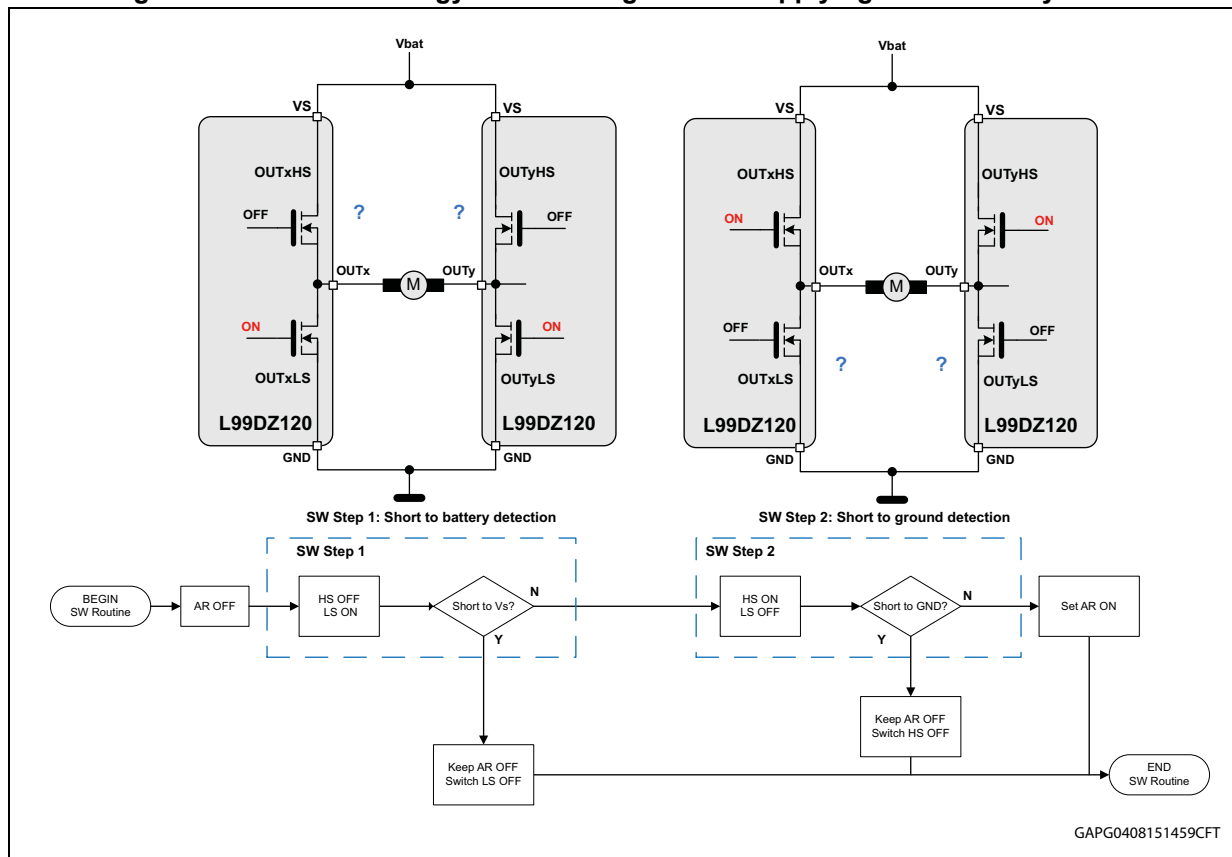
The device itself cannot distinguish between a real overload (e.g. short-circuit condition) and a load characterized by operation currents exceeding the short-circuit threshold.

Examples are non-linear loads like a light bulb used on the HS outputs or a motor used on the half bridge output with inrush and stall currents that shall be limited by the auto recovery feature.

For the bulb, a real overload condition can only be qualified by time. For overload detection the microcontroller can switch on the light bulbs by setting the overcurrent recovery bit for the first e.g. 50 ms. After clearing the recovery bit, the output will be switched off automatically if the overload condition remains.

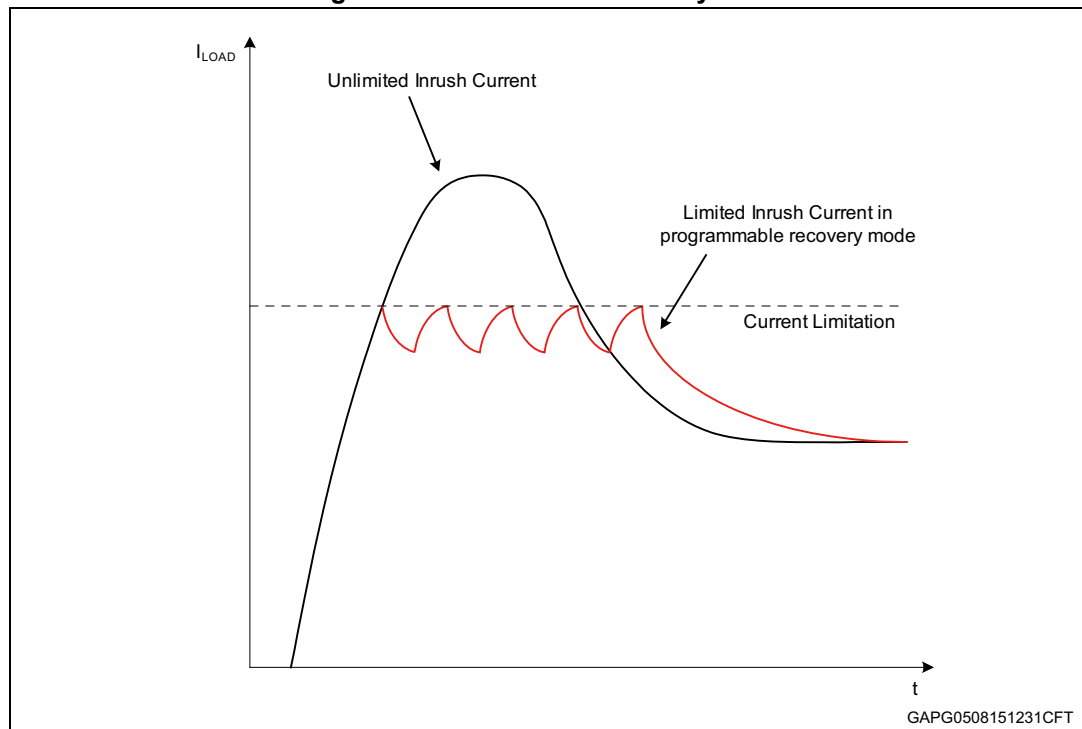
For the half bridges the high current can be present during all motor activation and another SW strategy must be applied to identify a SC to GND or Supply. Before running the motor e.g. with a first SPI command all bridges LS are switched on (without auto recovery functionality / cleared overcurrent recovery bit), all HS are switched off and a SC to Battery can be diagnosed. With a next SPI command, all HS are switched on (without auto recovery functionality/ cleared overcurrent recovery bit) and all LS are switched off. In this sequence, a short to GND can be diagnosed. If in both sequences no overload condition is identified, the motor can be run by switching on the relevant HS and LS each configured in auto recovery mode (see [Figure 35](#)). Such sequence can be applied before any motor activation to identify SC just before operating the motor (in case the delay due to the 2 additional SPI commands is not limiting the application) or in case of power up of the system resp. applied on a certain time base.

Figure 35. Software strategy for half bridges before applying auto-recovery mode



As soon as an output reaches auto-recovery condition, OUTx_OCR_ALERT (SR 4)) is set. The Alert bit indicates that an overload condition (load in-rush, short-circuit, etc) is present.

Figure 36. Overcurrent recovery mode



4.23 H-bridge control

The PWMH and DIRH inputs control the drivers of the external H-bridge transistors. In single Motor mode the motor direction can be chosen with the direction input (DIRH), the duty cycle^(a) and frequency with the PWMH input (single mode). With the SPI bits SD (CR 10) and SDS (CR 10) four different slow-decay modes (via drivers and via diode) can be selected using the high-side or the low-side transistors. Unconnected inputs are defined by internal pull-down current.

a. If tcpc is programmed to 4 μ s and frequency to 50 kHz, max duty cycle achievable is 92%.

Table 49. H-bridge control truth table

	Control pins		Control bits			Failure bits					Output pins				Motor config	Comment
Nb	DIRH	PWMH	HEN	SD	SDS	CP_LOW	VS_OV	VS_UV	DS	TSD1	GH1	GL1	GH2	GL2		
1	x	x	0	x	x	x	x	x	x	x	RL	RL	RL	RL		H-bridge disabled
2	x	x	1	x	x	1	0	0	0	0	RL	RL	RL	RL	Single	Charge pump voltage too low
3	x	x	1	x	x	0	x	x	x	1	RL	RL	RL	RL		Thermal shutdown
4	x	x	1	x	x	0	1	0	0	0	L	L	L	L		Overvoltage
5	x	x	1	x	x	0	0	0	1	0	L ⁽¹⁾	L ⁽¹⁾	L ⁽¹⁾	L ⁽¹⁾		Short-circuit ⁽¹⁾
6	0	1	1	x	x	0	0	0	0	0	L	H	H	L		Bridge H2/L1 on
7	x	0	1	0	0	0	0	0	0	0	L	H	L	H		Slow-decay mode LS1 and LS2 on
8	0	0	1	0	1	0	0	0	0	0	L	H	L	L		Slow-decay mode LS1 on
9	1	0	1	0	1	0	0	0	0	0	L	L	L	H		Slow-decay mode LS2 on
10	1	1	1	x	x	0	0	0	0	0	H	L	L	H		Bridge H1/L2 on
11	x	0	1	1	0	0	0	0	0	0	H	L	H	L		Slow-decay mode HS1 and HS2 on
12	0	0	1	1	1	0	0	0	0	0	L	L	H	L		Slow-decay mode HS1 on
13	1	0	1	1	1	0	0	0	0	0	H	L	L	L		Slow-decay mode HS2 on

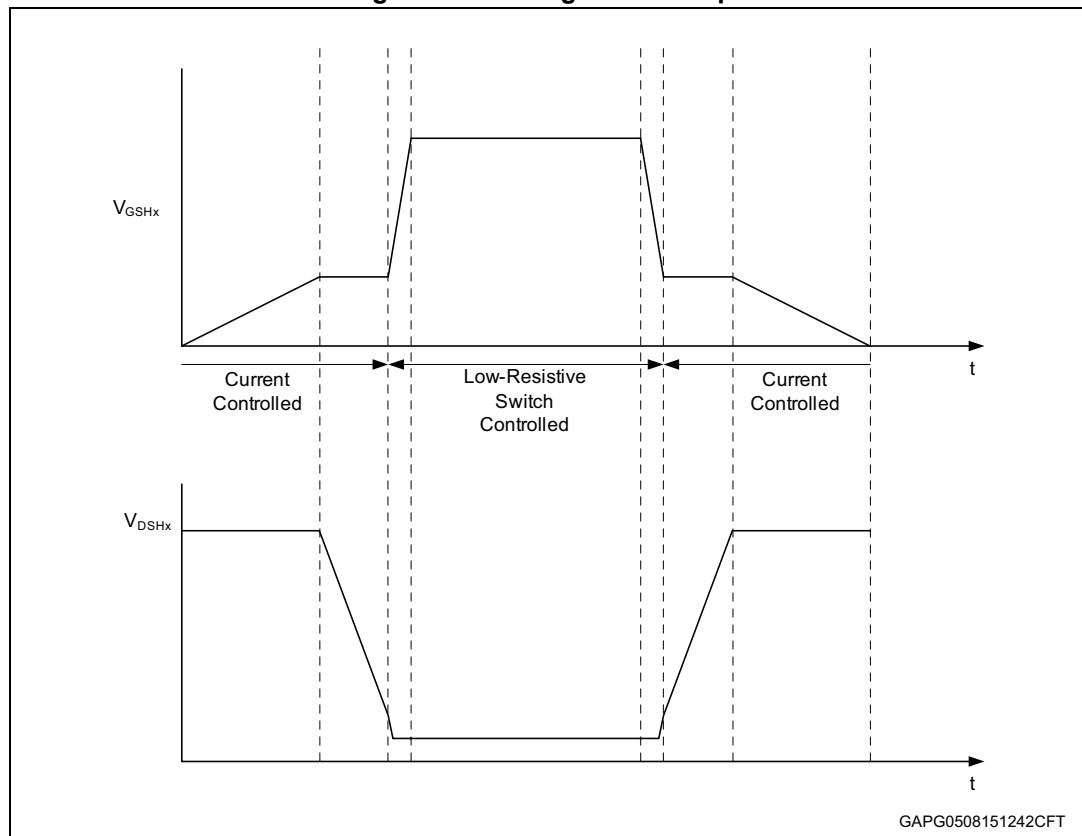
1. Only the H-bridge leg (low-side and high-side), in which one MOSFET is in short-circuit condition is switched off. Both MOSFETs of the other H-bridge leg remain active and driven by DIRH and PWMH.

During watchdog long-open window, the H-bridge drivers are forced off until the first valid watchdog trigger in window mode (setting TRIG = 0 during safe window). The Control Registers remain accessible during long open window.

4.24 H-bridge driver slew-rate control

The rising and falling slope of the drivers for the external high-side Power-MOS can be slew rate controlled. If this mode is enabled the gate of the external high-side Power-MOS is driven by a current source instead of a low-impedance output driver switch as long as the drain-source voltage over this Power-MOS is below the switch threshold. The current is programmed using the bits SLEW_x<4:0> (CR 10), which represent a binary number. This number is multiplied by the minimum current step. This minimum current step is the maximum source-/sink-current ($I_{GHx\max}$ / $I_{GHx\max}$) divided by 31. Programming SLEW_x <4:0> to 0 disables the slew rate control and the output is driven by the low-impedance output driver switch.

Figure 37. H-bridge GSHx slope



4.25 Resistive low

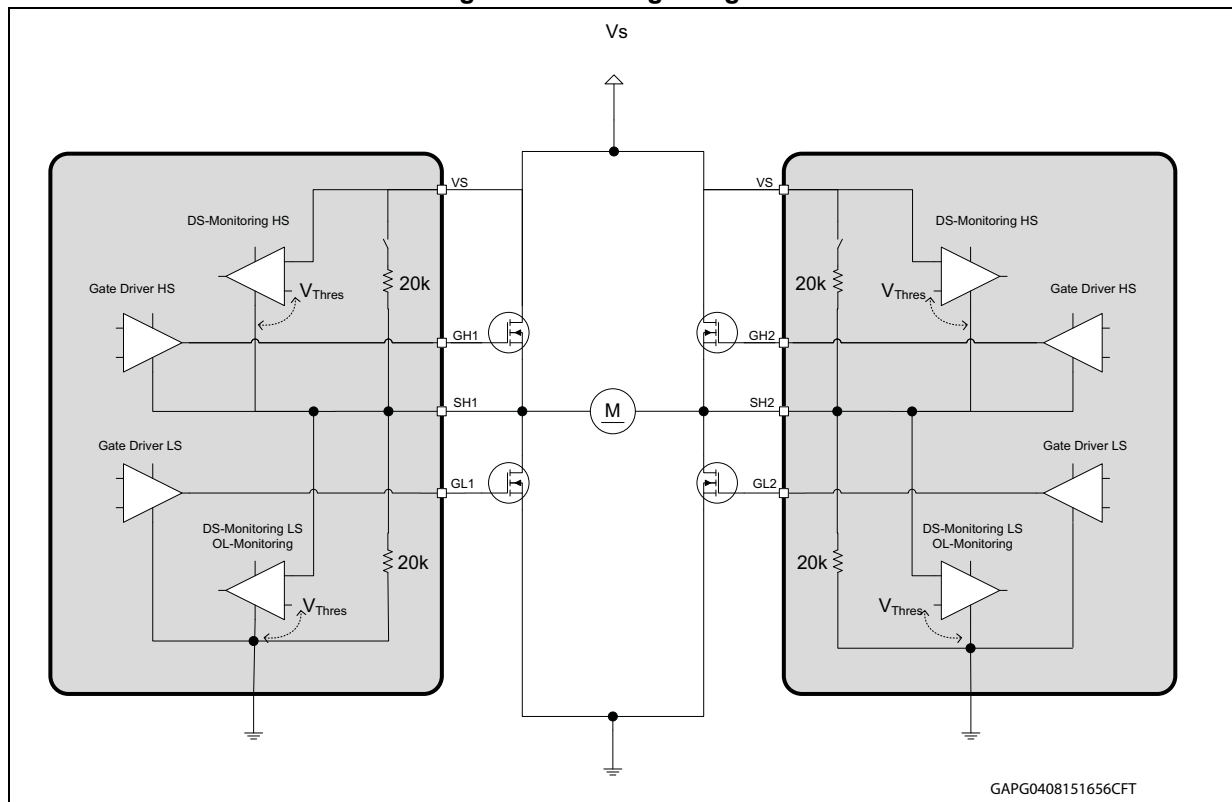
The resistive output mode protects the devices and the H-bridge in the standby mode and in some failure modes (thermal shutdown TSD1 (SR 1), charge pump low CP_LOW (SR 2) and DI pin stuck at '1' SPI_INV_CMD (SR 2)). When a gate driver changes into the resistive output mode due to a failure a sequence is started. In this sequence the concerning driver is switched into sink condition for 32 μ s to 64 μ s to ensure a fast switch-off of the H-bridge transistor. If slew rate control is enabled, the sink condition is slew-rate controlled. Afterwards the driver is switched into the resistive output mode (resistive path to source).

4.26 Short circuit detection / drain source monitoring

The Drain - Source voltage of each activated external MOSFET of the H-bridge is monitored by comparators to detect shorts to ground or battery. If the voltage-drop over the external MOSFET exceeds the configurable threshold voltage V_{SCd_HB} (DIAG_x (CR 10) for longer $t > t_{SCd_HB}$ the corresponding gate driver switches off the external MOSFET and the corresponding drain source monitoring flag DS_MON_x (SR 2) is set. The DSMON_x bits have to be cleared through the SPI to reactivate the gate drivers. This monitoring is only active while the corresponding gate driver is activated. If a drain-source monitor event is detected, the corresponding gate-driver remains activated for at maximum the filter time. When the gate driver switches on, the drain-source comparator requires the specified settling time until the drain-source monitoring is valid. During this time, this drain-source

monitor event may start the filter time. The threshold voltage V_{SCd_HB} can be programmed using the SPI bits DIAG_x (CR 10).

Figure 38. H-bridge diagnosis



4.27 H-bridge monitoring in off-mode

The drain source voltages of the H-bridge driver external transistors can be monitored, while the transistors are switched off. If either bit OL_H1L2 (CR 10) or OL_H2L1 (CR 10) is set to 1, while bit HEN (CR 1) = 1, the H-drivers enter resistive low mode and the drain-source voltages can be monitored. Since the pull-up resistance is equal to the pull-down resistance on both sides of the bridge a voltage of $2/3 V_S$ on the pull-up highside and $1/3 V_S$ on the low-side is expected, if they drive a low-resistive inductive load (e.g. motor). If the drain source voltage on each of these Power-MOS is less than $1/6 V_S$, the drain-source monitor bit of the associated driver is set.

The open-load filter time is t_{OL_HB} .

Figure 39. H-bridge open-load-detection (no open-load detected)

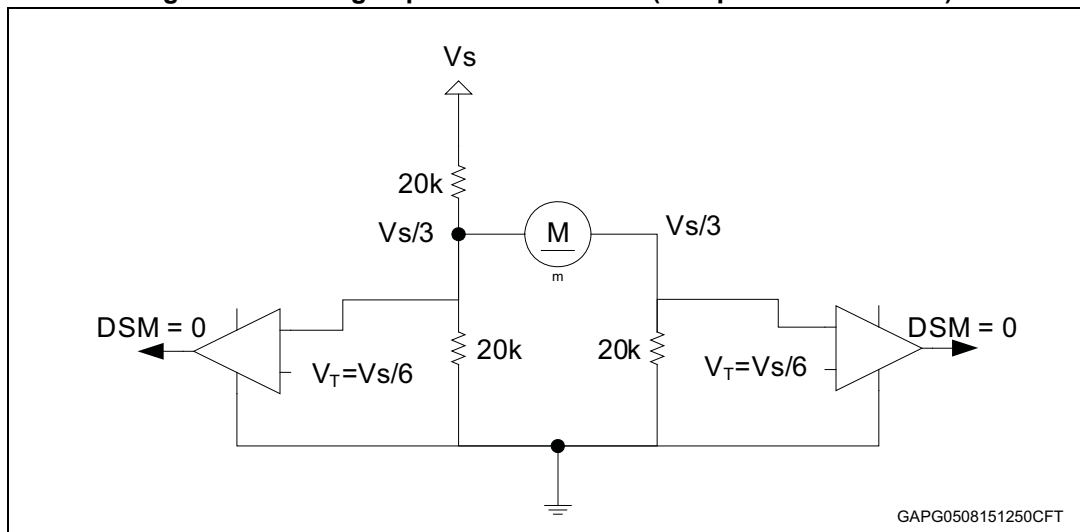


Figure 40. H-bridge open-load-detection (open-load detected)

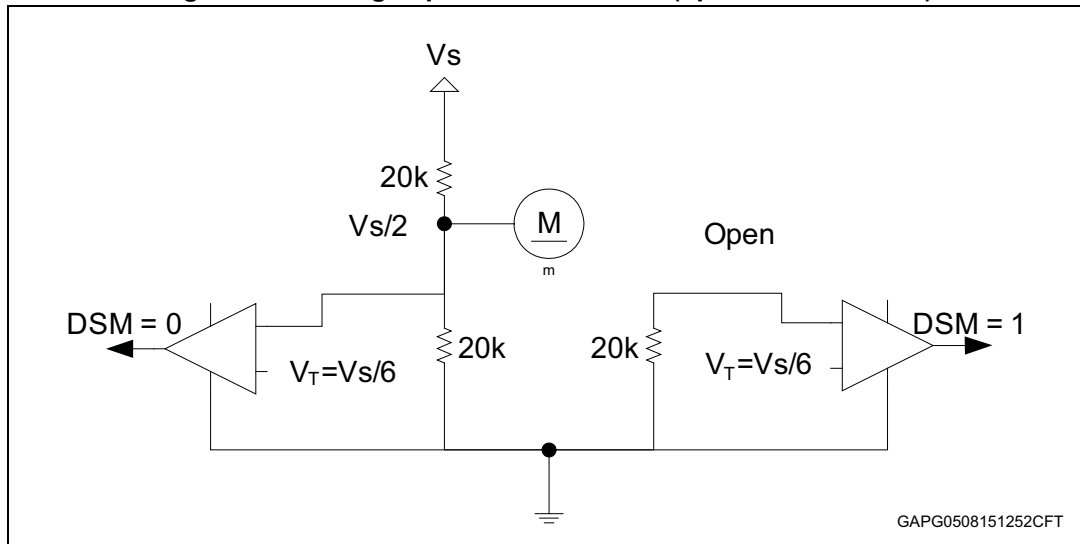


Figure 41. H-bridge open-load-detection (short to ground detected)

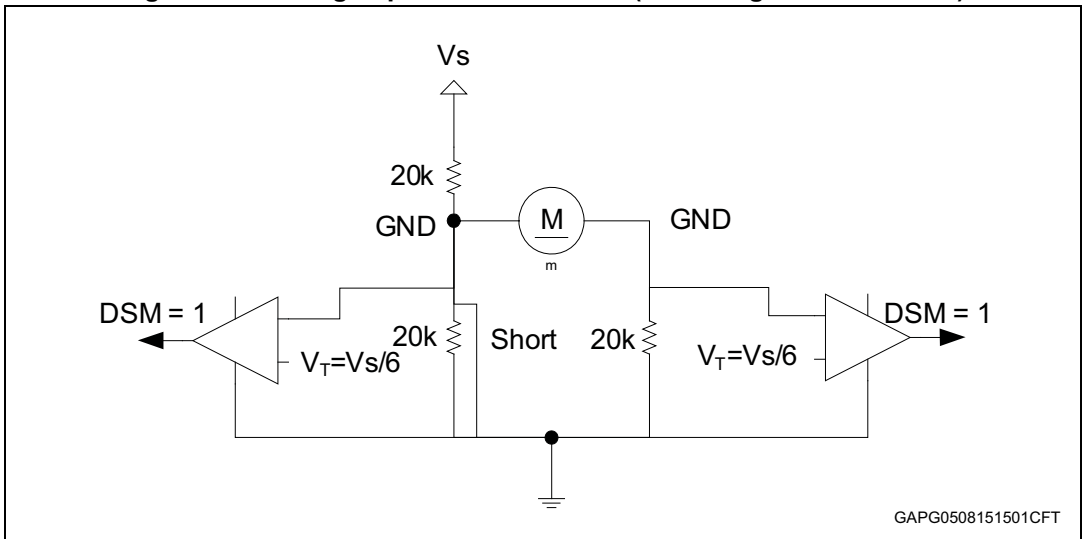


Figure 42. H-bridge open-load detection (short to V_S detected)

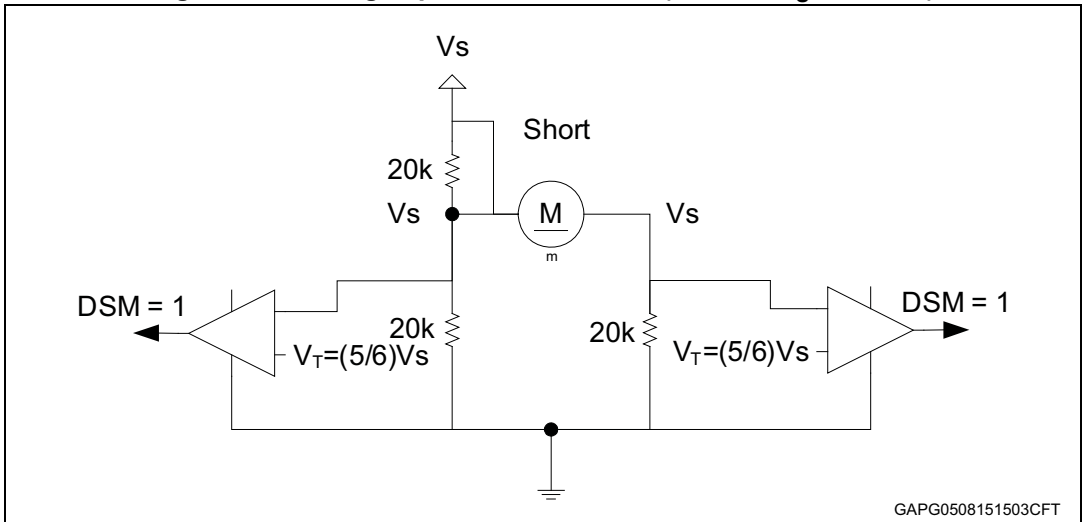


Table 50. H-bridge monitoring in off-mode

Nb	Control bits			Failure bits		Comments
	OL H1L2	OL H2L1	H OLTH High	DSMON LS1	DSMON LS2	
1	0	0	0	0	0	Drain-Source monitor disabled
2	1	0	x	0	0	No open-load detected
3	1	0	0	0	1	Open-load SH2
4	1	0	0	1	1	Short to GND
5	1	0	1	1	1	Short to VS
6	0	1	x	0	0	No open-load detected
7	0	1	0	1	0	Open-load SH1

Table 50. H-bridge monitoring in off-mode (continued)

Nb	Control bits			Failure bits		Comments
	OL H1L2	OL H2L1	H OLTH High	DSMON LS1	DSMON LS2	
8	0	1	0	1	1	Short to GND
9	0	1	1	1	1	Short to VS

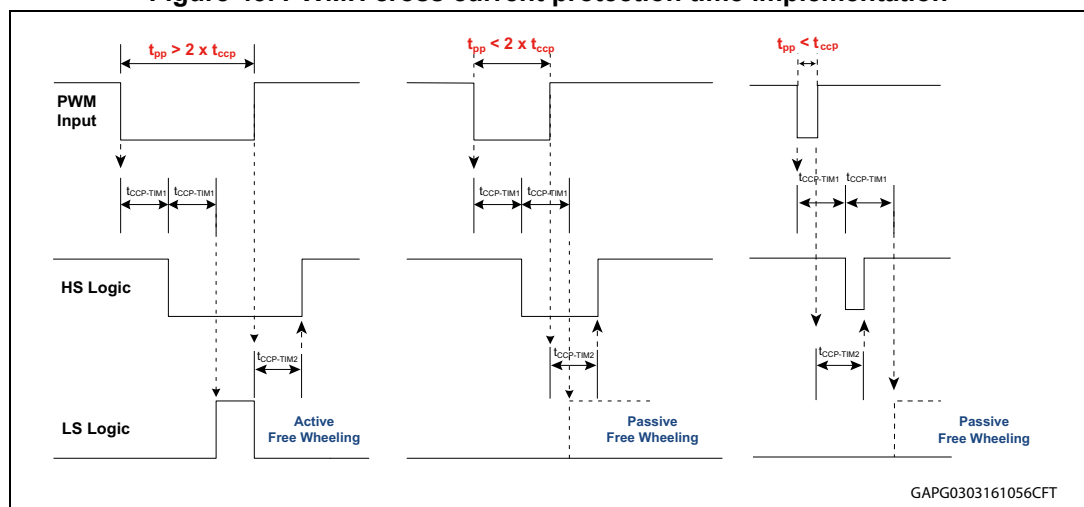
4.28 Programmable cross current protection

The external PowerMOSFETs transistors in H-bridge (two half-bridges) configuration are switched on with an additional delay time t_{CCP} to prevent cross current in the halfbridge. The cross current protection time t_{CCP} can be programmed with the SPI bits COPT_x<3:0> (CR 10). The timer is started when the gate driver is switched on in the device.

The PWMH module has 2 timers to configure locking time for high-side and freewheeling low-side. The programmable time $t_{CCP-TIM1}$ / $t_{CCP-TIM2}$ is the same. Sequence for switching in PWM mode is the following:

- HS switch off after locking $t_{CCP-TIM1}$
- LS switch on after 2nd locking $t_{CCP-TIM1}$
- HS switch on after locking $t_{CCP-TIM2}$ which starts with rising edge on PWM input

Figure 43. PWMH cross current protection time implementation



4.29 Power window H-bridge safety switch off block

The two LS Switches LS1_FSO and LS2_FSO are intended to be used to switch off the gates of the external high-side MOSFETs in the power window h-bridge if a fatal error happens. This block must work also in case the MOSFET driver and the according control blocks on the chip are destroyed. Therefore it is necessary to have a complete separated safety block on the device, which has its own supply and GND connection, separated from the other supplies and GNDs. In the block is implemented an own voltage regulator and oscillator.

The safety block is surrounded by a GND isolation ring realized by deep trench isolation. The LS driver must work down to a lower voltage than the other circuits. The block has its own internal supply and an own oscillator for monitoring the failure signals (WWD, V1 fail, SPI fail & Tj) which are Manchester encoded and decoupled by high ohmic resistances. In case of fail-safe event, both LS switches LS1_FSO and LS2_FSO are switched on.

In case of entering V1_standby mode or Vbat_standby mode both fail safe low-side switches are switched on to minimize the current drawn by the fail safe block (e.g. oscillator is switched off and Manchester Encoding is deactivated). Short circuit protection to V_S is active in both standby modes limiting the current to I_{OLimit} for a filter of t_{SCF} .

After this filter time the fail-safe switches are switched off and LSxFSO_OC (SR 3) is set. To reactivate the low-side functionality this bit has to be set back by a read and clear command. In case of V_S loss the fail safe switches are biased by their own output voltage to turn on the low-side switches down to V_{OUT_max} .

To allow verification of the Fail-Safe path, the low-side switches LS1_FSO and LS2_FSO can be turned on by SPI (Configuration Register 0x3F bit 4: FS_FORCED)

Figure 44. LSx_FSO: low-side driver “passively” turned on, taking supply from output pin (if main supply fails), can guarantee $V_{LSx_FSO} < V_{OUT_max}$

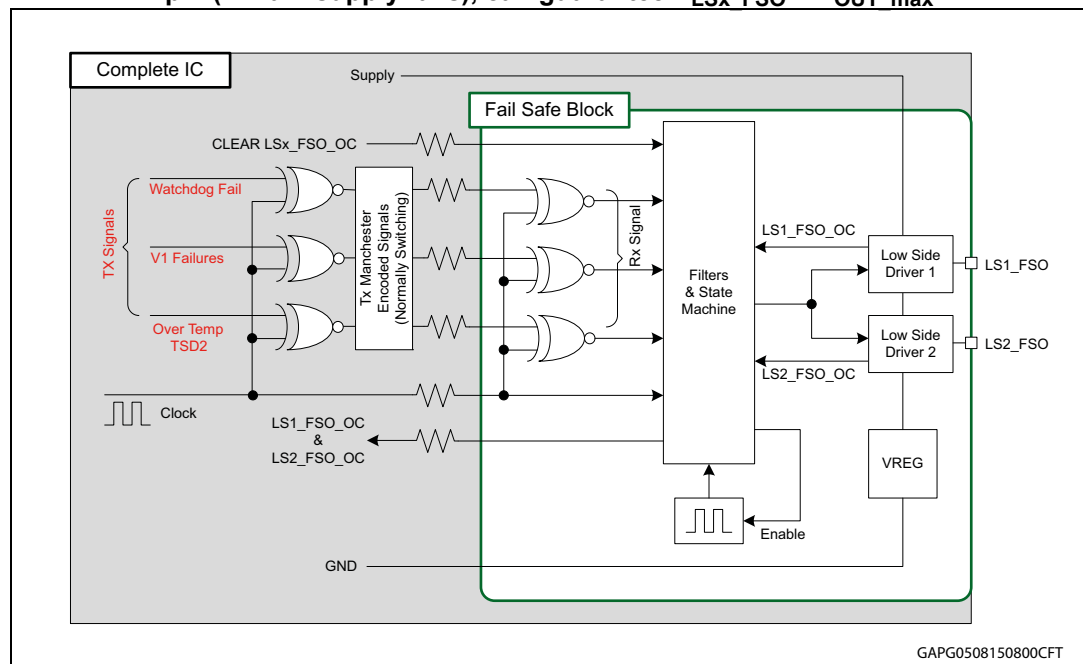
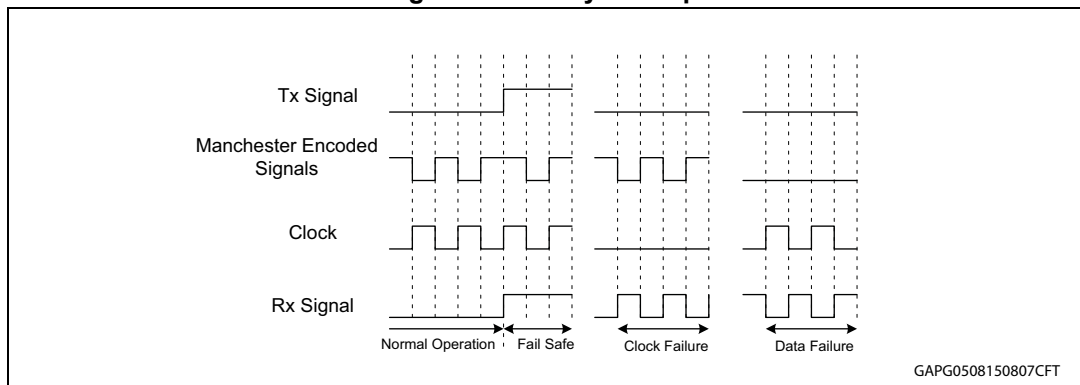


Figure 45. Safety concept



4.30 Temperature warning and shutdown

If any of the cluster (see [Section 4.31: Thermal clusters](#)) junction temperatures rises above the temperature warning threshold TW, the temperature warning flag TW (SR 2) is set after the temperature warning filter time t_{jft} and can be read via SPI. If the junction temperature increases above the temperature shutdown threshold (TSD1), the thermal shutdown bit TSD1 (SR 1) is set and the power transistors of all output stages are switched off to protect the device after the thermal shutdown filter time. The gates of the H-bridge is discharged by the 'Resistive Low' mode. After these bits have been cleared, the output stages are reactivated. If the temperature is still above the thermal warning threshold, the thermal warning bit is set after t_{jft} . Once this bit is set and the temperature is above the temperature shutdown threshold, temperature shutdown is detected after t_{jft} and the outputs are switched off. Therefore the minimum time after which the outputs are switched off after the bits have been cleared in case the temperature is still above the thermal shutdown threshold is twice the thermal warning/ thermal shutdown filter time t_{jft} .

4.31 Thermal clusters

In order to provide an advanced on-chip temperature control, the power outputs are grouped in six clusters with dedicated thermal sensors. The sensors are suitably located on the device (see [Figure 46: Thermal clusters identification](#)). In case the temperature of an output cluster reaches the thermal shutdown threshold, the outputs assigned to this cluster are shut down (all other outputs remain active). Each output cluster has a dedicated temperature warning and shutdown flag (SR 6) and the cluster temperature can be read out by SPI.

Hence, the thermal cluster concept allows to identify a group of outputs in which one or more channels are in overload condition.

If thermal shutdown has occurred within an output cluster, or if temperature is rising within a cluster, it may be desired to identify which of the output (s) is (are) determining the temperature increase. An additional evaluation, based on current monitoring and cluster temperature read-out, supports identification of the outputs mainly contributing to the temperature increase. The cluster temperatures are available in SR 7, SR 8 and SR 9 and can be calculated from the binary coded register value using the following formula:

$$\text{Decimal code} = (350 - \text{Temp}) / 0.488$$

Table 51. Thermal cluster definition

Th_CL1	Th_CL2	Th_CL3	Th_CL4	Th_CL5	Th_CL6
5 W Driver + OUT15	Door lock + OUT_HS	OUT1 + OUT6	10W driver high ohmic channels	VREG 1 VREG 2	Global
TW & TSD1 Both digitally managed	TW & TSD1 Both digitally managed	TW & TSD1 Both digitally managed	TW & TSD1 Both digitally managed	TW digitally managed TSD1 & TSD2 Both analog managed	TW digitally managed TSD1 Analog managed

4.32 V_S compensation (duty cycle adjustment) module

All stand-alone HS outputs can be programmed to calculate some internal duty cycle adjustment to adapt the duty cycle to a changing supply voltage at V_S . This feature is aimed to avoid LED brightness flickering in case of alternating supply voltage. The correction of the duty cycle is based on the following formula:

Equation 1: Duty cycle correction

$$\text{DutyCycle} = \frac{V_{th} - V_{LED}}{V_{Bat} - V_{LED}} \times DC_{nom}$$

V_{th} = Duty cycle reference voltage: defined as 10 V

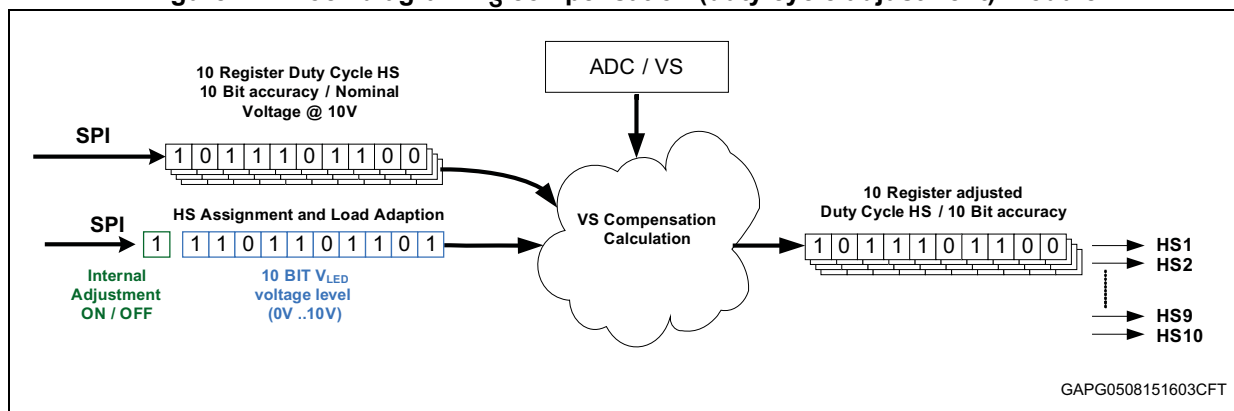
V_{Bat} = Reference voltage: defined as voltage at pin VS

V_{LED} = Voltage drop on the external LED

DC_{nom} = Nominal Duty Cycle programmed by SPI < PWMx DCx >

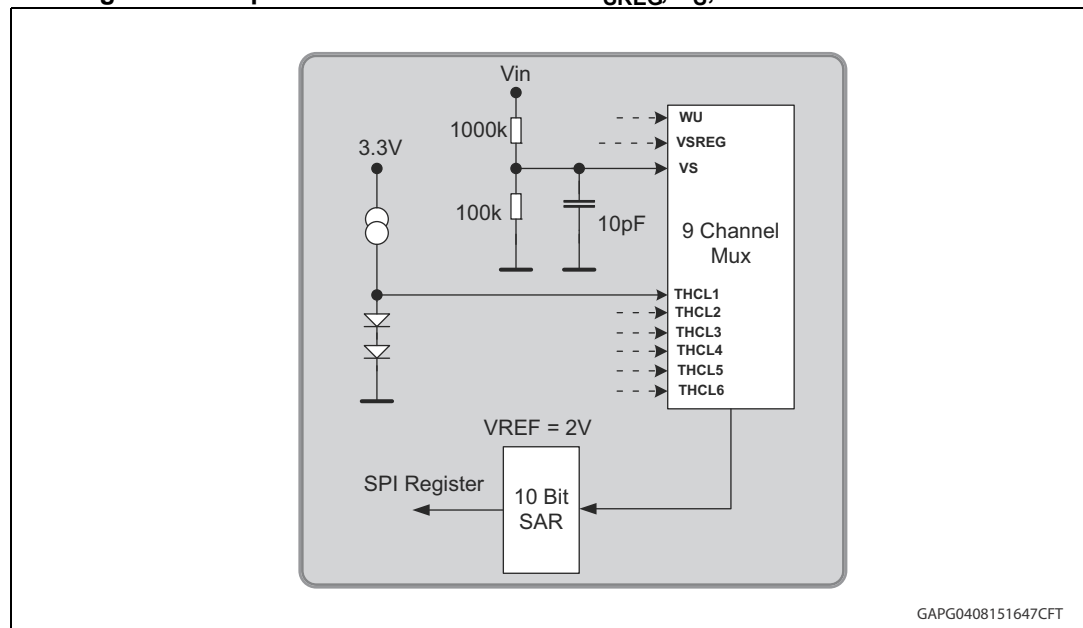
To be compatible to different LED load characteristics the value for V_{LED} can be programmed for each output by a dedicated control register OUT7_VLED ... OUT_HS_VLED (CR 18 to CR 22). Auto compensation features can be activated for all HS outputs each by setting OUTx_AUTOCOMP_EN (CR 18 to CR 22).

The programmed LED voltage (OUTx_V_LED (CR18 to CR22)) must be lower than V_{th} (10 V).

Figure 47. Block diagram V_S compensation (duty cycle adjustment) module

Voltage signals V_S , V_{SREG} , V_{WU} and $TH_CL1..6$ are read out sequentially. The voltage signals are multiplexed to an ADC. The ADC is realized as a 10 Bit SAR, that is sampled with the main clock f_{clk2} / f_{ADC} .

Figure 48. Sequential ADC Read Out for V_{SREG}, V_S, WU and THCL1 ..THCL6



5 Serial Peripheral Interface (SPI)

A 32-bit SPI is used for bi-directional communication with the microcontroller.

The SPI is driven by a microcontroller with its SPI peripheral running in the following mode: CPOL = 0 and CPHA = 0.

For this mode input data is sampled by the low to high transition of the clock CLK, and output data is changed from the high to low transition of CLK. This device is not limited to microcontroller with a built-in SPI. Only three CMOS-compatible output Pins and one input Pin will be needed to communicate with the device. A fault condition can be detected by setting CSN to low. If CSN = 0, the DO-Pin will reflect the global error flag (fault condition) of the device.

- Chip Select Not (CSN)

The input Pin is used to select the serial interface of this device. When CSN is high, the output Pin (DO) is in high impedance state. A low signal activates the output driver and a serial communication can be started. The state during CSN = 0 is called a communication frame. If CSN = low for $t > t_{\text{CSNfail}}$ the DO output will be switched to high impedance in order to not block the signal line for other SPI nodes.

- Serial Data In (DI)

The input Pin is used to transfer data serial into the device. The data applied to the DI will be sampled at the rising edge of the CLK signal and shifted into an internal 32-bit shift register. At the rising edge of the CSN signal the content of the shift register will be transferred to Data Input Register. The writing to the selected Data Input Register is only enabled if exactly 32-bit are transmitted within one communication frame (i.e. CSN low). If more or less clock pulses are counted within one frame the complete frame will be ignored. This safety function is implemented to avoid an activation of the output stages by a wrong communication frame.

Note: Due to this safety functionality a daisy chaining of SPI is not possible. Instead, a parallel operation of the SPI bus by controlling the CSN signal of the connected IC's is recommended.

- Serial Data Out (DO)

The data output driver is activated by a logical low level at the CSN input and will go from high impedance to a low or high level depending on the global error flag (fault condition). The first rising edge of the CLK input after a high to low transition of the CSN Pin will transfer the content of the selected status register into the data out shift register. Each subsequent falling edge of the CLK will shift the next bit out.

- Serial Clock (CLK)

The CLK input is used to synchronize the input and output serial bit streams. The data input (DI) is sampled at the rising edge of the CLK and the data output (DO) will change with the falling edge of the CLK signal. The SPI can be driven with a CLK Frequency up to 4 MHz.

5.1 ST SPI 4.0

The ST-SPI is a standard used in ST Automotive ASSP devices.

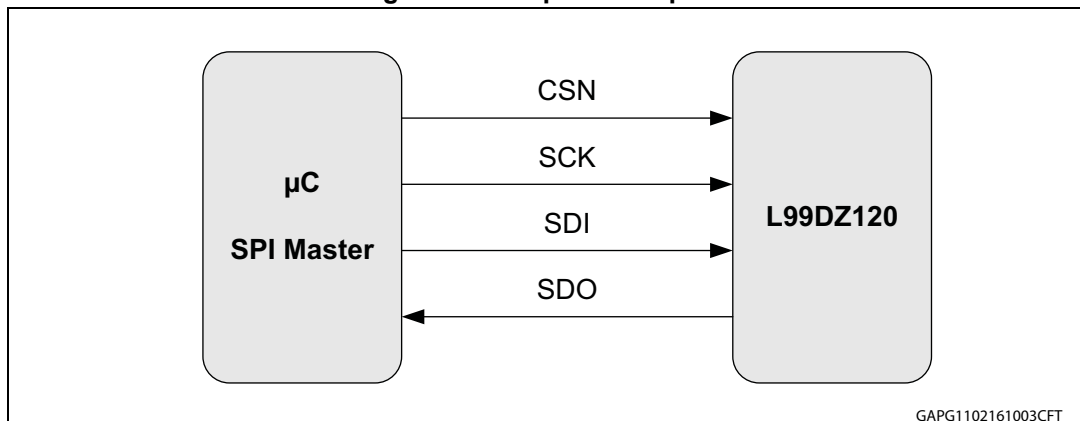
This chapter describes the SPI protocol standardization. It defines a common structure of the communication frames and defines specific addresses for product and status information.

The ST-SPI allows usage of generic software to operate the devices while maintaining the required flexibility to adapt it to the individual functionality of a particular product. In addition, failsafe mechanisms are implemented to protect the communication from external influences and wrong or unwanted usage.

The devices Serial Peripheral Interface are compliant to the ST SPI Standard Rev. 4.0.

5.1.1 Physical layer

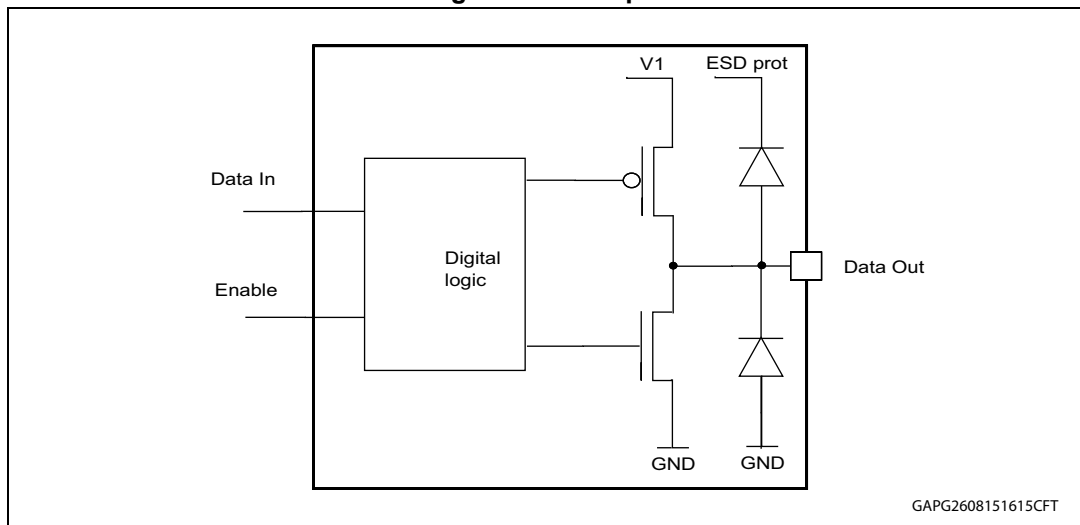
Figure 49. SPI pin description



5.2 Signal description

- **Chip Select Not (CSN)**
The communication interface is de-selected, when this input signal is logically high. A falling edge on CSN enables and starts the communication while a rising edge finishes the communication and the sent command is executed when a valid frame was sent. During communication start and stop the Serial Clock (SCK) has to be logically low. The Serial Data Out (SDO) is in high impedance when CSN is high or a communication timeout was detected.
- **Serial Clock (SCK)**
This SCK provides the clock of the SPI. Data present at Serial Data Input (SDI) is latched on the rising edge of Serial Clock (SCK) into the internal shift registers while on the falling edge data from the internal shift registers are shifted out to Serial Data Out (SDO).
- **Serial Data Input (SDI)**
This input is used to transfer data serially into the device. Data is latched on the rising edge of Serial Clock (SCK).
- **Serial Data Output (SDO)**
This output signal is used to transfer data serially out of the device. Data is shifted out on the falling edge of Serial Clock (SCK).

Figure 50. SDO pin



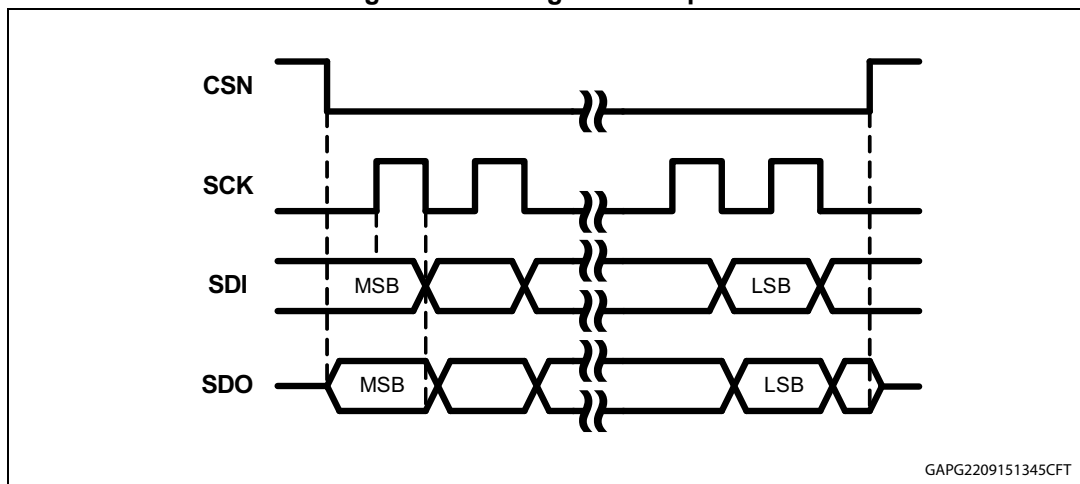
5.2.1 Clock and Data Characteristics

The ST-SPI can be driven by a microcontroller with its SPI peripheral running in the following mode:

CPOL = 0

CPHA = 0

Figure 51. SPI signal description



The communication frame starts with the falling edge of the CSN (Communication Start). SCK has to be low.

The SDI data is then latched at all following rising SCK edges into the internal shift registers. After Communication Start the SDO will leave 3-state mode and present the MSB of the data shifted out to SDO. At all following falling SCK edges data is shifted out through the internal shift registers to SDO.

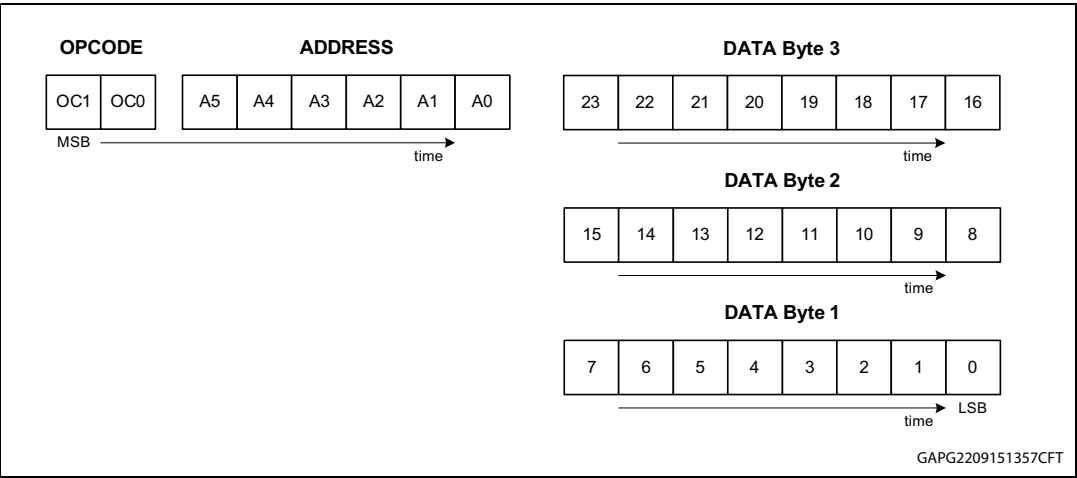
The communication frame is finished with the rising edge of CSN. If a valid communication took place (e.g. correct number of SCK cycles, access to a valid address), the requested operation according to the Operating Code will be performed (Write or Clear operation).

5.2.2 Communication protocol

SDI Frame

The devices Data-In Frame consist of 32-bit (OpCode (2 bits) + Address (6 bits) + Data Byte 3 + Data Byte 2 + Data Byte 1). The first two transmitted bits (MSB, MSB-1) contain the Operation Code which represents the instruction which will be performed. The following 6 bits (MSB-2 to MSB-7) represent the address on which the operation will be performed. The subsequent bytes contain the payload.

Figure 52. SDI Frame



Operating code

The operating code is used to distinguish between different access modes to the registers of the slave device.

Table 52. Operation codes

OC1	OC0	Description
0	0	Write Operation
0	1	Read Operation
1	0	Read & Clear Operation
1	1	Read Device Information

A Write Operation will lead to a modification of the addressed data by the payload if a write access is allowed (e.g. Control Register, valid data). Beside this a shift out of the content (data present at Communication Start) of the registers is performed.

A Read Operation shifts out the data present in the addressed register at Communication Start. The payload data will be ignored and internal data will not be modified. In addition a Burst Read can be performed.

A Read & Clear Operation will lead to a clear of addressed status bits. The bits to be cleared are defined first by address, second by payload bits set to '1'. Beside this a shift out of the content (data present at Communication Start) of the registers is performed.

Note: Status registers which change status during communication could be cleared by the actual Read & Clear Operation and are neither reported in actual communication nor in the following communications. To avoid a loss of any reported status it is recommended just clear status registers which are already reported in the previous communication (Selective Bitwise Clear).

Advanced operation codes

To provide the separate write of all control registers and the bitwise clear of all status registers, two Advanced Operation Codes can be used to set all control registers to the default value and to clear all status registers. A 'set all control registers to default' command is performed when an OpCode '11' at address b'111111 is performed.

Note: Please consider that potential device specific write protected registers cannot be cleared with this command in therefore a device Power-on-Reset is needed.

A 'clear all status registers' command is performed when an OpCode '10' at address b'111111 is performed.

Data-in payload

The Payload (Data Byte 1 to Data Byte 3) is the data transferred to the devices with every SPI communication. The Payload always follows the OpCode and the Address bits. For Write access the Payload represents the new data written to the addressed register. For Read & Clear operations the Payload defines which bits of the addressed Status Register will be cleared. In case of a '1' at the corresponding bit position the bit will be cleared.

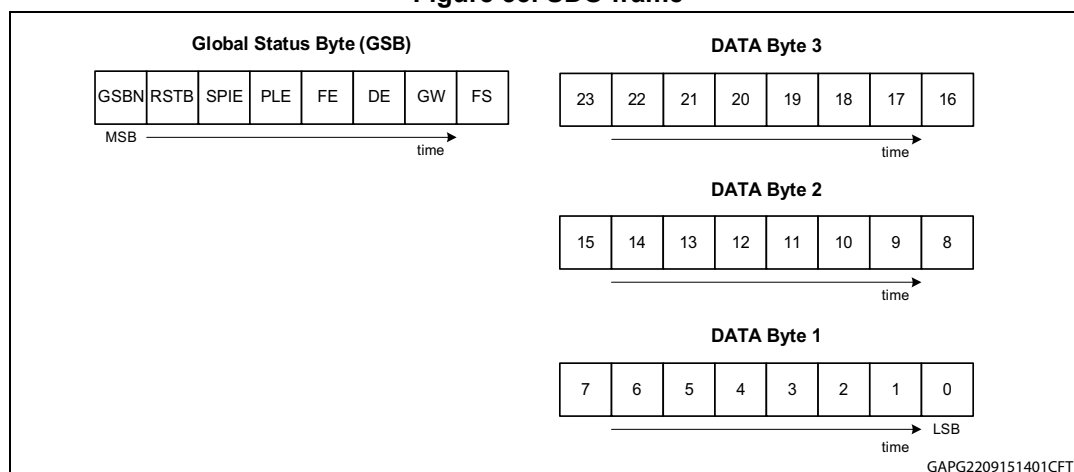
For a Read Operation the Payload is not used. For functional safety reasons it is recommended to set unused Payload to '0'.

SDO frame

The data-out frame consists of 32-bit (GSB + Data Byte 1 to 3).

The first eight transmitted bits contain device related status information and are latched into the shift register at the time of the Communication Start. These 8-bit are transmitted at every SPI transaction. The subsequent bytes contain the payload data and are latched into the shift register with the eighth positive SCK edge. This could lead to an inconsistency in data between the GSB and Payload due to different shift register load times. Anyhow, no unwanted Status Register clear should appear, as status information should just be cleared with a dedicated bit clear after.

Figure 53. SDO frame



Global Status Byte (GSB)

The bits (Bit0 to Bit4) represent a logical OR combination of bits located in the Status Registers. Therefore no direct Read & Clear can be performed on these bits inside the GSB.

Table 53. Global Status Byte

Bit 31	Bit 30	Bit 29	Bit 28	Bit 27	Bit 26	Bit 25	Bit 24
GSBN	RSTB	SPIE	PLE	FE	DE	GW	FS

Global Status Bit Not (GSBN)

The GSBN is a logical NOR combination of Bit 24 to Bit 30. This bit can also be used as Global Status Flag without starting a complete communication frame as it is present directly after pulling CSN low.

Reset Bit (RSTB)

The RSTB indicates a device reset. In case this bit is set, specific internal Control Registers are set to default and kept in that state until the bit is cleared. The RSTB bit is cleared after a Read & Clear of all the specific bits in the Status Registers which caused the reset event.

SPI Error (SPIE)

The SPIE is a logical OR combination of errors related to a wrong SPI communication.

Physical Layer Error (PLE)

The PLE is a logical OR combination of errors related to the LIN transceiver.

Functional Error (FE)

The FE is a logical OR combination of errors coming from functional blocks (e.g. high-side overcurrent).

Device Error (DE)

The DE is a logical OR combination of errors related to device specific blocks (e.g. VS overvoltage, overtemperature).

Global Warning (GW)

The GW is a logical OR combination of warning flags (e.g. thermal warning).

Fail Safe (FS)

The FS bit indicates that the device was forced into a safe state due to mistreatment or fundamental internal errors (e.g. Watchdog failure, Voltage regulator failure).

Data-Out Payload

The Payload (Data Bytes 1 to 3) is the data transferred from the slave device with every SPI communication to the master device. The Payload always follows the OpCode and the address bits of the actual shifted in data (In-frame-Response).

5.2.3 Address definition**Table 54. Device application access**

Operating Code	
OC1	OC0
0	0
0	1
1	0

Table 55. Device information read access

Operating Code	
OC1	OC0
1	1

Table 56. RAM address range

RAM Address	Description	Access
3FH	Configuration Register	R/W
3CH	Status Register 12	R/C
...	...	
32H	Status Register 2	R/C
31H	Status Register 1	R/C
...	...	
22H	Control Register 34	R/W
1DH	Control Register 29	R/W
...	...	
02H	Control Register 2	R/W

Table 56. RAM address range (continued)

RAM Address	Description	Access
01H	Control Register 1	R/W
00H	reserved	

Table 57. ROM address range

ROM Address	Description	Access
3FH	<Advanced Op.>	W
3EH	<GSB Options>	R
...		
20H	<SPI CPHA test>	R
16H	<WD bit pos. 4>	R
15H	<WD bit pos. 3>	R
14H	<WD bit pos. 2>	R
13H	<WD bit pos. 1>	R
12H	<WD Type 2>	R
11H	<WD Type 1>	R
10H	<SPI mode>	R
...		
0AH	<Silicon Ver.>	R
...		
06H	<Device No.5>	R
05H	<Device No.4>	R
04H	<Device No.3>	R
03H	<Device No.2>	R
02H	<Device No.1>	R
01H	<Device Family>	R
00H	<Company Code>	R

Information registers

The *Device Information Registers* can be read by using OpCode '11'. After shifting out the GSB the 8-bit wide payload will be transmitted. By reading *Device Information Registers* a communication width which is minimum 16-bit plus a multiple by 8 can be used. After shifting out the GSB followed by the 8-bit wide payload a series of '0' is shifted out at the SDO.

Table 58. Information Registers Map

ROM Address	Description	Access		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
3FH	<Advanced Op.>										
3EH	<GSB Options>	R	→	0	0	0	0	0	0	0	0
...											
20H	<SPI CPHA test>	R	→	0	1	0	1	0	1	0	1
16H	<WD bit pos. 4>	R	→	C0H							
15H	<WD bit pos. 3>	R	→	7FH							
14H	<WD bit pos. 2>	R	→	C0H							
13H	<WD bit pos. 1>	R	→	41H							
12H	<WD Type 2>	R	→	91H							
11H	<WD Type 1>	R	→	28H							
10H	<SPI mode>	R	→	B0H							
...			→								
0AH	<Silicon Ver.>	R	→	major revision				minor revision			
...			→								
06H	<Device No.5>	R		L99DZ120: 01H							
05H	<Device No.4>	R	→	06H							
04H	<Device No.3>	R	→	4DH							
03H	<Device No.2>	R	→	41H							
02H	<Device No.1>	R	→	55H							
01H	<Device Family>	R	→	01H							
00H	<Company Code>	R	→	00H							

Device Identification Registers

These registers represent a unique signature to identify the device and silicon version.

<Company Code>: 00H (STMicroelectronics)

<Device Family>: 01H (BCD Power Management)

<Device No. 1>: 55H

<Device No. 2>: 41H

<Device No. 3>: 4DH

<Device No. 4>: 06H

<Device No. 5>: for L99DZ120: 01H

SPI modes

By reading out the <SPI mode> register general information of SPI usage of the *Device Application Registers* can be read.

Table 59. SPI Mode Register

Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
BR	DL2	DL1	DL0	0	0	S1	S0
1	0	1	1	0	0	0	0

<SPI mode>: B0H (Burst mode read available, 32-bit, no data consistency check)

SPI Burst Read

Table 60. Burst Read Bit

Bit 7	Description
0	BR not available
1	BR available

The SPI Burst Read bit indicates if a burst read operation is implemented. The intention of a Burst Read is e.g. used to perform a device internal memory dump to the SPI Master.

The start of the Burst Read is like a normal Read Operation. The difference is, that after the SPI Data Length the CSN is not pulled high and the SCK will be continuously clocked. When the normal SCK max count is reached (SPI Data Length) the consecutive addressed data will be latched into the shift register. This procedure is performed every time when the SCK payload length is reached.

In case the automatic incremented address is not used by the device, undefined data is shifted out. An automatic address overflow is implemented when address 3FH is reached. The SPI Burst Read is limited by the CSN low timeout.

SPI Data Length

The SPI Data Length value indicates the length of the SCK count monitor which is running for all accesses to the Device Application Registers. In case a communication frame with an SCK count is not equal to the reported one it will lead to a SPI Error and the data will be rejected.

Table 61. SPI Data Length

Bit 6	Bit 5	Bit 4	Description
DL2	DL1	DL0	
0	0	0	invalid
0	0	1	16-bit SPI
0	1	0	24-bit SPI
0	1	1	32-bit SPI
			...
1	1	1	64-bit SPI

Data Consistency Check (Parity/CRC)

N/A

Table 62. Data Consistency Check

Bit 1	Bit 0	Description
S1	S0	
0	0	not used
0	1	Parity used
1	0	CRC used
1	1	Invalid

Watchdog Definition

In case a watchdog is implemented the default settings can be read out via the *Device Information Registers*.

Table 63. WD Type/Timing

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	WD1	WD0						
<WD Type 1/2>	0	0	Register is not used					
<WD Type 1>	0	1	WT5	WT4	WT3	WT2	WT1	WT0
		1	1	0	1	0	0	0
			Watchdog Timeout / Long Open Window WT[5:0] * 5ms					
<WD Type 2>	1	0	OW2	OW1	OW0	CW2	CW1	CW0
	1	0	0	1	0	0	0	1
			Open Window OW[2:0] * 5ms			Closed Window CW[2:0] * 5ms		
<WD Type 1/2>	1	1	Invalid					

<WD Type 1>: 28H (Long Open Window: 200ms)

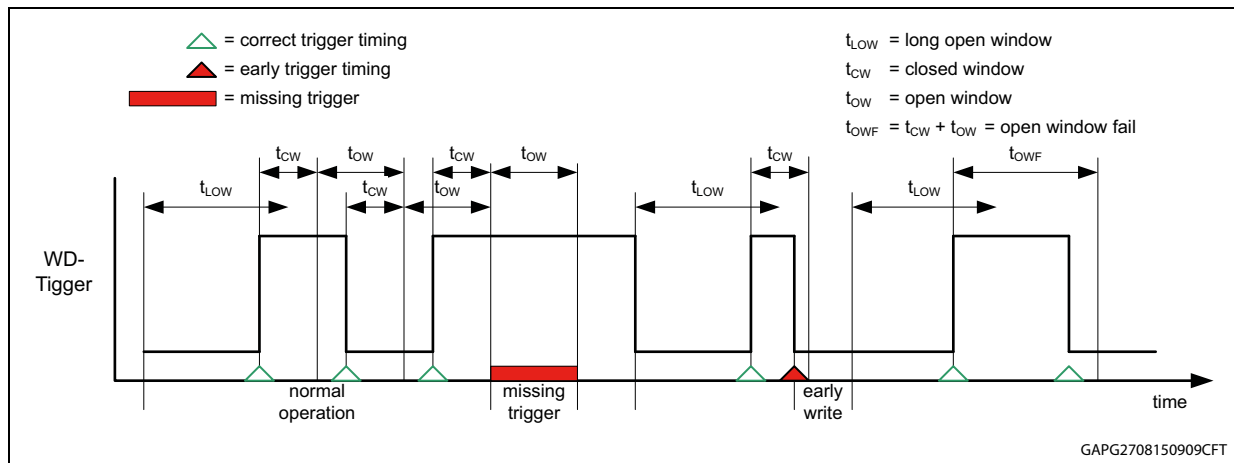
<WD Type 2>: 91H (Open Window: 10ms, Closed Window: 5ms)

<WD Type 1> indicates the Long Open Window (timeout) which is opened at the start of the watchdog. The binary value of WT[5:0] times 5ms indicates the typical value of the Timeout Time.

<WD Type 2> describes the default timing of the window watchdog.

The binary value of CW[2:0] times 5ms defines the typical Closed Window time and OW[2:0] times 5ms defines the typical Open Window time.

Figure 54. Window watchdog operation



The watchdog trigger bit location is defined by the <WD bit pos. X> registers.

Table 64. WD bit position

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	WB1	WB0						
<WD bit pos. X>	0	0	Register is not used					
<WD bit pos. X>	0	1	WBA5	WBA4	WBA3	WBA2	WBA1	WBA0
<WD bit pos. 1>	0	1	0	0	0	0	0	1
<WD bit pos. 3>	0	1	1	1	1	1	1	1
Defines the register addresses of the WD trigger bits								
<WD bit pos. X>	1	0	WBA5	WBA4	WBA3	WBA2	WBA1	WBA0
Defines the stop address of the address range (previous <WD bit pos. X> is a WB = '01'). The consecutive <WD bit pos. X> has to be a WB = '11'								
<WD bit pos. X>	1	1	0	WBP 4	WBP3	WBP2	WBP1	WBP0
<WD bit pos. 2>	1	1	0	0	0	0	0	0
<WD bit pos. 4>	1	1	0	0	0	0	0	0
Defines the binary bit position of the WD trigger bit within the register								

<WD bit pos 1>: 41H; watchdog trigger bit located at address 01H (CR1)

<WD bit pos 2>: C0H; watchdog trigger bit location is bit0

<WD bit pos 3>: 7FH; watchdog trigger bit located at address 3FH (Config Register)

<WD bit pos 4>: C0H; watchdog trigger bit location is bit0

Device Application Registers (RAM)

The *Device Application Registers* are all registers accessible using OpCode '00', '01' and '10'. The functions of these registers are defined in the device specification.

5.2.4 Protocol failure detection

To realize a protocol which covers certain failsafe requirements a basic set of failure detection mechanisms is implemented.

Clock monitor

During communication (CSN low to high phase) a clock monitor counts the valid SCK clock edges. If the SCK edges do not correlate with the SPI Data Length an SPIE is reported with the next command and the actual communication is rejected.

By accessing the Device Information Registers (OpCode = '11') the Clock Monitor is set to a minimum of 16 SCK edges plus a multiple by 8 (e.g. 16, 25, 32, ...). Providing no SCK edge during a CSN low to high phase is not recognized as an SPIE. For a SPI Burst Read also the SPI Data Length plus multiple numbers of Payloads SCK edges are assumed as a valid communication.

SCK Polarity (CPOL) check

To detect the wrong polarity access via SCK the internal Clock monitor is used. Providing first a negative edge on SCK during communication (CSN low to high phase) or a positive edge at last will lead to an SPI Error reported in the next communication and the actual data is rejected.

SCK Phase (CPHA) check

To verify, that the SCK Phase of the SPI master is set correctly a special Device Information Register is implemented. By reading this register the data must be 55H. In case AAH is read the CPHA setting of the SPI master is wrong and a proper communication cannot be guaranteed.

CSN timeout

By pulling CSN low the SDO is set active and leaves its 3-state condition. To ensure communication between other SPI devices within the same bus even in case of CSN stuck at low a CSN timeout is implemented. By pulling CSN low an internal timer is started. After timer end is reached the actual communication is rejected and the SDO is set to 3-state condition.

SDI stuck at GND

As a communication with data all-'0' and OpCode '00' on address b'000000 cannot be distinguished between a valid command and a SDI stuck at GND this communication is not allowed. Nevertheless, in case a stuck at GND is detected the communication will be rejected and the SPIE will be set with the next communication.

SDI stuck at HIGH

As a communication with data all-'1' and OpCode '11' on address b'111111 cannot be distinguished between a valid command and a SDI stuck at HIGH this communication is not

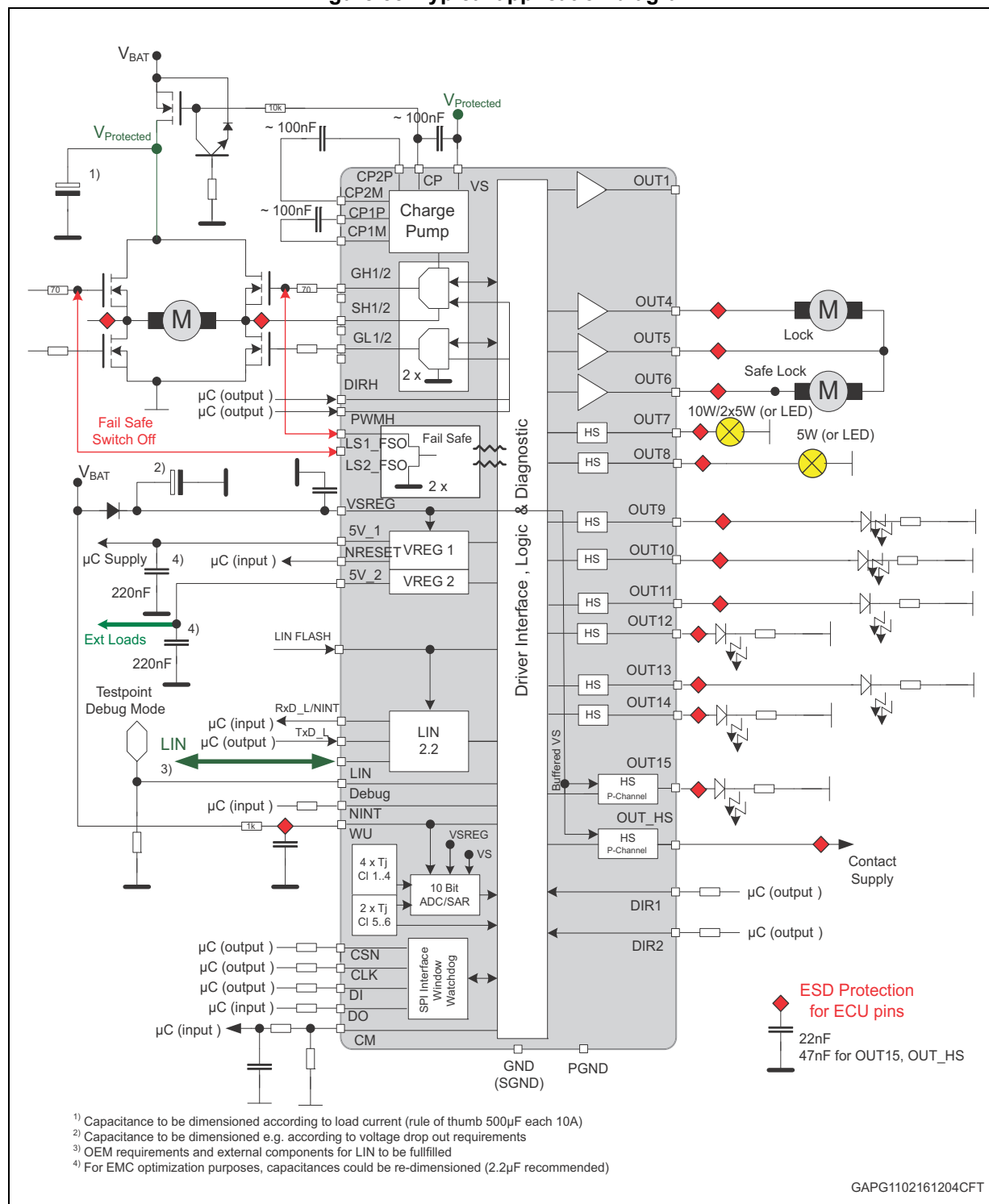
allowed. In case a stuck at HIGH is detected the communication will be rejected and the SPIE will be set with the next communication.

SDO stuck @

The SDO stuck at GND and stuck at HIGH have to be detected by the SPI master. As the definition of the GSB guarantees at least one toggle, a GSB with all-'0' or all-'1' reports a stuck at error.

6 Application

Figure 55. Typical application diagram



7 SPI Registers

7.1 Global Status Byte GSB

Table 65. Global Status Byte (GSB)

	31	30	29	28	27	26	25	24
Bit name	GSBN	RSTB	SPIE	PLE	FE	DE	GW	FS
Reset	1	0	0	0	0	0	0	0
Access	R							

Table 66. GSB signals description

Bit	Name	Description
31	GSBN	<p>Global Status Bit Inverted</p> <p>The GSBN is a logically NOR combination of GSB Bits 24 to Bit 30⁽¹⁾.</p> <p>This bit can also be used as Global Status Flag without starting a complete communication frame as it is present at SDO directly after pulling CSN low.</p> <p>0: error detected (1 or several GSB bits from 24 to 30 are set)</p> <p>1: no error detected (default after Power-on)</p> <p>Specific failures may be masked in the Configuration Register 0x3F. A masked failure will still be reported in the GSB by the related failure flag, however it is not reflected in the GSBN (bit 31).</p>
30	RSTB	<p>Reset</p> <p>The RSTB indicates a device reset and it is set in case of the following events:</p> <ul style="list-style-type: none"> – VPOR (SR1 - 0x31) – WDFAIL (SR1 - 0x31) – V1UV (SR1 - 0x31) – FORCED_SLEEP_TSD2/V1SC (SR1 - 0x31) <p>0: no reset signal has been generated (default)</p> <p>1: Reset signal has been generated</p> <p>RSTB is cleared by a <i>Read & Clear</i> command to all bits in <i>Status Register 1</i> causing the Reset event.</p>
29	SPIE ⁽²⁾	<p>SPI Error Bit</p> <p>The SPIE indicates errors related to a wrong SPI communication.</p> <ul style="list-style-type: none"> – SPI_INV_CMD (SR2 - 0x32) – SPI_SCK_CNT (SR2 - 0x32) <p>The bit is also set in case of an SPI CSN Time-out detection</p> <p>0: no error (default)</p> <p>1: error detected</p> <p>SPIE is cleared by a valid SPI command.</p>

Table 66. GSB signals description (continued)

Bit	Name	Description
28	PLE ⁽²⁾	<p>Physical Layer Error</p> <p>The PLE is a logical OR combination of errors related to the LIN transceiver.</p> <ul style="list-style-type: none"> – LIN_PERM_DOM (SR2 - 0x32) – LIN_TXD_DOM (SR2 - 0x32) – LIN_PERM_REC (SR2 - 0x32) <p>0: no error (default) 1: error detected</p> <p>PLE is cleared by a <i>Read & Clear</i> command to all related bits in <i>Status Registers 2 and 12</i>.</p>
27	FE	<p>Functional Error Bit</p> <p>The FE is a logical OR combination of errors coming from functional blocks.</p> <ul style="list-style-type: none"> – V2SC (SR2 - 0x32) – DSMON_HSx (SR2 - 0x32) – DSMON_LSx (SR2 - 0x32) – OUTxHS_OC TH EX (SR3 - 0x33) – OUTxLS_OC TH EX (SR3 - 0x33) – OUTHS_OC TH EX (SR3 - 0x33) – OUTx_OC (SR3 - 0x33) – LSxFS_OC (SR3 - 0x33) – OUTxHS_OL (SR5 - 0x35)⁽³⁾ – OUTxLS_OL (SR5 - 0x35) – OUTx_OL (SR5 - 0x35) – OUTHS_OL (SR5 - 0x35) <p>0: no error (default) 1: error detected</p> <p>FE is cleared by a <i>Read & Clear</i> command to all related bits in <i>Status Registers 2, 3, 4, 5</i></p>
26	DE	<p>Device Error Bit</p> <p>DE is a logical OR combination of global errors related to the device.</p> <ul style="list-style-type: none"> – VS_OV (SR2 - 0x32) – VS_UV (SR2 - 0x32) – VSREG_OV (SR2 - 0x32) – VSREG_UV (SR2 - 0x32) – CP_LOW (SR2 - 0x32) – TSD1_CLx (SR6 - 0x36) <p>0: no error (default) 1: error detected</p> <p>DE is cleared by a <i>Read & Clear</i> command to all related bits in <i>Status Registers 2 and 6</i></p>

Table 66. GSB signals description (continued)

Bit	Name	Description
25	GW ⁽²⁾	<p>Global Warning Bit</p> <p>GW is a logical OR combination of warning flags. Warning bits do not lead to any device state change or switch off of functions.</p> <ul style="list-style-type: none"> – VSREG_EW (SR2 - 0x32) – V1_FAIL (SR2 - 0x32) – V2_FAIL (SR2 - 0x32) – TW ⁽³⁾ (SR2 - 0x32) – SPI_INV_CMD (SR2 - 0x32) – SPI_SCK_CNT (SR2 - 0x32) <p>0: no error (default) 1: error detected</p> <p>GW is cleared by a <i>Read & Clear</i> command to all related bits in <i>Status Register 2</i>.</p>
24	FS	<p>Fail Safe</p> <p>The FS bit indicates the device was forced into a safe state due to the following failure conditions:</p> <ul style="list-style-type: none"> – WDFAIL (SR1 - 0x31) – V1UV (SR1 - 0x31) – TSD2 (SR1 - 0x31) – FORCED_SLEEP_TSD/V1SC (SR1 - 0x31) <p>All Control Registers are set to default</p> <p>Control Registers are blocked for WRITE access except the following bits:</p> <ul style="list-style-type: none"> – TRIG (CR1 - 0x01) – V2_0 (CR1 - 0x01) – V2_1 (CR1 - 0x01) – Timer settings (bits 8...23) (CR2 - 0x02) – OUTHS_x (bits 0...3) (CR5 - 0x05) – OUT15_x (bits 0...3) (CR6 - 0x06) – CR12 (0x0C) to CR17 (0x11); PWM frequency and duty cycles <p>0: Fail Safe inactive (default) 1: Fail Safe active</p> <p>FS is cleared upon exit from Fail-Safe mode (refer to chapter 'Fail-Safe mode')</p>

1. Individual failure flags may be masked in the Configuration Register (0x3F).
2. Bit may be masked in the Configuration Register (0x3F), i.e. the bit will not be included in the Global Status Bit (GSBN).
3. Open-load status flags may be masked in the Configuration register (0x3F), i.e. the open-load flag will be included in the FE flag, but will not set the GSBN. TW failure status flags may be masked in the Configuration register (0x3F), i.e. the TW flag will be included in the GW flag, but will not set the GSBN.

7.2 Control register overview

Table 67. Control register overview

		Bit																									
Addr.	Reg.	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	Access	
0x00		Reserved																									
0x01	CR1	Reserved	WU_EN	Reserved	WU_PU	Reserved	Reserved	WU_FILT_1	WU_FILT_0	TIMER_NINT_WAKE_SEL	TIMER_NINT_EN	Reserved								HEN	V2_1	V2_0	PARITY	STBY_SEL	GO_STBY	TRIG	R/W
0x02	CR2	T1_RESTART	T1_DIR	T1_ON_2	T1_ON_1	T1_ON_0	T1_PER_2	T1_PER_1	T1_PER_0	T2_RESTART	T2_DIR	T2_ON_2	T2_ON_1	T2_ON_0	T2_PER_2	T2_PER_1	T2_PER_0	LIN_REC_ONLY	LIN_TXD_TOUT_EN	Reserved	Reserved	V1_RESET_1	V1_RESET_0	WD_TIME_1	WD_TIME_0	R/W	
0x03	CR3	VSREG_LOCK_EN	VS_LOCK_EN	VSREG_OV_SD_EN	VSREG_UV_SD_EN	VS_OV_SD_EN	VS_UV_SD_EN	Reserved								VSREG_EWTH_9	VSREG_EWTH_8	VSREG_EWTH_7	VSREG_EWTH_6	VSREG_EWTH_5	VSREG_EWTH_4	VSREG_EWTH_3	VSREG_EWTH_2	VSREG_EWTH_1	VSREG_EWTH_0	R/W	
0x04	CR4	Reserved	OUT1_HS	OUT1_LS	Reserved								OUT4_HS	OUT4_LS	Reserved	OUT5_HS	OUT5_LS	Reserved	OUT6_HS	OUT6_LS	R/W						
0x05	CR5	OUT7_3	OUT7_2	OUT7_1	OUT7_0	OUT8_3	OUT8_2	OUT8_1	OUT8_0	Reserved				OUT10_3	OUT10_2	OUT10_1	OUT10_0	Reserved				OUTHS_3	OUTHS_2	OUTHS_1	OUTHS_0	R/W	
0x06	CR6	OUT9_3	OUT9_2	OUT9_1	OUT9_0	OUT11_3	OUT11_2	OUT11_1	OUT11_0	OUT12_3	OUT12_2	OUT12_1	OUT12_0	OUT13_3	OUT13_2	OUT13_1	OUT13_0	OUT14_3	OUT14_2	OUT14_1	OUT14_0	OUT15_3	OUT15_2	OUT15_1	OUT15_0	R/W	
0x07	CR7	OUT1_OCR	Reserved	OUT4_OCR	OUT5_OCR	OUT6_OCR	OUT7_OCR	OUT8_OCR	OUTHS_OCR	Reserved								OCR_FREQ	OUT5_OC1	OUT5_OC0	CM_EN	Reserved	CM_SEL_3	CM_SEL_2	CM_SEL_1	CM_SEL_0	R/W

Table 67. Control register overview (continued)

		Bit																								Access	
Addr.	Reg.	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0		
0x08	CR8	OUT1_OCR_THX_EN	Reserved			OUT4_OCR_THX_EN	OUT5_OCR_THX_EN	OUT6_OCR_THX_EN	OUT7_OCR_THX_EN	OUT8_OCR_THX_EN	OUTHS_OCR_THX_EN	Reserved														R/W	
0x09	CR9	OUT7_RDSON	OUT8_RDSON	Reserved						OUTHS_OL	OUT15_OL	OUT14_OL	OUT13_OL	OUT12_OL	OUT11_OL	OUT10_OL	OUT9_OL	OUTHS_OC	OUT15_OC	OUT14_OC	OUT13_OC	OUT12_OC	OUT11_OC	OUT10_OC	OUT9_OC	R/W	
0x0A	CR10	DIAG_2	DIAG_1	DIAG_0	Reserved						SD		SDS	COPT_3	COPT_2	COPT_1	COPT_0	H_OLTH_HIGH	OL_H1L2	OL_H2L1	SLEW_4	SLEW_3	SLEW_2	SLEW_1	SLEW_0	R/W	
0x0B	CR11	Reserved																						R/W			
0x0C	CR12	PMW1_FREQ_1	PMW1_FREQ_0	PMW2_FREQ_1	PMW2_FREQ_0	PMW3_FREQ_1	PMW3_FREQ_0	PMW4_FREQ_1	PMW4_FREQ_0	PMW5_FREQ_1	PMW5_FREQ_0	PMW6_FREQ_1	PMW6_FREQ_0	PMW7_FREQ_1	PMW7_FREQ_0	PMW8_FREQ_1	PMW8_FREQ_0	PMW9_FREQ_1	PMW9_FREQ_0	PMW10_FREQ_1	PMW10_FREQ_0	Reserved				R/W	
0x0D	CR13	Reserved	PWM1_DC_9	PWM1_DC_8	PWM1_DC_7	PWM1_DC_6	PWM1_DC_5	PWM1_DC_4	PWM1_DC_3	PWM1_DC_2	PWM1_DC_1	PWM1_DC_0	Reserved				PWM2_DC_9	PWM2_DC_8	PWM2_DC_7	PWM2_DC_6	PWM2_DC_5	PWM2_DC_4	PWM2_DC_3	PWM2_DC_2	PWM2_DC_1	PWM2_DC_0	R/W
0x0E	CR14	Reserved	PWM3_DC_9	PWM3_DC_8	PWM3_DC_7	PWM3_DC_6	PWM3_DC_5	PWM3_DC_4	PWM3_DC_3	PWM3_DC_2	PWM3_DC_1	PWM3_DC_0	Reserved				PWM4_DC_9	PWM4_DC_8	PWM4_DC_7	PWM4_DC_6	PWM4_DC_5	PWM4_DC_4	PWM4_DC_3	PWM4_DC_2	PWM4_DC_1	PWM4_DC_0	R/W
0x0F	CR15	Reserved	PWM5_DC_9	PWM5_DC_8	PWM5_DC_7	PWM5_DC_6	PWM5_DC_5	PWM5_DC_4	PWM5_DC_3	PWM5_DC_2	PWM5_DC_1	PWM5_DC_0	Reserved				PWM6_DC_9	PWM6_DC_8	PWM6_DC_7	PWM6_DC_6	PWM6_DC_5	PWM6_DC_4	PWM6_DC_3	PWM6_DC_2	PWM6_DC_1	PWM6_DC_0	R/W

Table 67. Control register overview (continued)

Addr.	Reg.	Bit																								Access	
		23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0		
0x10	CR16	Reserved		PWM7_DC_9	PWM7_DC_8	PWM7_DC_7	PWM7_DC_6	PWM7_DC_5	PWM7_DC_4	PWM7_DC_3	PWM7_DC_2	PWM7_DC_1	PWM7_DC_0	Reserved		PWM8_DC_9	PWM8_DC_8	PWM8_DC_7	PWM8_DC_6	PWM8_DC_5	PWM8_DC_4	PWM8_DC_3	PWM8_DC_2	PWM8_DC_1	PWM8_DC_0	R/W	
0x11	CR17	Reserved		PWM9_DC_9	PWM9_DC_8	PWM9_DC_7	PWM9_DC_6	PWM9_DC_5	PWM9_DC_4	PWM9_DC_3	PWM9_DC_2	PWM9_DC_1	PWM9_DC_0	Reserved		PWM10_DC_9	PWM10_DC_8	PWM10_DC_7	PWM10_DC_6	PWM10_DC_5	PWM10_DC_4	PWM10_DC_3	PWM10_DC_2	PWM10_DC_1	PWM10_DC_0	R/W	
0x12	CR18	Reserved		OUT7_AUTOCOMP_EN	OUT7_VLED_9	OUT7_VLED_8	OUT7_VLED_7	OUT7_VLED_6	OUT7_VLED_5	OUT7_VLED_4	OUT7_VLED_3	OUT7_VLED_2	OUT7_VLED_1	OUT7_VLED_0	Reserved		OUT8_VLED_9	OUT8_VLED_8	OUT8_VLED_7	OUT8_VLED_6	OUT8_VLED_5	OUT8_VLED_4	OUT8_VLED_3	OUT8_VLED_2	OUT8_VLED_1	OUT8_VLED_0	R/W
0x13	CR19	Reserved		OUT9_AUTOCOMP_EN	OUT9_VLED_9	OUT9_VLED_8	OUT9_VLED_7	OUT9_VLED_6	OUT9_VLED_5	OUT9_VLED_4	OUT9_VLED_3	OUT9_VLED_2	OUT9_VLED_1	OUT9_VLED_0	Reserved		OUT10_VLED_9	OUT10_VLED_8	OUT10_VLED_7	OUT10_VLED_6	OUT10_VLED_5	OUT10_VLED_4	OUT10_VLED_3	OUT10_VLED_2	OUT10_VLED_1	OUT10_VLED_0	R/W
0x14	CR20	Reserved		OUT11_AUTOCOMP_EN	OUT11_VLED_9	OUT11_VLED_8	OUT11_VLED_7	OUT11_VLED_6	OUT11_VLED_5	OUT11_VLED_4	OUT11_VLED_3	OUT11_VLED_2	OUT11_VLED_1	OUT11_VLED_0	Reserved		OUT12_VLED_9	OUT12_VLED_8	OUT12_VLED_7	OUT12_VLED_6	OUT12_VLED_5	OUT12_VLED_4	OUT12_VLED_3	OUT12_VLED_2	OUT12_VLED_1	OUT12_VLED_0	R/W

Table 67. Control register overview (continued)

		Bit																											
Addr.	Reg.	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	Access			
0x15	CR21	Reserved	OUT13_AUTOCOMP_EN	OUT13_VLED_9	OUT13_VLED_8	OUT13_VLED_7	OUT13_VLED_6	OUT13_VLED_5	OUT13_VLED_4	OUT13_VLED_3	OUT13_VLED_2	OUT13_VLED_1	OUT13_VLED_0	Reserved	OUT14_AUTOCOMP_EN	OUT14_VLED_9	OUT14_VLED_8	OUT14_VLED_7	OUT14_VLED_6	OUT14_VLED_5	OUT14_VLED_4	OUT14_VLED_3	OUT14_VLED_2	OUT14_VLED_1	OUT14_VLED_0	R/W			
		Reserved	OUT15_AUTOCOMP_EN	OUT15_VLED_9	OUT15_VLED_8	OUT15_VLED_7	OUT15_VLED_6	OUT15_VLED_5	OUT15_VLED_4	OUT15_VLED_3	OUT15_VLED_2	OUT15_VLED_1	OUT15_VLED_0	Reserved	OUTHS_AUTOCOMP_EN	OUTHS_VLED_9	OUTHS_VLED_8	OUTHS_VLED_7	OUTHS_VLED_6	OUTHS_VLED_5	OUTHS_VLED_4	OUTHS_VLED_3	OUTHS_VLED_2	OUTHS_VLED_1	OUTHS_VLED_0	R/W			
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
		Reserved																								CP_OFF	ICMP	WD_EN	R/W
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Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
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Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF	ICMP	WD_EN	R/W		
Reserved																								CP_OFF					

Note: All reserved bits (RES) are read-only (R) and will be read as '0'. Writing '1' to a reserved bit is ignored and does not cause an SPI error.

7.3 Status register overview

Table 68. Status register overview

		Bit																								Access	
Addr.	Reg.	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0		
0x31	SR1	Reserved	WU_STATE	Reserved	WU_WAKE	Reserved	WAKE_LIN	WAKE_TIMER	DEBUG_ACTIVE	V1UV	V1_RESTART_2	V1_RESTART_1	V1_RESTART_0	WDFAIL_CNT_3	WDFAIL_CNT_2	WDFAIL_CNT_1	WDFAIL_CNT_0	DEVICE_STATE_1	DEVICE_STATE_0	TSD2	TSD1	FORCED_SLEEP_TSD2M1SC	FORCED_SLEEP_WD	WDFAIL	VPOR	⌘	
0x32	SR2	LIN_PERM_DOM	LIN_TXD_DOM	LIN_PERM_REC	Reserved					DSMON_HS2	DSMON_HS1	DSMON_LS2	DSMON_LS1	SPI_INV_CMD	SPI_SCK_CNT	CP_LOW	TW	V2SC	V2FAIL	V1FAIL	VSREG_EW	VSREG_OV	VSREG_UV	VS_OV	VS_UV	⌘	
0x33	SR3	OUT1_HS_OC_TH_EX	OUT1_LS_OC_TH_EX	Reserved					OUT4_HS_OC_TH_EX	OUT4_LS_OC_TH_EX	OUT5_HS_OC_TH_EX	OUT5_LS_OC_TH_EX	OUT6_HS_OC_TH_EX	OUT6_LS_OC_TH_EX	OUT7_OC_TH_EX	OUT8_OC_TH_EX	OUT9_OC	OUT10_OC	OUT11_OC	OUT12_OC	OUT13_OC	OUT14_OC	OUT15_OC	OUTHS_OC_TH_EX	LS2FSO_OC	LS1FSO_OC	⌘
0x34	SR4	OUT1_HS_OCR_ALERT	OUT1_LS_OCR_ALERT	Reserved					OUT4_HS_OCR_ALERT	OUT4_LS_OCR_ALERT	OUT5_HS_OCR_ALERT	OUT5_LS_OCR_ALERT	OUT6_HS_OCR_ALERT	OUT6_LS_OCR_ALERT	OUT7_OCR_ALERT	OUT8_OCR_ALERT	Reserved						OUTHS_OCR_ALERT	Reserved		⌘	
0x35	SR5	OUT1_HS_OL	OUT1_LS_OL	Reserved					OUT4_HS_OL	OUT4_LS_OL	OUT5_HS_OL	OUT5_LS_OL	OUT6_HS_OL	OUT6_LS_OL	OUT7_OL	OUT8_OL	OUT9_OL	OUT10_OL	OUT11_OL	OUT12_OL	OUT13_OL	OUT14_OL	OUT15_OL	OUTHS_OL	Reserved	⌘	

Table 68. Status register overview (continued)

		Bit																				Access																								
Addr.	Reg.	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0																					
0x36	SR6	WD_TIMER_STATE_1	WD_TIMER_STATE_0	Reserved									TW_CL6		TW_CL5		TW_CL4		TW_CL3		TW_CL2		TW_CL1		Reserved		TSD1_CL6		TSD1_CL5		TSD1_CL4		TSD1_CL3		TSD1_CL2		TSD1_CL1		R							
0x37	SR7	Reserved		TEMP_CL2_9		TEMP_CL2_8		TEMP_CL2_7		TEMP_CL2_6		TEMP_CL2_5		TEMP_CL2_4		TEMP_CL2_3		TEMP_CL2_2		TEMP_CL2_1		TEMP_CL2_0		Reserved		TEMP_CL1_9		TEMP_CL1_8		TEMP_CL1_7		TEMP_CL1_6		TEMP_CL1_5		TEMP_CL1_4		TEMP_CL1_3		TEMP_CL1_2		TEMP_CL1_1		TEMP_CL1_0		R
0x38	SR8	Reserved		TEMP_CL4_9		TEMP_CL4_8		TEMP_CL4_7		TEMP_CL4_6		TEMP_CL4_5		TEMP_CL4_4		TEMP_CL4_3		TEMP_CL4_2		TEMP_CL4_1		TEMP_CL4_0		Reserved		TEMP_CL3_9		TEMP_CL3_8		TEMP_CL3_7		TEMP_CL3_6		TEMP_CL3_5		TEMP_CL3_4		TEMP_CL3_3		TEMP_CL3_2		TEMP_CL3_1		TEMP_CL3_0		R
0x39	SR9	Reserved		TEMP_CL6_9		TEMP_CL6_8		TEMP_CL6_7		TEMP_CL6_6		TEMP_CL6_5		TEMP_CL6_4		TEMP_CL6_3		TEMP_CL6_2		TEMP_CL6_1		TEMP_CL6_0		Reserved		TEMP_CL5_9		TEMP_CL5_8		TEMP_CL5_7		TEMP_CL5_6		TEMP_CL5_5		TEMP_CL5_4		TEMP_CL5_3		TEMP_CL5_2		TEMP_CL5_1		TEMP_CL5_0		R
0x3A	SR10	Reserved		VSREG_9		VSREG_8		VSREG_7		VSREG_6		VSREG_5		VSREG_4		VSREG_3		VSREG_2		VSREG_1		VSREG_0		Reserved										R												
0x3B	SR11	Reserved		VS_9		VS_8		VS_7		VS_6		VS_5		VS_4		VS_3		VS_2		VS_1		VS_0		Reserved										R												

7.4 Control registers

7.4.1 Control Register CR1 (0x01)

Table 69. Control Register CR1

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved	WU_EN	Reserved	WU_PU	Reserved		WU_FILT_1	WU_FILT_0	TIMER_NINT_WAKE_SEL	TIMER_NINT_EN	Reserved							HEN	V2_1	V2_0	PARITY	STBY_SEL	GO_STBY	TRIG
Reset	0	1	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R	R/W	R	R/W	R		R/W																	

Table 70. CR1 signals description

Bit	Name	Description
23	Reserved	—
22	WU_EN	Wake-up Input 1 (WU) enable ⁽¹⁾ 0: WU disabled 1: WU enabled (default)
21	Reserved	—
20	WU_PU	Wake-up Input1 Pull-up/down configuration: configuration of internal current source ⁽¹⁾ 0: pull-down (default) 1: pull-up
19	Reserved	—
18		
17	WU_FILT_1	Wake-up Input1 Filter configuration Bits: configuration of input filter ⁽¹⁾ See Table 71: Wake-up input1 filter configuration
16	WU_FILT_0	
15	TIMER_NINT_WAKE_SEL	Select Timer for NINT / Wake: select timer for periodic interrupt in standby modes 0: Timer 2 (default) 1: Timer 1

Table 70. CR1 signals description (continued)

Bit	Name	Description
14	TIMER_NINT_EN	Timer NINT enable: enable timer interrupt in standby modes 0: timer interrupt disabled (default) 1: timer interrupt enabled V1_standby mode: periodic NINT pulse generated by timer (NINT pulse at start of timer on-phase) Vbat_standby mode: device wakes up after timer expiration and generates NReset
13:7	Reserved	—
6	HEN	Enable H-bridge 0: H-bridge disabled (default) 1: H-bridge enabled Refer to chapter <i>H-bridge Control</i> for details
5	V2_1	Voltage Regulator V2 Configuration See Table 72: Voltage regulator V2 configuration
4	V2_0	
3	PARITY	PARITY: Standby Command Parity Bit
2	STBY_SEL	STBY SEL: Select Standby mode GO_STBY: Execute transition into Standby mode
1	GO_STBY	The STBY_SEL and GO_STBY bits are protected by a parity check. The bits STBY_SEL, GO_STBY and PARITY must represent an even number of '1', otherwise the command is ignored and the SPI_INV_CMD bit is set. Table 73: Standby transition configuration shows the valid settings. All other settings are invalid; command will be ignored and SPI_INV_CMD will be set. The GO_STBY bit is not cleared automatically after wake-up.
0	TRIG	Watchdog Trigger Bit

1. Setting is only valid if input is configured as wake-up input in Configuration Register (0x3F).

Table 71. Wake-up input1 filter configuration

WU_FILT_1	WU_FILT_0	
0	0	Wake-up inputs monitored in static mode (filter time t_{wu_stat}) (default)
0	1	Wake- up inputs monitored in cyclic mode with Timer2 (filter time: t_{wu_cyc} ; blanking time 80% of timer ON time)
1	0	Wake- up inputs monitored in cyclic mode with Timer1 (filter time: t_{wu_cyc} ; blanking time 80% of timer ON time)
1	1	Invalid setting; command will be ignored and SPI INV CMD will be set

Table 72. Voltage regulator V2 configuration

V2_1	V2_0	
0	0	V2 OFF in all modes (default)
0	1	V2 ON in Active mode; OFF in Standby modes

Table 72. Voltage regulator V2 configuration (continued)

V2_1	V2_0	
1	0	V2 ON in Active and V1_standby mode; OFF in Vbat_standby mode
1	1	V2 ON in all modes

Table 73. Standby transition configuration

PARITY	STBY_SEL	GO_STBY	
0	1	1	Go to V1 standby
1	0	1	Go to Vbat_standby
0	0	0	No transition to standby
1	1	0	

7.4.2 Control Register CR2 (0x02)

Table 74. Control Register CR2

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	T1_RESTART	T1_DIR	T1_ON_2	T1_ON_1	T1_ON_0	T1_PER_2	T1_PER_1	T1_PER_0	T2_RESTART	T2_DIR	T2_ON_2	T2_ON_1	T2_ON_0	T2_PER_2	T2_PER_1	T2_PER_0	LIN_REC_ONLY	LIN_TXD_TOUT_EN	Reserved		V1_RESET_1	V1_RESET_0	WD_TIME_1	WD_TIME_0
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0
Access	R/W																							

Table 75. CR2 signals description

Bit	Name	Description
23	T1_RESTART	Timer 1 Restart: Restart of Timer 1 0: timer is running with period and on-time according to configuration (default) 1: restart of timer at CSN low to high transition; starting with ON phase ⁽¹⁾ Bit is automatically reset with next SPI frame.
22	T1_DIR1	T1_DIR1: Timer 1 Direct Drive by DIR1 T1_ON_x: Timer 1 On-Time Bits Configuration of Timer 1 on-time, for details see Table 76 and Figure 56
21	T1_ON_2	
20	T1_ON_1	
19	T1_ON_0	

Table 75. CR2 signals description (continued)

Bit	Name	Description	
18	T1_PER_2	Configuration of Timer 1 Period 000: T1 (default) 001: T2 010: T3 011: T4 100: T5 101: T6 110: T7 111: T8	
17	T1_PER_1		
16	T1_PER_0		
15	T2_RESTART	Timer 2 Restart: restart of timer 2 0: timer is running with period and on-time according to configuration (default) 1: restart of timer at CSN low to high transition; starting with ON phase ⁽¹⁾ Bit is automatically reset with next SPI frame.	
14	T2_DIR1	T2_DIR1: Timer 2 Direct Drive by DIR1 T2_ON_x: Timer 2 On-Time Bits Configuration of Timer 2 on-time, for details see Table 76 and Figure 56	
13	T2_ON_2		
12	T2_ON_1		
11	T2_ON_0		
10	T2_PER_2	Configuration of Timer 2 Period 000: T1 (default) 001: T2 010: T3 011: T4 100: T5 101: T6 110: T7 111: T8	
9	T2_PER_1		
8	T2_PER_0		
7	LIN_REC_ONLY	LIN Transceiver Receive Only mode 0: LIN receive only mode disabled (default) 1: LIN receive only mode enabled	
6	LIN_TXD_TOUT_EN	LIN TxD Timeout Enable 0: LIN TxD timeout detection disabled 1: LIN TxD timeout detection enabled (default)	
5:4	Reserved	—	

Table 75. CR2 signals description (continued)

Bit	Name	Description
3	V1_RESET_1	Voltage Regulator V1 Reset Threshold
2	V1_RESET_0	00: Vrt4 (default) 01: Vrt3 10: Vrt2 11: Vrt1 thresholds are monitored in Active mode and V1_standby mode
1	WD_TIME_1	Watchdog Trigger Time
0	WD_TIME_0	00: TSW1 (default) 01: TSW2 10: TSW3 11: TSW4 Writing to WD_TIME_x is blocked unless WD CONFIG EN = 1. The modified WD Trigger Time is valid immediately after the Write command (CSN transition low-high). The watchdog timer is reset when the trigger time is modified (restart at CSN transition low-high).

1. Timer restart behavior:

Write to CR2 when Tx_ON_x and Tx_PERx remain unchanged:

Tx_RESTART = 1: timers restart at end of SPI frame, starting with ON time

Tx_RESTART = 0: write operation to CR2 has no effect on timers

Write to CR2 when Tx_ON_x and Tx_PERx are modified

Tx_RESTART = 1: timers restart at end of SPI frame, starting with ON time and according to new setting (ON time and period)

Tx_RESTART = 0: behavior is not defined; if a predictable behavior is needed, it is recommended to set Tx_RESTART = 1

Table 76. Configuration of Timer x on-time

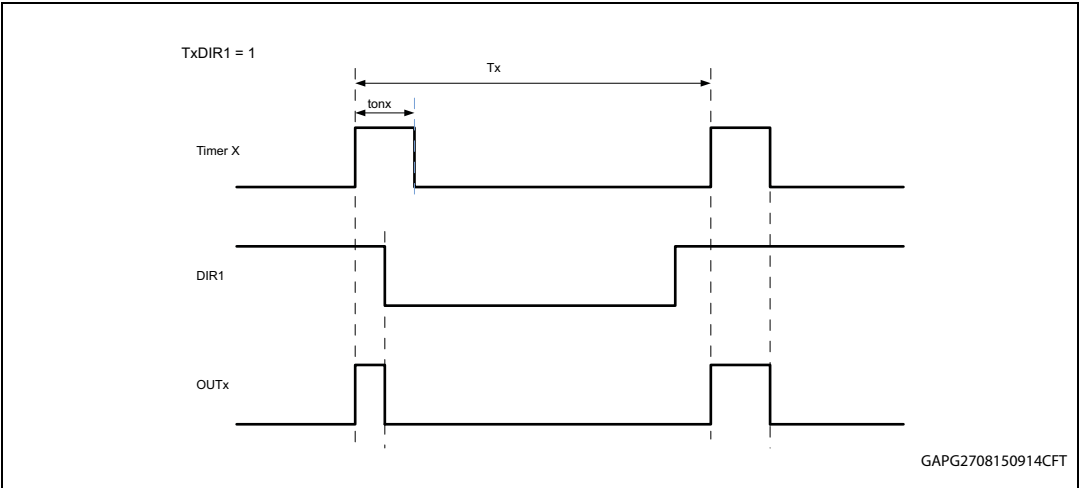
Tx_DIR1	Tx_ON_2	Tx_ON_1	Tx_ON_0	
0	0	0	0	ton1 (default)
0	0	0	1	ton2
0	0	1	0	ton3
0	0	1	1	ton4
0	1	0	0	ton5
0	1	0	1	Invalid setting; command will be ignored and SPI INV CMD will be set
0	1	1	0	
0	1	1	1	
1 ⁽¹⁾	0	0	0	ton1 controlled by DIR1 input signal (logical AND)
1 ⁽¹⁾	0	0	1	ton2 controlled by DIR1 input signal (logical AND)
1 ⁽¹⁾	0	1	0	ton3 controlled by DIR1 input signal (logical AND)
1 ⁽¹⁾	0	1	1	ton4 controlled by DIR1 input signal (logical AND)
1 ⁽¹⁾	1	0	0	ton5 controlled by DIR1 input signal (logical AND)

Table 76. Configuration of Timer x on-time (continued)

Tx_DIR1	Tx_ON_2	Tx_ON_1	Tx_ON_0	
1 ⁽¹⁾	1	0	1	Invalid setting; command will be ignored and <i>SPI INV CMD</i> will be set
1 ⁽¹⁾	1	1	0	
1 ⁽¹⁾	1	1	1	

1. Tx_DIR1 = 1 is only valid for OUT7-OUT15 and OUT_HS control; the DIR1 signal has no influence for WU monitoring if WU is monitored by timer.

Figure 56. Timer_x controlled by DIR1



7.4.3 Control Register CR3 (0x03)

Table 77. Control Register CR3

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	VSREG_LOCK_EN	VS_LOCK_EN	VSREG_OV_SD_EN	VSREG_UV_SD_EN	VS_OV_SD_EN	VS_UV_SD_EN	Reserved								VSREG_EWTH_9	VSREG_EWTH_8	VSREG_EWTH_7	VSREG_EWTH_6	VSREG_EWTH_5	VSREG_EWTH_4	VSREG_EWTH_3	VSREG_EWTH_2	VSREG_EWTH_1	VSREG_EWTH_0
Reset	1	1	1	1	1	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R/W																							



Table 78. CR3 signals description

Bit	Name	Description
23	VSREG_LOCK_EN	<p>VSREG lockout enable: Lockout of V_{SREG} related outputs after V_{SREG} overvoltage/undervoltage shutdown</p> <p>0: V_{SREG} related Outputs are turned on automatically and status bits (VSREG_UV, VSREG_OV) are cleared</p> <p>1: V_{SREG} related Outputs remain turned off until status bits (VSREG_UV, VSREG_OV) are cleared (default)</p> <p>Lockout is always disabled in standby modes in order to ensure supply of external contacts and detect wake-up conditions</p>
22	VS_LOCK_EN	<p>V_S lockout enable: Lockout of V_S related outputs after V_S over/undervoltage shutdown</p> <p>0: V_S related Outputs are turned on automatically and status bits (VS_UV, VS_OV) are cleared</p> <p>1: V_S related Outputs remain turned off until status bits (VS_UV, VS_OV) are cleared (default)</p> <p>Lockout is always disabled in standby modes in order to ensure supply of external contacts and detect wake-up conditions</p>
21	VSREG_OV_SD_EN	<p>VSREG overvoltage shutdown enable: shutdown of V_{SREG} related outputs in case of V_{SREG} overvoltage</p> <p>0: no shutdown of V_{SREG} related outputs in case of V_{SREG} overvoltage</p> <p>1: shutdown of V_{SREG} related outputs in case of V_{SREG} overvoltage (default)</p>
20	VSREG_UV_SD_EN	<p>VSREG undervoltage shutdown enable: shutdown of V_{SREG} related outputs in case of V_{SREG} undervoltage</p> <p>0: no shutdown of V_{SREG} related outputs in case of V_{SREG} undervoltage</p> <p>1: shutdown of V_{SREG} related outputs in case of V_{SREG} undervoltage (default)</p> <p>In case of V1 undervoltage due to VSREG_UV, the device enters Fail-Safe mode and the outputs are turned off</p>
19	VS_OV_SD_EN	<p>V_S overvoltage shutdown enable: shutdown of V_S related outputs in case of V_S overvoltage</p> <p>0: no shutdown of V_S related outputs in case of V_S overvoltage if charge pump output voltage is still sufficient (until CPLOW threshold is reached)</p> <p>1: shutdown of V_S related outputs in case of V_S overvoltage (default)</p>
18	VS_UV_SD_EN	<p>V_S undervoltage shutdown enable: shutdown of V_S related outputs in case of V_S undervoltage</p> <p>0: no shutdown V_S related of outputs in case of V_S undervoltage</p> <p>1: shutdown of V_S related outputs in case of V_S undervoltage (default)</p> <p>In case of V1 undervoltage due to VS_UV, the device enters Fail-Safe mode and the outputs are turned off</p>
17:10	Reserved	Reserved

Table 78. CR3 signals description (continued)

Bit	Name	Description
9	VSREG_EW_TH_9	VSREG early warning threshold. At $V_{SREG} < VSREG_EW_TH$, an interrupt is generated at NINT and status bit VSREG_EW in SR2 is set (in Active mode) 0000000000: 0 V (default) feature deactivated ... 1111111111: V_{AINVS}
8	VSREG_EW_TH_8	
7	VSREG_EW_TH_7	
6	VSREG_EW_TH_6	
5	VSREG_EW_TH_5	
4	VSREG_EW_TH_4	
3	VSREG_EW_TH_3	
2	VSREG_EW_TH_2	
1	VSREG_EW_TH_1	
0	VSREG_EW_TH_0	

7.4.4 Control Register CR4 (0x04)

Table 79. Control Register CR4

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved		OUT1_HS	OUT1_LS	Reserved										OUT4_HS	OUT4_LS	Reserved		OUT5_HS	OUT5_LS	Reserved		OUT6_HS	OUT6_LS
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R/W																							

Table 80. CR4 signals description

Bit	Name	Description
23:22	Reserved	Reserved
21	OUT1_HS	OUT1 high-side Driver control 0: OUT1_HS is turned off (default) 1: OUT1_HS is turned on An internal cross-current protection prevents, that both the low- and high-side drivers of the half-bridge OUT1 are switched on simultaneously.
20	OUT1_LS	OUT1 low-side Driver control 0: OUT1_LS is turned off (default) 1: OUT1_LS is turned on An internal cross-current protection prevents, that both the low- and high-side drivers of the half-bridge OUT1 are switched on simultaneously.
19:10	Reserved	Reserved

Table 80. CR4 signals description (continued)

Bit	Name	Description
9	OUT4_HS	OUT4 high-side Driver control 0: OUT4_HS is turned off (default) 1: OUT4_HS is turned on An internal cross-current protection prevents, that both the low- and high-side drivers of the half-bridge OUT4 are switched on simultaneously.
8	OUT4_LS	OUT4 low-side Driver control 0: OUT4_LS is turned off (default) 1: OUT4_LS is turned on An internal cross-current protection prevents, that both the low- and high-side drivers of the half-bridge OUT4 are switched on simultaneously.
7:6	Reserved	Reserved
5	OUT5_HS	OUT5 high-side Driver control 0: OUT5_HS is turned off (default) 1: OUT5_HS is turned on An internal cross-current protection prevents, that both the low- and high-side drivers of the half-bridge OUT5 are switched on simultaneously.
4	OUT5_LS	OUT5 low-side Driver control 0: OUT5_LS is turned off (default) 1: OUT5_LS is turned on An internal cross-current protection prevents, that both the low- and high-side drivers of the half-bridge OUT5 are switched on simultaneously.
3:2	Reserved	Reserved
1	OUT6_HS	OUT6 high-side Driver control 0: OUT6_HS is turned off (default) 1: OUT6_HS is turned on An internal cross-current protection prevents, that both the low-side and high-side drivers of the half-bridge OUT6 are switched on simultaneously.
0	OUT6_LS	OUT6 low-side Driver control 0: OUT6_LS is turned off (default) 1: OUT6_LS is turned on An internal cross-current protection prevents, that both the low-side and high-side drivers of the half-bridge OUT6 are switched on simultaneously.

7.4.5 Control Register CR5 (0x05)

Table 81. Control Register CR5

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	OUT7_3	OUT7_2	OUT7_1	OUT7_0	OUT8_3	OUT8_2	OUT8_1	OUT8_0	Reserved				OUT10_3	OUT10_2	OUT10_1	OUT10_0	Reserved				OUTHS_3	OUTHS_2	OUTHS_1	OUTHS_0
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R/W																							

Table 82. CR5 signals description

Bit	Name	Description
23	OUT7_3	OUT7 Configuration Bits: high-side Driver OUT7 Configuration For OUT7 bits configuration see Table 83: OUTx Configuration bits
22	OUT7_2	
21	OUT7_1	
20	OUT7_0	
19	OUT8_3	OUT8 Configuration Bits: high-side Driver OUT8 Configuration For OUT8 bits configuration see Table 83: OUTx Configuration bits
18	OUT8_2	
17	OUT8_1	
16	OUT8_0	
15:12	Reserved	—
11	OUT10_3	OUT10 Configuration Bits: high-side Driver OUT10 Configuration For OUT10 bits configuration see Table 83: OUTx Configuration bits
10	OUT10_2	
9	OUT10_1	
8	OUT10_0	
7:4	Reserved	—
3	OUTHS_3	OUTHS Configuration Bits: high-side Driver OUTHS Configuration For OUTHS bits configuration see Table 83: OUTx Configuration bits
2	OUTHS_2	
1	OUTHS_1	
0	OUTHS_0	

Table 83. OUTx Configuration bits

OUTx_3	OUTx_2	OUTx_1	OUTx_0	Description
0	0	0	0	Off (default)
0	0	0	1	On
0	0	1	0	Timer1
0	0	1	1	Timer2
0	1	0	0	PWM1
0	1	0	1	PWM2
0	1	1	0	PWM3
0	1	1	1	PWM4
1	0	0	0	PWM5
1	0	0	1	PWM6
1	0	1	0	PWM7
1	0	1	1	PWM8
1	1	0	0	PWM9

Table 83. OUTx Configuration bits (continued)

OUTx_3	OUTx_2	OUTx_1	OUTx_0	Description
1	1	0	1	PWM10
1	1	1	0	DIR1
1	1	1	1	DIR2

7.4.6 Control Register CR6 (0x06)

Table 84. Control Register CR6

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	OUT9_3	OUT9_2	OUT9_1	OUT9_0	OUT11_3	OUT11_2	OUT11_1	OUT11_0	OUT12_3	OUT12_2	OUT12_1	OUT12_0	OUT13_3	OUT13_2	OUT13_1	OUT13_0	OUT14_3	OUT14_2	OUT14_1	OUT14_0	OUT15_3	OUT15_2	OUT15_1	OUT15_0
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R/W																							

Table 85. CR6 signals description

Bit	Name	Description
23	OUT9_3	OUT9 Configuration Bits: high-side Driver OUT9 Configuration For OUT9 bits configuration see Table 83: OUTx Configuration bits
22	OUT9_2	
21	OUT9_1	
20	OUT9_0	
19	OUT11_3	OUT11 Configuration Bits: high-side Driver OUT11 Configuration For OUT11 bits configuration see Table 83: OUTx Configuration bits
18	OUT11_2	
17	OUT11_1	
16	OUT11_0	
15	OUT12_3	OUT12 Configuration Bits: high-side Driver OUT12 Configuration For OUT12 bits configuration see Table 83: OUTx Configuration bits
14	OUT12_2	
13	OUT12_1	
12	OUT12_0	
11	OUT13_3	OUT13 Configuration Bits: high-side Driver OUT13 Configuration For OUT13 bits configuration see Table 83: OUTx Configuration bits
10	OUT13_2	
9	OUT13_1	
8	OUT13_0	

Table 85. CR6 signals description (continued)

Bit	Name	Description
7	OUT14_3	OUT14 Configuration Bits: high-side Driver OUT14 Configuration For OUT14 bits configuration see Table 83: OUTx Configuration bits
6	OUT14_2	
5	OUT14_1	
4	OUT14_0	
3	OUT15_3	OUT15 Configuration Bits: high-side Driver OUT15 Configuration For OUT15 bits configuration see Table 83: OUTx Configuration bits
2	OUT15_2	
1	OUT15_1	
0	OUT15_0	

7.4.7 Control Register CR7 (0x07)

Table 86. Control Register CR7

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	OUT1_OCR	Reserved		OUT4_OCR	OUT5_OCR	OUT6_OCR	OUT7_OCR	OUT8_OCR	OUTHS_OCR	Reserved						OCR_FREQ	OUT5_OC1	OUT5_OC0	CM_EN	Reserved	CM_SEL_3	CM_SEL_2	CM_SEL_1	CM_SEL_0
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0
Access	R/W																							

Table 87. CR7 signals description

Bit	Name	Description
23	OUT1_OCR	Overcurrent recovery for OUT1 0: overcurrent recovery is turned off (default) 1: overcurrent recovery is turned on
22:21	Reserved	—
20	OUT4_OCR	Overcurrent recovery for OUTx 0: overcurrent recovery is turned off (default) 1: overcurrent recovery is turned on
19	OUT5_OCR	
18	OUT6_OCR	
17	OUT7_OCR	
16	OUT8_OCR	Overcurrent recovery for OUTHS 0: overcurrent recovery is turned off (default) 1: overcurrent recovery is turned on
15	OUTHS_OCR	
14:9	Reserved	—

Table 87. CR7 signals description (continued)

Bit	Name	Description
8	OCR_FREQ	Overcurrent recovery frequency 0: freq0 (default) 1: freq1
7	OUT5_OC1	Overcurrent Threshold for OUT5
6	OUT5_OC0	00: IOC5_3 overcurrent threshold 3 (default) 01: IOC5_1 overcurrent threshold 1 10: IOC5_2 overcurrent threshold 2 11: IOC5_3 overcurrent threshold 3
5	CM_EN	Current monitor: 0: off (3-state) 1: on (default)
4	Reserved	—
3	CM_SEL_3	Current Monitor Select Bits.
2	CM_SEL_2	A current image of the selected binary coded output is multiplexed to the CM output. If a corresponding output does not exist, the current monitor is deactivated.
1	CM_SEL_1	0000: OUT1
0	CM_SEL_0	0001: invalid configuration 0010: invalid configuration 0011: OUT4 0100: OUT5 0101: OUT6 0110: OUT7 0111: OUT8 1000: OUT9 1001: OUT10 1010: OUT11 1011: OUT12 1100: OUT13 1101: OUT14 1110: OUT15 1111: OUT_HS

7.4.8 Control Register CR8 (0x08)

Table 88. Control Register CR8

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	OUT1_OCR_THX_EN	Reserved			OUT4_OCR_THX_EN	OUT5_OCR_THX_EN	OUT6_OCR_THX_EN	OUT7_OCR_THX_EN	OUT8_OCR_THX_EN	OUTHS_OCR_THX_EN	Resrved													
Reset	1	1	1	1	1	1	1	1	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R/W																							

Table 89. CR8 signals description

Bit	Name	Description
23	OUT1_OCR_THX_EN	Enable Overcurrent Recovery with Thermal Expiration for OUTx. 0: Overcurrent Recovery with Thermal Expiration is off 1: Overcurrent Recovery with Thermal Expiration is on (default) The output is turned off after Thermal Expiration.
22:21	Reserved	—
20	OUT4_OCR_THX_EN	Enable Overcurrent Recovery with Thermal Expiration for OUTx. 0: Overcurrent Recovery with Thermal Expiration is off 1: Overcurrent Recovery with Thermal Expiration is on (default) The output is turned off after Thermal Expiration.
19	OUT5_OCR_THX_EN	
18	OUT6_OCR_THX_EN	
17	OUT7_OCR_THX_EN	
16	OUT8_OCR_THX_EN	
15	OUTHS_OCR_THX_EN	Enable Overcurrent Recovery with Thermal Expiration for OUTHS. 0: Overcurrent Recovery with Thermal Expiration is off 1: Overcurrent Recovery with Thermal Expiration is on (default) The output is turned off after Thermal Expiration.
14:0	Reserved	—

7.4.9 Control Register CR9 (0x09)

Table 90. Control Register CR9

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
Bit name	OUT7_RDSON	OUT8_RDSON	Reserved							OUTHS_OL	OUT15_OL	OUT14_OL	OUT13_OL	OUT12_OL	OUT11_OL	OUT10_OL	OUT9_OL	OUTHS_OC	OUT15_OC	OUT14_OC	OUT13_OC	OUT12_OC	OUT11_OC	OUT10_OC	OUT9_OC
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R/W																								

Table 91. CR9 signals description

Bit	Name	Description
23	OUT7_RDSON	Select Rdson for OUT7 0: r_{on_low} (default) 1: r_{on_high}
22	OUT8_RDSON	Select Rdson for OUT8 0: r_{on_low} (default) 1: r_{on_high}
21:16	Reserved	—
15	OUTHS_OL	Open-load Threshold for OUTx 0: I_{OLD1} ; high-current mode (default) 1: I_{OLD1} ; low-current mode
14	OUT15_OL	
13	OUT14_OL	
12	OUT13_OL	
11	OUT12_OL	
10	OUT11_OL	
9	OUT10_OL	
8	OUT9_OL	
7	OUTHS_OC	Overcurrent Threshold for OUTx 0: I_{OC} ; high-current mode (default) 1: I_{OC} ; low-current mode
6	OUT15_OC	
5	OUT14_OC	
4	OUT13_OC	
3	OUT12_OC	
2	OUT11_OC	
1	OUT10_OC	
0	OUT9_OC	

7.4.10 Control Register CR10 (0x0A)

Table 92. Control Register CR10

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	DIAG_2	DIAG_1	DIAG_0	Reserved							SD	SDS	COPT_3	COPT_2	COPT_1	COPT_0	H_OLTH_HIGH	OL_H1L2	OL_H2L1	SLEW_4	SLEW_3	SLEW_2	SLEW_1	SLEW_0
Reset	1	1	1	0	0	1	1	1	0	0	0	0	1	1	1	1	0	0	0	0	0	0	0	0
Access	R/W																							

Table 93. CR10 signals description

Bit	Name	Description
23	DIAG_2	Drain-source monitoring threshold for external H-bridge 000: V _{SCd1_HB} 001: V _{SCd2_HB} 010: V _{SCd3_HB} 011: V _{SCd4_HB} 100: V _{SCd5_HB} 101: V _{SCd6_HB} 110: V _{SCd7_HB} 111: V _{SCd7_HB} (default)
22	DIAG_1	
21	DIAG_0	
20:14	Reserved	
13	SD	Slow decay
12	SDS	Slow decay single
11	COPT_3	Cross current protection time 0000: not allowed 0001: tccp ₀₀₀₁ 0010: tccp ₀₀₁₀ 0011: tccp ₀₀₁₁ 0100: tccp ₀₁₀₀ 0101: tccp ₀₁₀₁ 0110: tccp ₀₁₁₀ 0111: tccp ₀₁₁₁ 1000: tccp ₁₀₀₀ 1001: tccp ₁₀₀₁ 1010: tccp ₁₀₁₀ 1011: tccp ₁₀₁₁ 1100: tccp ₁₁₀₀ 1101: tccp ₁₁₀₁ 1110: tccp ₁₁₁₀ 1111: tccp ₁₁₁₁ (default)
10	COPT_2	
9	COPT_1	
8	COPT_0	
7	H_OLTH_HIGH	H-bridge OL high threshold (5/6 * V _S) select

Table 93. CR10 signals description (continued)

Bit	Name	Description
6	OL_H1L2	Test open-load condition between H1 and L2
5	OL_H2L1	Test open-load condition between H2 and L1
4	SLEW_4	Binary coded slew rate of H-bridge (bit0 = LSB; bit4 = MSB) 00000: Control disabled (default) 11111: I_{GHxmax}
3	SLEW_3	
2	SLEW_2	
1	SLEW_1	
0	SLEW_0	

7.4.11 Control Register CR11 (0x0B)

Table 94. Control Register CR11

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved																							
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0
Access	R/W																							

Table 95. CR11 signals description

Bit	Name	Description
23:0	Reserved	—

7.4.12 Control Register CR12 (0x0C)

Table 96. Control Register CR12

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	PMW1_FREQ_1	PMW1_FREQ_0	PMW2_FREQ_1	PMW2_FREQ_0	PMW3_FREQ_1	PMW3_FREQ_0	PMW4_FREQ_1	PMW4_FREQ_0	PMW5_FREQ_1	PMW5_FREQ_0	PMW6_FREQ_1	PMW6_FREQ_0	PMW7_FREQ_1	PMW7_FREQ_0	PMW8_FREQ_1	PMW8_FREQ_0	PMW9_FREQ_1	PMW9_FREQ_0	PMW10_FREQ_1	PMW10_FREQ_0	Reserved			
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R/W																							

Table 97. CR12 signals description

Bit	Name	Description
23	PMW1_FREQ_1	Frequency of PWM channel PWM1 00: $f_{PWMx}(00)$ (default) 01: $f_{PWMx}(01)$ 10: $f_{PWMx}(10)$ 11: $f_{PWMx}(11)$
22	PMW1_FREQ_0	
21	PMW2_FREQ_1	Frequency of PWM channel PWM2 00: $f_{PWMx}(00)$ (default) 01: $f_{PWMx}(01)$ 10: $f_{PWMx}(10)$ 11: $f_{PWMx}(11)$
20	PMW2_FREQ_0	
19	PMW3_FREQ_1	Frequency of PWM channel PWM3 00: $f_{PWMx}(00)$ (default) 01: $f_{PWMx}(01)$ 10: $f_{PWMx}(10)$ 11: $f_{PWMx}(11)$
18	PMW3_FREQ_0	
17	PMW4_FREQ_1	Frequency of PWM channel PWM4 00: $f_{PWMx}(00)$ (default) 01: $f_{PWMx}(01)$ 10: $f_{PWMx}(10)$ 11: $f_{PWMx}(11)$
16	PMW4_FREQ_0	
15	PMW5_FREQ_1	Frequency of PWM channel PWM5 00: $f_{PWMx}(00)$ (default) 01: $f_{PWMx}(01)$ 10: $f_{PWMx}(10)$ 11: $f_{PWMx}(11)$
14	PMW5_FREQ_0	
13	PMW6_FREQ_1	Frequency of PWM channel PWM6 00: $f_{PWMx}(00)$ (default) 01: $f_{PWMx}(01)$ 10: $f_{PWMx}(10)$ 11: $f_{PWMx}(11)$
12	PMW6_FREQ_0	
11	PMW7_FREQ_1	Frequency of PWM channel PWM7 00: $f_{PWMx}(00)$ (default) 01: $f_{PWMx}(01)$ 10: $f_{PWMx}(10)$ 11: $f_{PWMx}(11)$
10	PMW7_FREQ_0	
9	PMW8_FREQ_1	Frequency of PWM channel PWM8 00: $f_{PWMx}(00)$ (default) 01: $f_{PWMx}(01)$ 10: $f_{PWMx}(10)$ 11: $f_{PWMx}(11)$
8	PMW8_FREQ_0	

Table 97. CR12 signals description (continued)

Bit	Name	Description
7	PMW9_FREQ_1	Frequency of PWM channel PWM9 00: $f_{PWMx}(00)$ (default) 01: $f_{PWMx}(01)$ 10: $f_{PWMx}(10)$ 11: $f_{PWMx}(11)$
6	PMW9_FREQ_0	
5	PMW10_FREQ_1	
4	PMW10_FREQ_0	
3:0	Reserved	—

7.4.13 Control Register CR13 (0x0D) to CR17 (0x11)

Table 98. Control Register CR13 to CR17

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved		PWMx_DC_9	PWMx_DC_8	PWMx_DC_7	PWMx_DC_6	PWMx_DC_5	PWMx_DC_4	PWMx_DC_3	PWMx_DC_2	PWMx_DC_1	PWMx_DC_0	Reserved		PWMx_DC_9	PWMx_DC_8	PWMx_DC_7	PWMx_DC_6	PWMx_DC_5	PWMx_DC_4	PWMx_DC_3	PWMx_DC_2	PWMx_DC_1	PWMx_DC_0
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R/W																							

Where:

$$x = 1 + (z * 2), z = 0 \text{ to } 4$$

$$y = 2 + (z * 2), z = 0 \text{ to } 4$$

Table 99. CR13 to CR17 signals description

Bit	Name	Description
23:22	Reserved	—

Table 99. CR13 to CR17 signals description (continued)

Bit	Name	Description
21	PWMx_DC_9	Binary coded on-dutycycle of PWM channel PWMx (bit12 = LSB; bit21 = MSB) 00 0000 0000: duty cycle 0% (default) xx xxxx xxxx: duty cycle 100%/1023 x register value 11 1111 1111: duty cycle 100%
20	PWMx_DC_8	
19	PWMx_DC_7	
18	PWMx_DC_6	
17	PWMx_DC_5	
16	PWMx_DC_4	
15	PWMx_DC_3	
14	PWMx_DC_2	
13	PWMx_DC_1	
12	PWMx_DC_0	
11:10	Reserved	—
9	PWMy_DC_9	Binary coded on-dutycycle of PWM channel PWMy (bit0 = LSB; bit9 = MSB) 00 0000 0000: duty cycle 0% (default) xx xxxx xxxx: duty cycle 100%/1023 x register value 11 1111 1111: Duty cycle 100%
8	PWMy_DC_8	
7	PWMy_DC_7	
6	PWMy_DC_6	
5	PWMy_DC_5	
4	PWMy_DC_4	
3	PWMy_DC_3	
2	PWMy_DC_2	
1	PWMy_DC_1	
0	PWMy_DC_0	

7.4.14 Control Register CR18 (0x12) to CR22 (0x16)

Table 100. Control Register CR18

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved	OUTx_AUTOCOMP_EN	OUTx_VLED_9	OUTx_VLED_8	OUTx_VLED_7	OUTx_VLED_6	OUTx_VLED_5	OUTx_VLED_4	OUTx_VLED_3	OUTx_VLED_2	OUTx_VLED_1	OUTx_VLED_0	Reserved	OUTy_AUTOCOMP_EN	OUTy_VLED_9	OUTy_VLED_8	OUTy_VLED_7	OUTy_VLED_6	OUTy_VLED_5	OUTy_VLED_4	OUTy_VLED_3	OUTy_VLED_2	OUTy_VLED_1	OUTy_VLED_0
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
Access	R/W																							

Where:

$$x = 7 + (z * 2), z = 0 \text{ to } 4$$

$$y = 8 + (z * 2), z = 0 \text{ to } 4$$

Table 101. CR18 to CR22 signals description

Bit	Name	Description
23	Reserved	—
22	OUTx_AUTOCOMP_EN	Setting this bit to '1' enables the automatic V_S compensation for OUTx
21	OUTx_VLED_9	Binary coded nominal LED voltage of OUTx (bit12 = LSB; bit21 = MSB) 00 0000 0000: $V_{LED} = 0 \text{ V}$ (default) xx xxxx xxxx: $V_{LED} = V_{AINVS} / 1023 \times \text{register value}$ 01 1101 0000: $V_{LED} = V_{AINVS}$ V_{LED} is clamped at 10 V (0x1D0h)
20	OUTx_VLED_8	
19	OUTx_VLED_7	
18	OUTx_VLED_6	
17	OUTx_VLED_5	
16	OUTx_VLED_4	
15	OUTx_VLED_3	
14	OUTx_VLED_2	
13	OUTx_VLED_1	
12	OUTx_VLED_0	
11	Reserved	—
10	OUTy_AUTOCOMP_EN	Setting this bit to '1' enables the automatic V_S compensation for OUTy
9	OUTy_VLED_9	Binary coded nominal LED voltage of OUTy (bit0 = LSB; bit9 = MSB) 00 0000 0000: $V_{LED} = 0 \text{ V}$ (default) xx xxxx xxxx: $V_{LED} = V_{AINVS} / 1023 \times \text{register value}$ 01 1101 0000: $V_{LED} = V_{AINVS}$ V_{LED} is clamped at 10 V (0x1D0h)
8	OUTy_VLED_8	
7	OUTy_VLED_7	
6	OUTy_VLED_6	
5	OUTy_VLED_5	
4	OUTy_VLED_4	
3	OUTy_VLED_3	
2	OUTy_VLED_2	
1	OUTy_VLED_1	
0	OUTy_VLED_0	

7.4.15 Control Register CR34 (0x22)

Table 102. Control Register CR34

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved																					CP_OFF	ICMP	WD_EN
Reset	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1
Access	R/W																							

Table 103. CR34 signals description

Bit	Name	Description
23:3	Reserved	—
2	CP_OFF	Charge pump control 0: Enabled; charge pump on in active mode (default) 1: Disabled; charge pump off in active mode setting CP_OFF = 1 is only possible when CP_OFF_EN = 1
1	ICMP	V1 load current supervision 0: Enabled; Watchdog is disabled in V1 Standby when $I_{V1} < I_{CMP}$ (default) 1: Disabled; watchdog is disabled upon transition into V1_standby mode setting ICMP = 1 is only possible when ICMP_config_en = 1
0	WD_EN	Watchdog Enable 0: Watchdog disabled 1: Watchdog enabled (default)

7.4.16 Configuration Register (0x3F)

Table 104. Configuration Register

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	WU_CONFIG	LIN_WU_CONFIG	LIN_HS_EN	TSD_CONFIG	Reserved	DM	ICMP_CONFIG_EN	WD_CONFIG_EN	MASK_OL_HS1	MASK_OL_LS1	MASK_TW	Reserved	MASK_OL	MASK_SPIE	MASK_PLE	MASK_GW	CP_OFF_EN	CP_LOW_CONFIG	CP_DITH_DIS	FS_FORCED	Reserved			TRIG
Reset	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1
Access	R/W																							

Table 105. CR signals description

Bit	Name	Description
23	WU_CONFIG	Configuration of input pin WU Input configured as wake-up input 0: WU configured as wake-up input 1: WU configured for input voltage measurement (default)
22	LIN_WU_CONFIG	Configuration of LIN wake-up behaviour 0: wake up at recessive - dominant - recessive with $t_{dom} > t_{dom_LIN}$ (default) (according to LIN 2.2a and Hardware Requirements for Transceivers version 1.3) 1: wake up at recessive - dominant transition
21	LIN_HS_EN	Configuration of LIN transceiver bit rate 0: LIN transceiver in normal communication mode (20kbit/s) (default) 1: LIN transceiver in high speed mode for fast Flashing (115kbit/s)
20	TSD_CONFIG	Configuration of thermal shutdown behaviour 0: in case of TSD1 all power stages are switched off (default) 1: selective shut down of power stage cluster
19	Reserved	—
18	DM	H-bridge configuration 0: single motor mode (default) 1: reserved
17	ICMP_CONFIG_EN	ICMP configuration Enable 0: writing ICMP = 1 is blocked (writing ICMP=0 is possible); (default) 1: writing ICMP = 1 is possible with next SPI command bit is automatically reset to 0 after next SPI command
16	WD_CONFIG_EN	Watchdog configuration Enable 0: writing to WD Configuration (CR2 [0:1] is blocked (default) 1: writing to WD Configuration Bits is possible with next SPI command bit is automatically reset to 0 after next SPI command
15	MASK_OL_HS1	Mask Open-load HS1 0: Open-load condition at HS1 is not masked (default) 1: Open-load condition at HS1 is masked i.e. it is reported as a Functional Error (GSB bit 3) but not as a Global Error (GSB bit 7)
14	MASK_OL_LS1	Mask Open-load LS1 0: Open-load condition at LS1 is not masked (default) 1: Open-load condition at LS1 is masked i.e. it is reported as a Functional Error (GSB bit 3) but not as a Global Error (GSB bit 7)
13	MASK_TW	Mask Thermal Warning 0: Thermal warning is not masked (default) 1: Thermal warning is masked i.e. it is reported as a Global Warning (GSB bit 1) but not as a Global Error (GSB bit 7)

Table 105. CR signals description (continued)

Bit	Name	Description
12	Reserved	—
11	MASK_OL	Mask open-load 0: Open-load condition at all outputs are not masked (default) 1: Open-load condition at all outputs are masked i.e. it is reported as a Functional Error (GSB bit 3) but not as a Global Error (GSB bit 7)
10	MASK_SPIE	Mask SPI error 0: SPI errors are not masked (default) 1: SPI errors are masked i.e. reported as an SPI Error (GSB bit 5) but not as a Global Error (GSB bit 7)
9	MASK_PLE	Mask physical layer error 0: Physical Layer Errors are not masked (default) 1: Physical Layer Errors are masked i.e. reported as a Physical Layer Error (GSB bit 4) but not as a Global Error (GSB bit 7)
8	MASK_GW	Mask global warning 0: Global Warning conditions are not masked (default) 1: Global Warning conditions are masked i.e. reported as a Global Warning (GSB bit 1) but not as a Global Error (GSB bit 7)
7	CP_OFF_EN	Charge pump control enable 0: writing CP_OFF = 1 is blocked (writing CP_OFF = 0 is possible); (default) 1: writing CP_OFF = 1 is possible with next SPI command Bit is automatically reset to 0 after next SPI command
6	CP_LOW_CONFIG	Charge pump low configuration 0: CP_low (SR 2, bit 9) is latched and outputs are off until R&C; (default) 1: CP_low (SR 2, bit 9) is a 'live' bit; outputs are re-activated automatically upon recovery of the charge pump output voltage
5	CP_DITH_DIS	Charge pump clock dithering 0: CP clock dithering is enabled; (default) 1: CP clock dithering is disabled
4	FS_FORCED	Force LSx_FSO ON LSx_FSO low-side outputs are forced ON (to allow diagnosis of the fail-safe path) 0: LSx_FSO outputs are controlled by the Fail-safe logic (default) 1: LSx_FSO outputs are forced ON and the device enters Fail-Safe mode; no NReset is generated
3:1	Reserved	—
0	TRIG	Watchdog Trigger bit

7.5 Status Registers

7.5.1 Status Register SR1 (0x31)

Table 106. Status Register SR1 (0x31)

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved	WU_STATE	Reserved	WU_WAKE	Reserved	WAKE_LIN	WAKE_TIMER	DEBUG_ACTIVE	V1UV	V1_RESTART_2	V1_RESTART_1	V1_RESTART_0	WDFAIL_CNT_3	WDFAIL_CNT_2	WDFAIL_CNT_1	WDFAIL_CNT_0	DEVICE_STATE_1	DEVICE_STATE_0	TSD2	TSD1	FORCED_SLEEP_TSD2/V1SC	FORCED_SLEEP_WD	WDFAIL	VPOR
Access	R/C	R			R/C								R								R/C			

Table 107. SR1 signals description

Bit	Name	Description
23	Reserved	—
22	WU_STATE	State of WU input 0: input level is low 1: input level is high The bit shows the momentary status of WU and cannot be cleared (“Live bit”) Note: The status is only valid if WU is configured as wake-up input in Configuration Register (0x3F). Otherwise this bit remains at his previous logic state.
21	Reserved	—
20	WU_WAKE	Wake-up by WU: shows wake up source 1: wake-up Bits are latched until a “Read and clear” command
19	Reserved	—
18	WAKE_LIN	Wake-up by LIN: shows wake up source 1: wake-up Bits are latched until a “Read and clear” command
17	WAKE_TIMER	Wake-up by Timer: shows wake up source 1: wake-up Bits are latched until a “Read and clear” command
16	DEBUG_ACTIVE	Debug Mode Active: indicates Device is in Debug mode 1: Debug mode The bit shows the momentary status and cannot be cleared (“Live bit”)

Table 107. SR1 signals description (continued)

Bit	Name	Description
15	V1UV	Indicates undervoltage condition at voltage regulator V1 ($V1 < V_{RTX}$) 1: undervoltage Bit is latched until a "Read and clear" command
14	V1_RESTART_2	Indicates the number of TSD2 events which caused a restart of voltage regulator V1 Bits cannot be cleared; counter will be cleared automatically if no additional TSD2 event occurs within 1 minute.
13	V1_RESTART_1	
12	V1_RESTART_0	
11	WDFAIL_CNT_3	Indicates number of subsequent watchdog failures. Bits cannot be cleared; will be cleared with a valid watchdog trigger
10	WDFAIL_CNT_2	
9	WDFAIL_CNT_1	
8	WDFAIL_CNT_0	
7	DEVICE_STATE_1	State from which the device woke up
6	DEVICE_STATE_0	00: Active Mode after Read&Clear command or after Flash Mode state 01: Active mode after wake-up from V1_standby mode (before Read&Clear command) 10: Active Mode after Power-on or after wake-up from Vbat_standby Mode (before Read&Clear command) 11: Flash mode (LIN Flash mode) Bit is latched until a "Read and clear" command After a "read and clear access", the device state will be updated
5	TSD2	Thermal Shutdown 2 was reached Bit is latched until a "Read and clear" command
4	TSD1	Thermal Shutdown 1 was reached (Logical Or combination of all TSD1_CLx; see status register SR6). This bit cannot be cleared directly. It is reset if the corresponding TSD1_CLx bits in SR6 are cleared.
3	FORCED_SLEEP_TSD2/V1SC	Device entered Forced Vbat_standby mode due to: – Thermal shutdown or – Short circuit on V1 during startup Bit is latched until a "Read and clear" command
2	FORCED_SLEEP_WD	Device entered Forced Vbat_standby mode due to multiple watchdog failures Bit is latched until a "Read and clear" command
1	WDFAIL	Watchdog failure Bit is latched until a "Read and clear" command
0	VPOR	V_S Power-on Reset threshold (VPOR) reached Bit is latched until a "Read and clear" command

7.5.2 Status Register SR2 (0x32)

Table 108. Status Register SR2 (0x32)

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
Bit name	LIN_PERM_DOM	LIN_TXD_DOM	LIN_PERM_REC	Reserved						DSMON_HS2	DSMON_HS1	DSMON_LS2	DSMON_LS1	SPI_INV_CMD	SPI_SCK_CNT	CP_LOW	TW	V2SC	V2FAIL	V1FAIL	VSREG_EW	VSREG_OV	VSREG_UV	VS_OV	VS_UV
Access	R/C														R	R/C									

Table 109. SR2 signals description

Bit	Name	Description
23	LIN_PERM_DOM	LIN bus signal is dominant for $t > t_{dom(bus)}$ Bit is latched until a “Read and clear” command
22	LIN_TXD_DOM	TxDL pin is dominant for $t > t_{dom(TXDL)}$ The LIN transmitter is disabled until the bit is cleared Bit is latched until a “Read and clear” command
21	LIN_PERM_REC	LIN bus signal does not follow TxDL within t_{LIN} The LIN transmitter is disabled until the bit is cleared Bit is latched until a “Read and clear” command
20:16	Reserved	—
15	DSMON_HS2	Drain-Source Monitoring ‘1’ indicates a short-circuit or open-load condition was detected Bit is latched until a “Read and clear” command
14	DSMON_HS1	
13	DSMON_LS2	
12	DSMON_LS1	
11	SPI_INV_CMD	Invalid SPI command ‘1’ indicates one of the following conditions was detected: <ul style="list-style-type: none"> – access to undefined address – Write operation to Status Register – DI stuck at ‘0’ or ‘1’ – CSN timeout – Parity failure – invalid or undefined setting The SPI frame is ignored Bit is latched until a “Read and clear” command
10	SPI_SCK_CNT	SPI clock counter ‘1’ indicates an SPI frame with wrong number of CLK cycles was detected Bit is latched until a valid SPI frame
9	CP_LOW	Charge pump voltage low ‘1’ indicates that the charge pump voltage is too low Bit is latched until a “Read and clear” command

Table 109. SR2 signals description (continued)

Bit	Name	Description
8	TW	Thermal warning '1' indicates the temperature has reached the thermal warning threshold (logical OR combination of bits TW_CLx in SR6) Bit is latched until a "Read and clear" command
7	V2SC	V2 short circuit detection '1' indicates a short circuit to GND condition of V2 at turn-on of the regulator ($V2 < V2_fail$ for $t > t_{V2_short}$) Bit is latched until a "Read and clear" command
6	V2FAIL	V2 failure detection '1' indicates a V2 fail event occurred since last readout ($V2 < V2_fail$ for $t > t_{V2_fail}$) Bit is latched until a "Read and clear" command
5	V1FAIL	V1 failure detection '1' indicates a V1 fail event occurred since last readout ($V1 < V1_fail$ for $t > t_{V1_fail}$) Bit is latched until a "Read and clear" command
4	VSREG_EW	VSREG early warning '1' indicates the voltage at VSREG has reached the early warning threshold (configured in CR3) In Active mode, an interrupt pulse is generated at NINT Bit is latched until a "Read and clear" command. Bit needs a "Read and clear" command after wake-up from standby modes
3	VSREG_OV	VSREG overvoltage '1' indicates the voltage at VSREG has reached the overvoltage threshold Bit is latched until a "Read and clear" command
2	VSREG_UV	VSREG undervoltage '1' indicates the voltage at VSREG has reached the undervoltage threshold Bit is latched until a "Read and clear" command
1	VS_OV	VS overvoltage '1' indicates the voltage at VS has reached the overvoltage threshold Bit is latched until a "Read and clear" command
0	VS_UV	VS undervoltage '1' indicates the voltage at VS has reached the undervoltage threshold Bit is latched until a "Read and clear" command

7.5.3 Status Register SR3 (0x33)

Table 110. Status Register SR3 (0x33)

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	OUT1_HS_OC_TH_EX	OUT1_LS_OC_TH_EX	Reserved				OUT4_HS_OC_TH_EX	OUT4_LS_OC_TH_EX	OUT5_HS_OC_TH_EX	OUT5_LS_OC_TH_EX	OUT6_HS_OC_TH_EX	OUT6_LS_OC_TH_EX	OUT7_OC_TH_EX	OUT8_OC_TH_EX	OUT9_OC	OUT10_OC	OUT11_OC	OUT12_OC	OUT13_OC	OUT14_OC	OUT15_OC	OUTHS_OC_TH_EX	LS2FSO_OC	LS1FSO_OC
Access	R/C																							

Table 111. SR3 signals description

Bit	Name	Description
23	OUT1_HS_OC_TH_EX	Overcurrent shutdown
22	OUT1_LS_OC_TH_EX	<p>'1' indicates the output was shut down due to overcurrent condition.</p> <p>If Overcurrent Recovery is disabled (CR7: OUTx_OCR = 0): Bit is set upon overcurrent condition and output is turned off.</p> <p>If Overcurrent Recovery is enabled (CR7: OUTx_OCR = 1): In case of overcurrent condition this bit is not set. The output goes into Overcurrent Recovery mode and OUTx_OCR_alert in SR4 is set to '1'</p> <p>In case of Thermal Expiration enabled (CR8: OUTx_OCR_THx_en = 1): Bit is set after thermal expiration and output is turned off</p> <p>Bit is latched until a "Read and clear" command</p>
21:18	Reserved	—
17	OUT4_HS_OC_TH_EX	Overcurrent shutdown
16	OUT4_LS_OC_TH_EX	'1' indicates the output was shut down due to overcurrent condition.
15	OUT5_HS_OC_TH_EX	If Overcurrent Recovery is disabled (CR7: OUTx_OCR = 0): Bit is set upon overcurrent condition and output is turned off.
14	OUT5_LS_OC_TH_EX	If Overcurrent Recovery is enabled (CR7: OUTx_OCR = 1):
13	OUT6_HS_OC_TH_EX	In case of overcurrent condition this bit is not set. The output goes into
12	OUT6_LS_OC_TH_EX	Overcurrent Recovery mode and OUTx_OCR_alert in SR4 is set to '1'
11	OUT7_OC_TH_EX	In case of Thermal Expiration enabled (CR8: OUTx_OCR_THx_en = 1): Bit is set after thermal expiration and output is turned off
10	OUT8_OC_TH_EX	Bit is latched until a "Read and clear" command

Table 111. SR3 signals description (continued)

Bit	Name	Description
9	OUT9_OC	Overcurrent shutdown '1' indicates the output was shut down due to overcurrent condition. Bit is latched until a "Read and clear" command
8	OUT10_OC	
7	OUT11_OC	
6	OUT12_OC	
5	OUT13_OC	
4	OUT14_OC	
3	OUT15_OC	
2	OUTHS_OC_TH_EX	Overcurrent shutdown '1' indicates the output was shut down due to overcurrent condition. If Overcurrent Recovery is disabled (CR7: OUTx_OCR = 0): Bit is set upon overcurrent condition and output is turned off. If Overcurrent Recovery is enabled (CR7: OUTx_OCR = 1): In case of overcurrent condition this bit is not set. The output goes into Overcurrent Recovery mode and OUTx_OCR_alert in SR4 is set to '1' In case of Thermal Expiration enabled (CR8: OUTx_OCR_THx_en = 1): Bit is set after thermal expiration and output is turned off Bit is latched until a "Read and clear" command
1	LS2FSO_OC	Overcurrent shutdown
0	LS1FSO_OC	'1' indicates the output was shut down due to overcurrent condition. Bit is latched until a "Read and clear" command

7.5.4 Status Register SR4 (0x34)

Table 112. Status Register SR4 (0x34)

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	OUT1_HS_OCR_ALERT	OUT1_LS_OCR_ALERT	Reserved				OUT4_HS_OCR_ALERT	OUT4_LS_OCR_ALERT	OUT5_HS_OCR_ALERT	OUT5_LS_OCR_ALERT	OUT6_HS_OCR_ALERT	OUT6_LS_OCR_ALERT	OUT7_OCR_ALERT	OUT8_OCR_ALERT	Reserved							OUTHS_OCR_ALERT	Reserved	
Access	R														R/C							R	R/C	

Table 113. SR4 signals description

Bit	Name	Description
23	OUT1_HS_OCR_ALERT	Autorecovery Alert '1' indicates that the output reached the overcurrent threshold and is in autorecovery mode Bit is not latched and cannot be cleared.
22	OUT1_LS_OCR_ALERT	
21:18	Reserved	—
17	OUT4_HS_OCR_ALERT	Autorecovery Alert '1' indicates that the output reached the overcurrent threshold and is in autorecovery mode Bit is not latched and cannot be cleared.
16	OUT4_LS_OCR_ALERT	
15	OUT5_HS_OCR_ALERT	
14	OUT5_LS_OCR_ALERT	
13	OUT6_HS_OCR_ALERT	
12	OUT6_LS_OCR_ALERT	
11	OUT7_OCR_ALERT	
10	OUT8_OCR_ALERT	
9:3	Reserved	—
2	OUTHS_OCR_ALERT	Autorecovery Alert '1' indicates that the output reached the overcurrent threshold and is in autorecovery mode Bit is not latched and cannot be cleared.
1:0	Reserved	—

7.5.5 Status Register SR5 (0x35)

Table 114. Status Register SR5 (0x35)

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	OUT1_HS_OL	OUT1_LS_OL	Reserved				OUT4_HS_OL	OUT4_LS_OL	OUT5_HS_OL	OUT5_LS_OL	OUT6_HS_OL	OUT6_LS_OL	OUT7_OL	OUT8_OL	OUT9_OL	OUT10_OL	OUT11_OL	OUT12_OL	OUT13_OL	OUT14_OL	OUT15_OL	OUTHS_OL	Reserved	
Access	R/C																							

Table 115. SR5 signals description

Bit	Name	Description
23	OUT1_HS_OL	Open-load '1' indicates an open-load condition was detected at the output Bit is latched until a "Read and clear" command
22	OUT1_LS_OL	
21:18	Reserved	—

Table 115. SR5 signals description (continued)

Bit	Name	Description
17	OUT4_HS_OL	Open-load '1' indicates an open-load condition was detected at the output Bit is latched until a "Read and clear" command
16	OUT4_LS_OL	
15	OUT5_HS_OL	
14	OUT5_LS_OL	
13	OUT6_HS_OL	
12	OUT6_LS_OL	
11	OUT7_OL	
10	OUT8_OL	
9	OUT9_OL	
8	OUT10_OL	
7	OUT11_OL	
6	OUT12_OL	
5	OUT13_OL	
4	OUT14_OL	
3	OUT15_OL	
2	OUTHS_OL	
1:0	Reserved	—

7.5.6 Status Register SR6 (0x36)

Table 116. Status Register SR6 (0x36)

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
Bit name	WD_TIMER_STATE_1	WD_TIMER_STATE_0	Reserved									TW_CL6	TW_CL5	TW_CL4	TW_CL3	TW_CL2	TW_CL1	Reserved		TSD1_CL6	TSD1_CL5	TSD1_CL4	TSD1_CL3	TSD1_CL2	TSD1_CL1
Access	R		R/C																						

Table 117. SR6 signals description

Bit	Name	Description
23	WD_TIMER_STATE_1	Watchdog timer status 00: 0 - 33% 01: 33 - 66% 11: 66 - 100%
22	WD_TIMER_STATE_0	

Table 117. SR6 signals description (continued)

Bit	Name	Description
21:14	Reserved	—
13	TW_CL6	Thermal warning for Cluster x '1' indicates Cluster x has reached the thermal warning threshold Bit is latched until a "Read and clear" command
12	TW_CL5	
11	TW_CL4	
10	TW_CL3	
9	TW_CL2	
8	TW_CL1	
7:6	Reserved	—
5	TSD1_CL6	Thermal shutdown of Cluster x '1' indicates Cluster x has reached the thermal shutdown threshold (TSD1) and the output cluster was shut down Bit is latched until a "Read and clear" command
4	TSD1_CL5	
3	TSD1_CL4	
2	TSD1_CL3	
1	TSD1_CL2	
0	TSD1_CL1	

7.5.7 Status Register SR7 (0x37) to SR9 (0x39)

Table 118. Status Register SR7 (0x37) to SR9 (0x39)

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved		TEMP_CLx_9	TEMP_CLx_8	TEMP_CLx_7	TEMP_CLx_6	TEMP_CLx_5	TEMP_CLx_4	TEMP_CLx_3	TEMP_CLx_2	TEMP_CLx_1	TEMP_CLx_0	Reserved		TEMP_Cly_9	TEMP_Cly_8	TEMP_Cly_7	TEMP_Cly_6	TEMP_Cly_5	TEMP_Cly_4	TEMP_Cly_3	TEMP_Cly_2	TEMP_Cly_1	TEMP_Cly_0
Access	R/C		R										R/C		R									

Where:

$$x = 2 + (z * 2), z = 0 \text{ to } 2$$

$$y = 1 + (z * 2), z = 0 \text{ to } 2$$

Table 119. SR7 to SR9 signals description

Bit	Name	Description
23:22	Reserved	—

Table 119. SR7 to SR9 signals description (continued)

Bit	Name	Description
21	TEMP_CLx_9	Temperature Cluster x: Binary coded voltage of temperature diode for cluster x (bit12 = LSB; bit21 = MSB) (see Section 4.31: Thermal clusters) Bits cannot be cleared.
20	TEMP_CLx_8	
19	TEMP_CLx_7	
18	TEMP_CLx_6	
17	TEMP_CLx_5	
16	TEMP_CLx_4	
15	TEMP_CLx_3	
14	TEMP_CLx_2	
13	TEMP_CLx_1	
12	TEMP_CLx_0	
11:10	Reserved	—
9	TEMP_CLy_9	Temperature Cluster y: binary coded voltage of temperature diode for cluster y (bit0 = LSB; bit9 = MSB) (see Section 4.31: Thermal clusters) Bits cannot be cleared.
8	TEMP_CLy_8	
7	TEMP_CLy_7	
6	TEMP_CLy_6	
5	TEMP_CLy_5	
4	TEMP_CLy_4	
3	TEMP_CLy_3	
2	TEMP_CLy_2	
1	TEMP_CLy_1	
0	TEMP_CLy_0	

7.5.8 Status Register SR10 (0x3A)

Table 120. Status Register SR10 (0x3A)

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved		VSREG_9	VSREG_8	VSREG_7	VSREG_6	VSREG_5	VSREG_4	VSREG_3	VSREG_2	VSREG_1	VSREG_0	Reserved											
Access	R/C		R										R/C											

Table 121. SR10 signals description

Bit	Name	Description
23:22	Reserved	—

Table 121. SR10 signals description (continued)

Bit	Name	Description
21	VSREG_9	Binary coded voltage at V _{SREG} pin (bit12 = LSB; bit21 = MSB) 00 0000 0000: 0V xx xxxx xxxx: V _{AINVS} /1023 x register value 11 1111 1111: V _{AINVS} Bits cannot be cleared.
20	VSREG_8	
19	VSREG_7	
18	VSREG_6	
17	VSREG_5	
16	VSREG_4	
15	VSREG_3	
14	VSREG_2	
13	VSREG_1	
12	VSREG_0	
11:0	Reserved	—

7.5.9 Status Register SR11 (0x3B)

Table 122. Status Register SR11 (0x3B)

	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Bit name	Reserved		VS_9	VS_8	VS_7	VS_6	VS_5	VS_4	VS_3	VS_2	VS_1	VS_0	Reserved		VWU_9	VWU_8	VWU_7	VWU_6	VWU_5	VWU_4	VWU_3	VWU_2	VWU_1	VWU_0
Access	R/C		R										R/C		R									

Table 123. SR11 signals description

Bit	Name	Description
23:22	Reserved	—
21	VS_9	Binary coded voltage at V _S pin (bit12 = LSB; bit21 = MSB) 00 0000 0000: 0V xx xxxx xxxx: V _{AINVS} /1023 x register value 11 1111 1111: V _{AINVS} Bits cannot be cleared.
20	VS_8	
19	VS_7	
18	VS_6	
17	VS_5	
16	VS_4	
15	VS_3	
14	VS_2	
13	VS_1	
12	VS_0	
11:10	Reserved	—

Table 123. SR11 signals description (continued)

Bit	Name	Description
9	VWU_9	Binary coded voltage at WU pin (bit0 = LSB; bit9 = MSB) 00 0000 0000: 0V xx xxxx xxxx: $V_{AINVS}/1023 \times \text{register value}$ 11 1111 1111: V_{AINVS} Bits cannot be cleared.
8	VWU_8	
7	VWU_7	
6	VWU_6	
5	VWU_5	
4	VWU_4	
3	VWU_3	
2	VWU_2	
1	VWU_1	
0	VWU_0	

8 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.

8.1 LQFP-64 package information

Figure 57. LQFP-64 package dimension

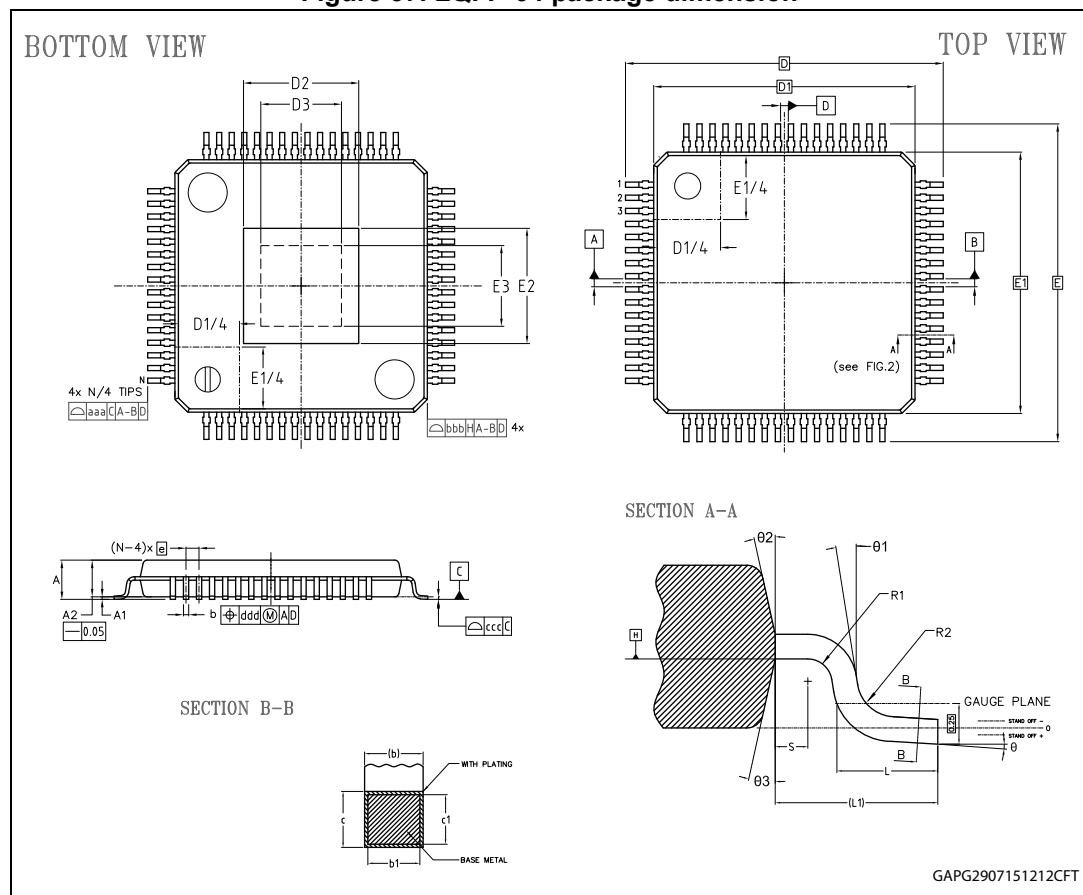


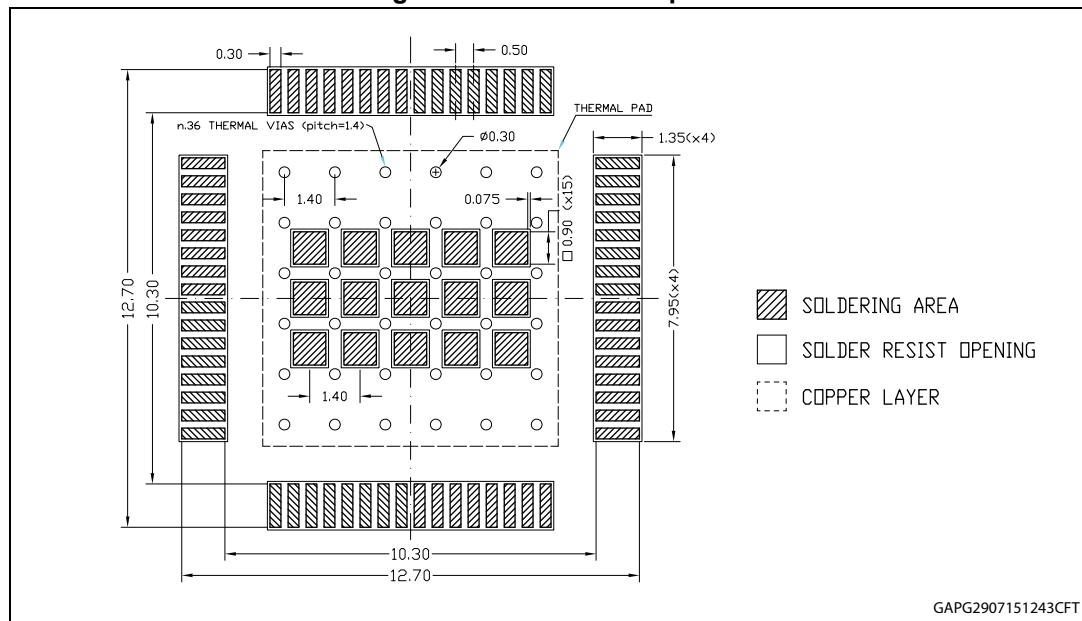
Table 124. LQFP-64 mechanical data

Symbol	Millimeters		
	Min.	Typ.	Max.
Θ	0°	3.5°	6°
$\Theta1$	0°	9°	12°
$\Theta2$	11°	12°	13°
$\Theta3$	11°	12°	13°

Table 124. LQFP-64 mechanical data (continued)

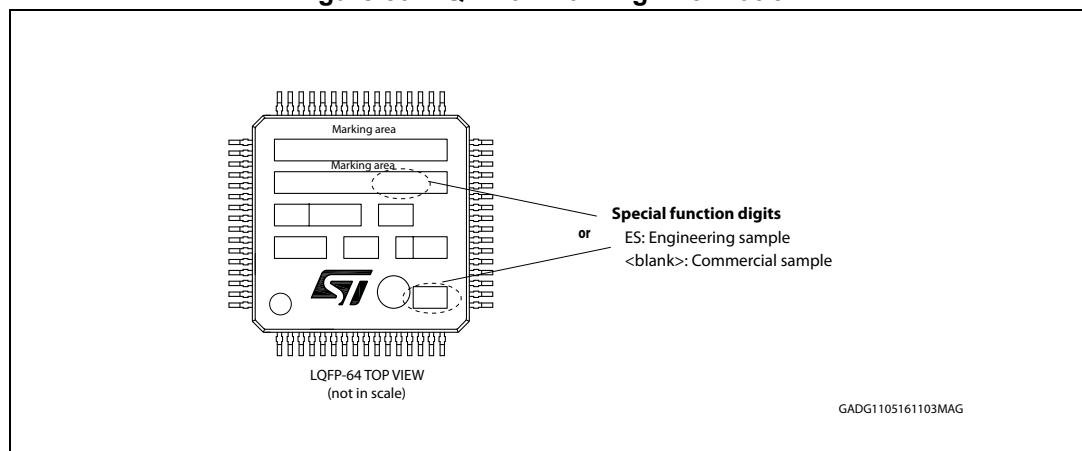
Symbol	Millimeters		
	Min.	Typ.	Max.
A			1.60
A1	0.05		0.15
A2	1.35	1.40	1.45
b			0.27
b1	0.17	0.20	0.23
c	0.09		0.20
c1	0.09	0.127	0.16
D	12.00 BSC		
D1	10.00 BSC		
D2			6.85
D3	5.7		
e	0.50 BSC		
E	12.00 BSC		
E1	10.00 BSC		
E2			4.79
E3	3.3		
L	0.45	0.60	0.75
L1	1.00		
N	64		
R1	0.08		
R2	0.08		0.20
S	0.20		
Tolerance of form and position			
aaa	0.20		
bbb	0.20		
ccc	0.08		
ddd	0.08		

Figure 58. LQFP-64 footprint



8.2 LQFP-64 marking information

Figure 59. LQFP-64 marking information



Parts marked as ES are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted to run a qualification activity prior to any decision to use these engineering samples.

9 Order code

Table 125. Device summary

Package	Order codes	
	Tray	Tape and reel
LQFP-64 epad	L99DZ120	L99DZ120-TR

10 Revision history

Table 126. Document revision history

Date	Revision	Changes
27-Apr-2016	1	Initial release.
11-May-2016	2	Updated Section 3.3.1: LQFP64 thermal data Updated Table 19 Updated Table 21 Updated Table 39 Updated Figure 59 Updated Section 4.14: Auto-recovery alert and thermal expiration Updated Section 4.22: Programmable soft-start function to drive loads with higher inrush current Updated Figure 43 Updated Table 113
12-Sep-2016	3	Updated Table 28
22-Nov-2016	4	Added AEC-Q100 qualified in Features . Updated Table 3: ESD protection , Added Section 3.4.12: Over Current Recovery settings Updated Section 4.22: Programmable soft-start function to drive loads with higher inrush current Added Table 17: Half bridges (OUT1, OUT4, OUT5 and OUT6) OCR timing parameters and Table 18: High-side (OUT7, OUT8 and OUT_HS) OCR timing parameters Updated Table 19: Current monitoring Updated Table 109: SR2 signals description Updated Table 123: SR11 signals description

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